

Impact of Impedance effects on beam chamber specifications

BE/ABP-HSC (Collective/Coherent Effects)

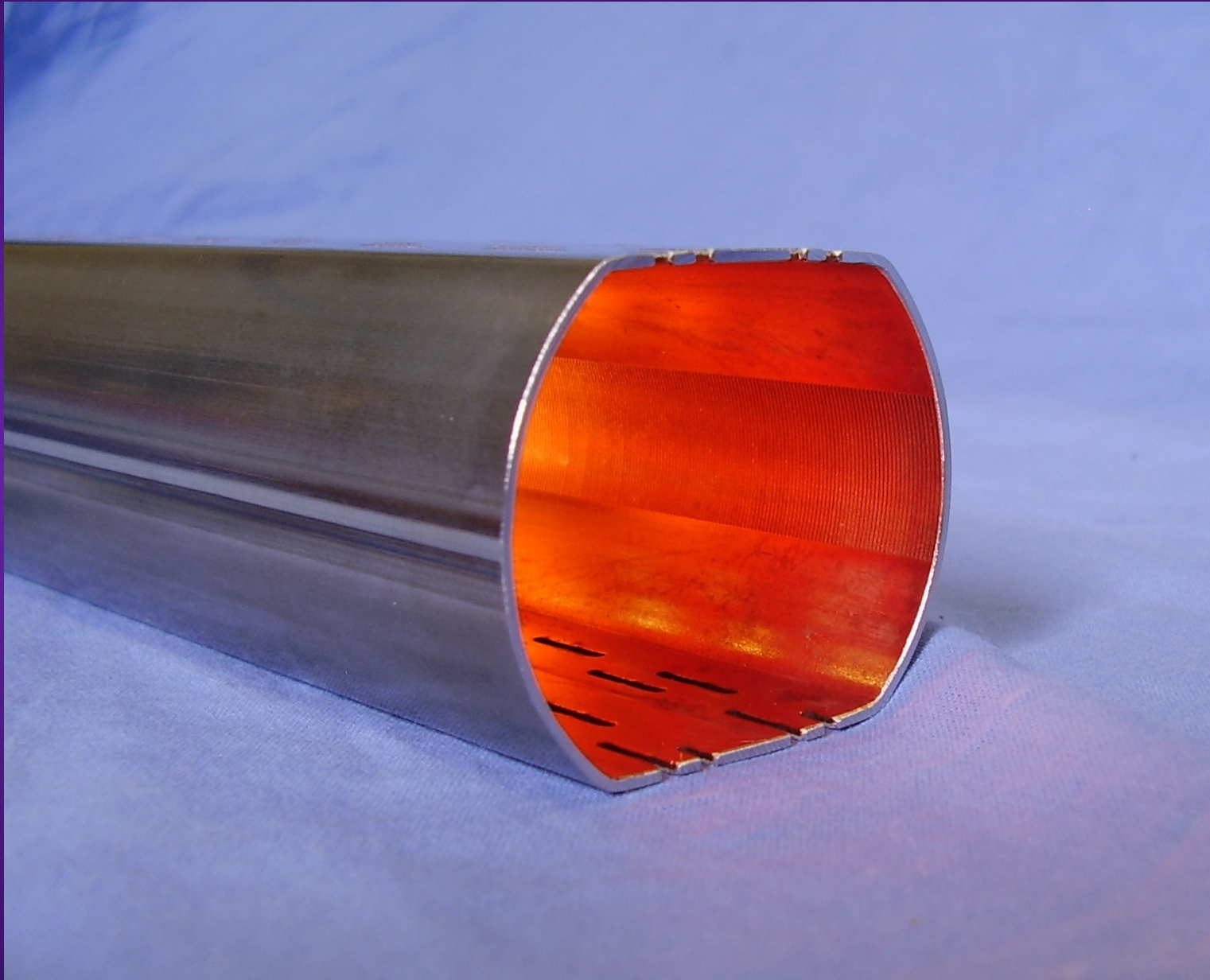
Elias Métral

Elias.Metral@cern.ch

Tel.: 00 41 75 411 4809

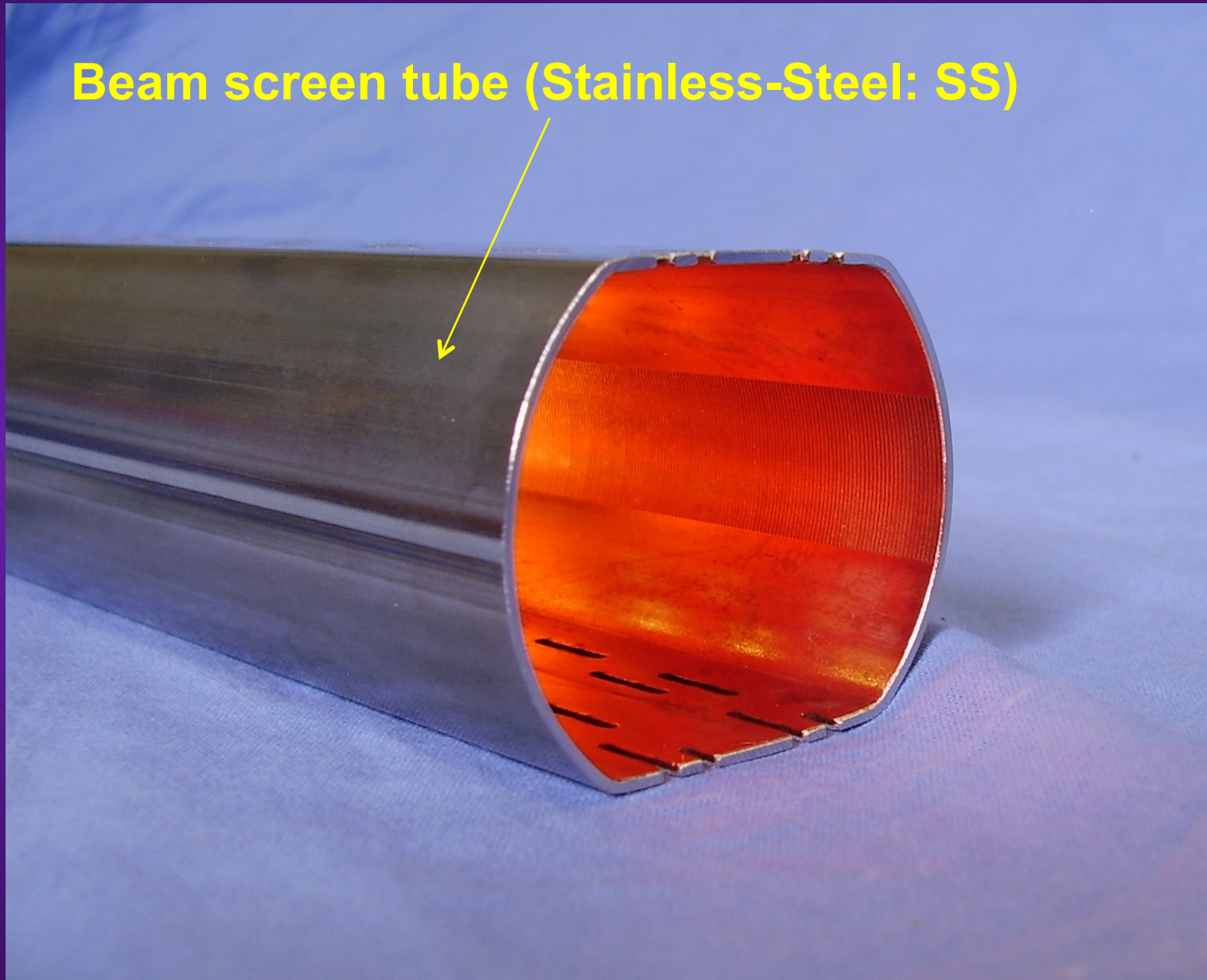
<http://emetral.web.cern.ch/emetral/>

INTRODUCTION: THE LHC BEAM CHAMBER

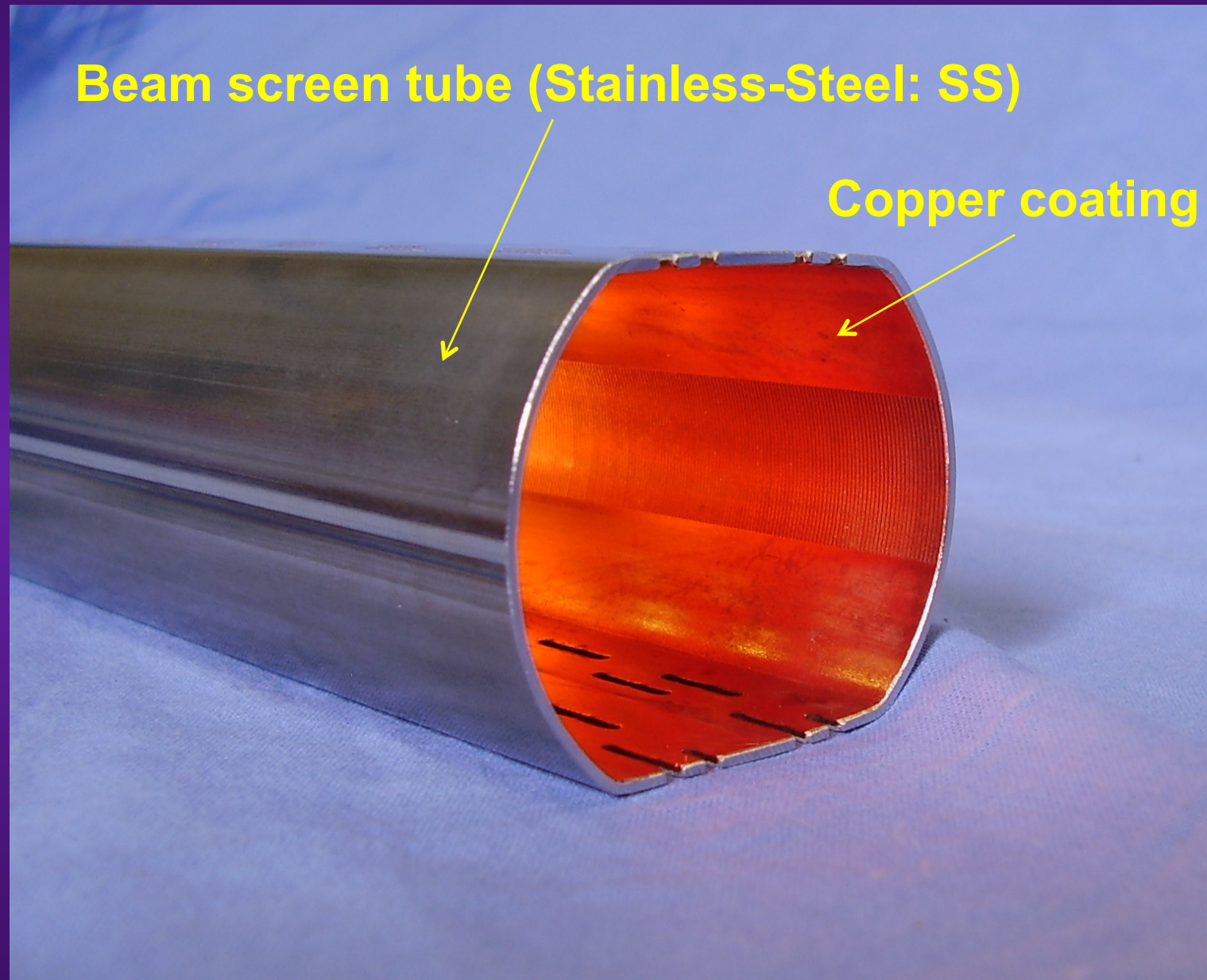


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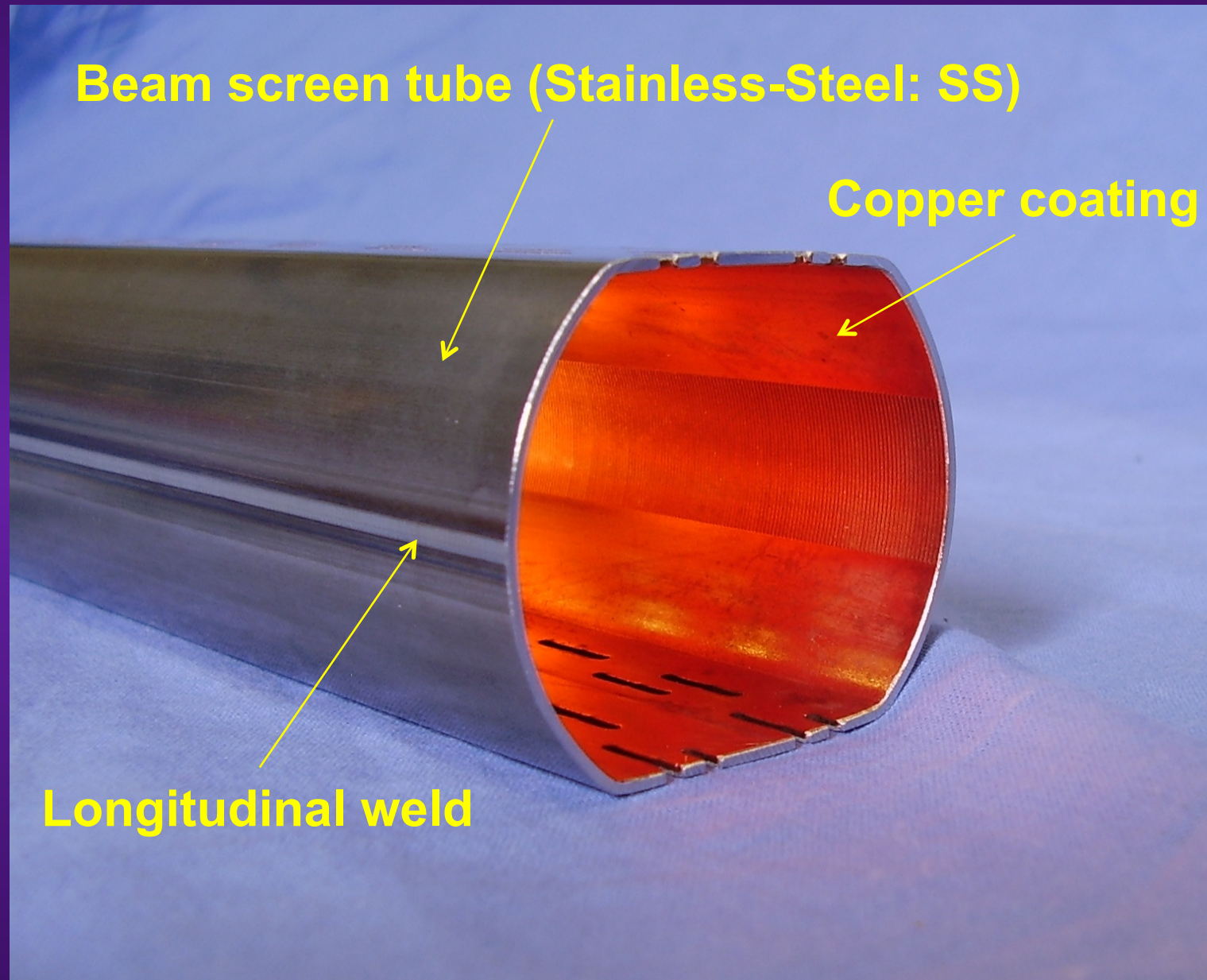
Beam screen tube (Stainless-Steel: SS)



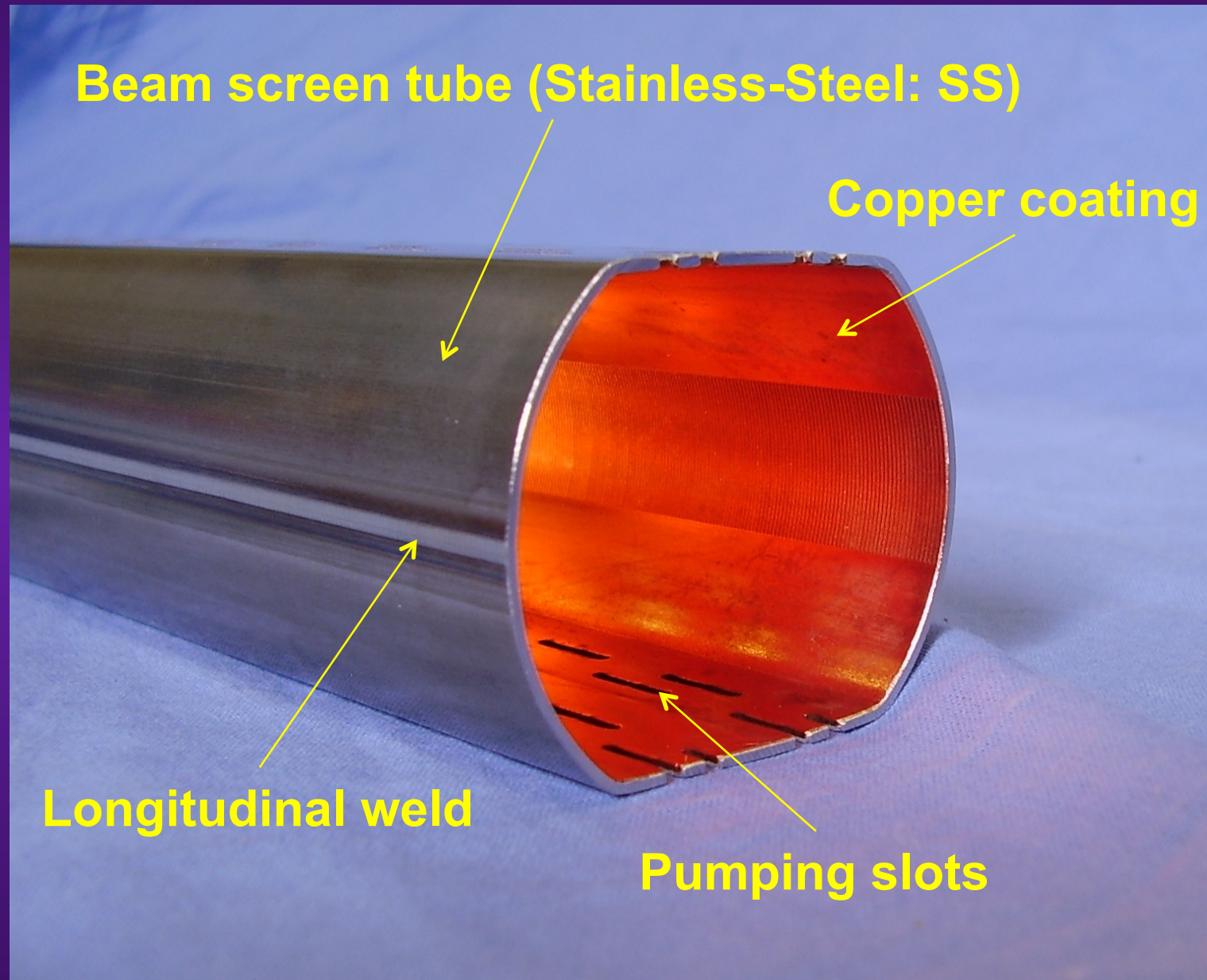
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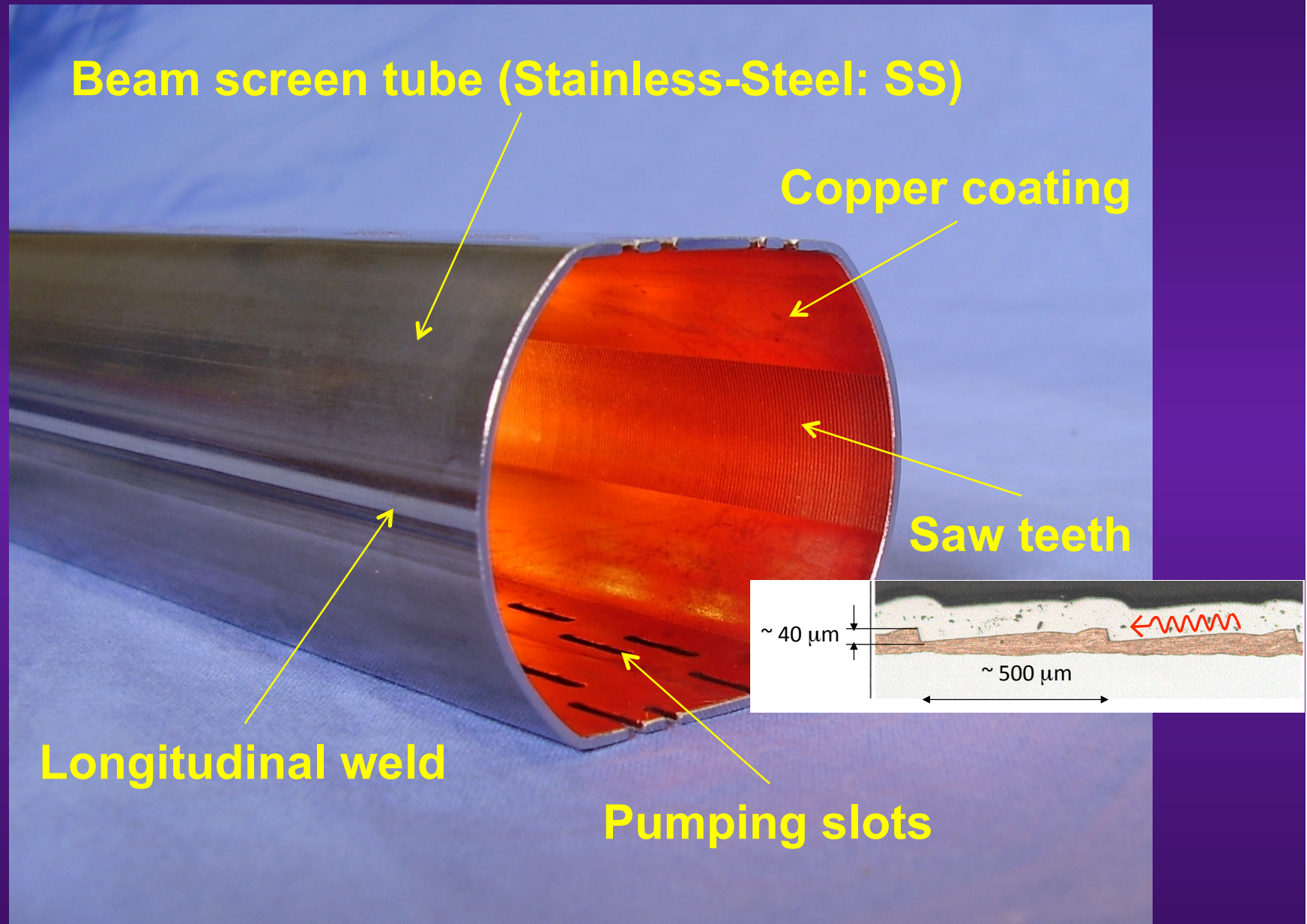
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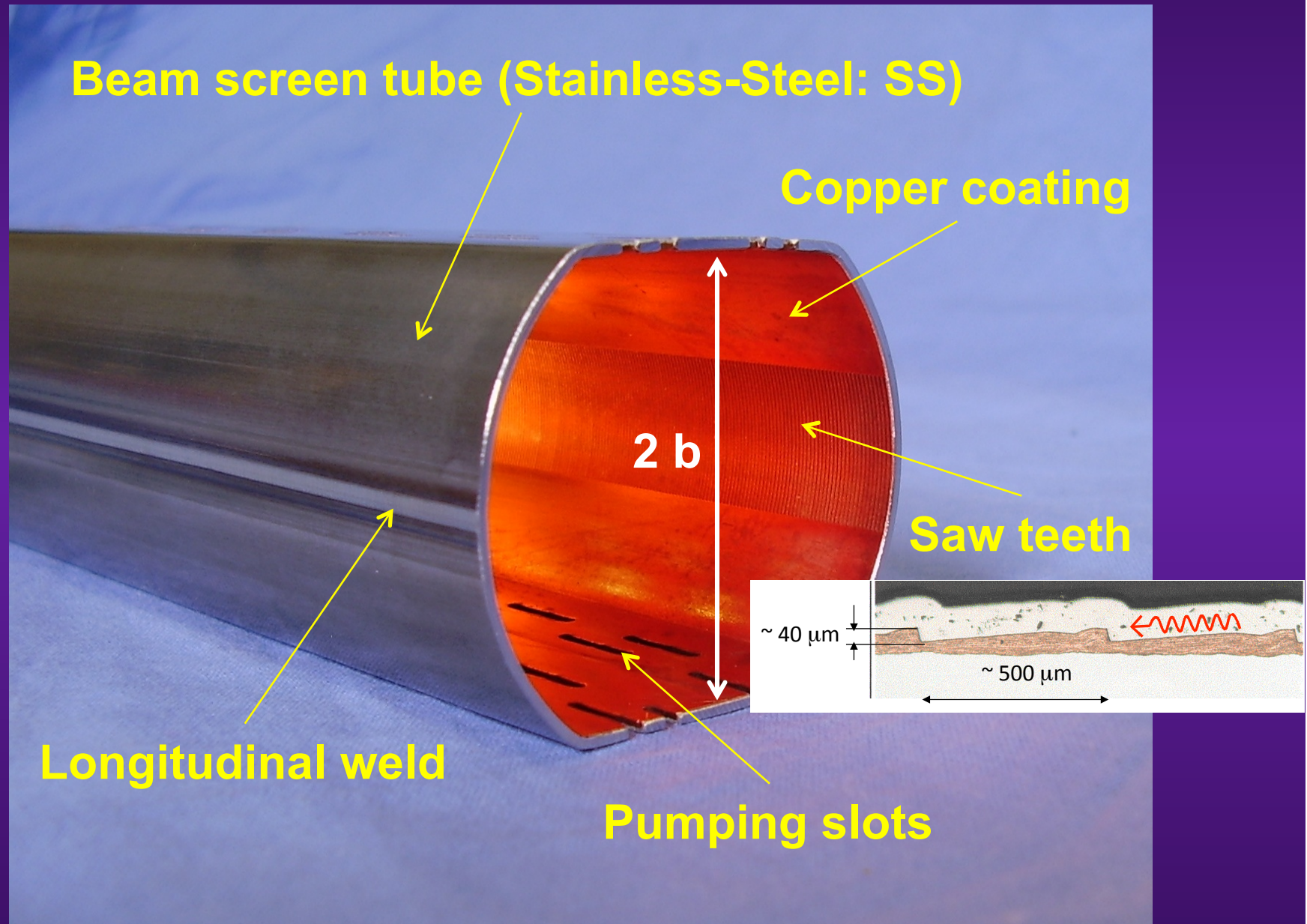
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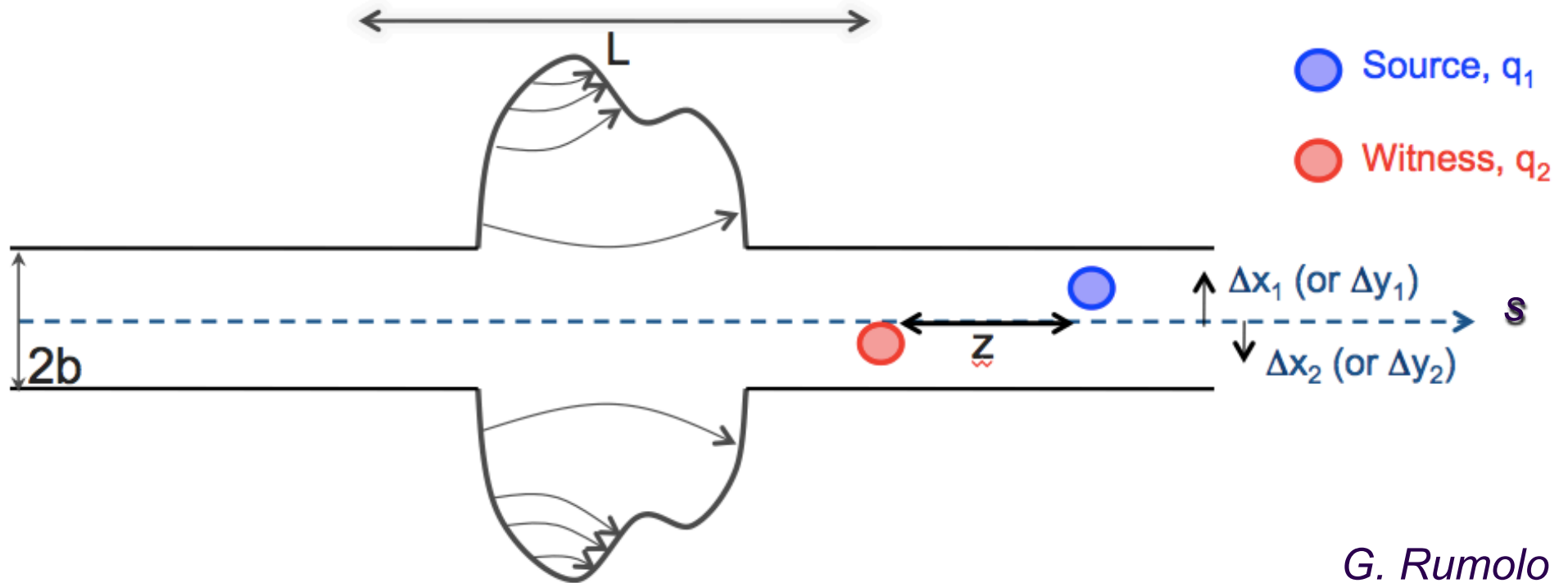
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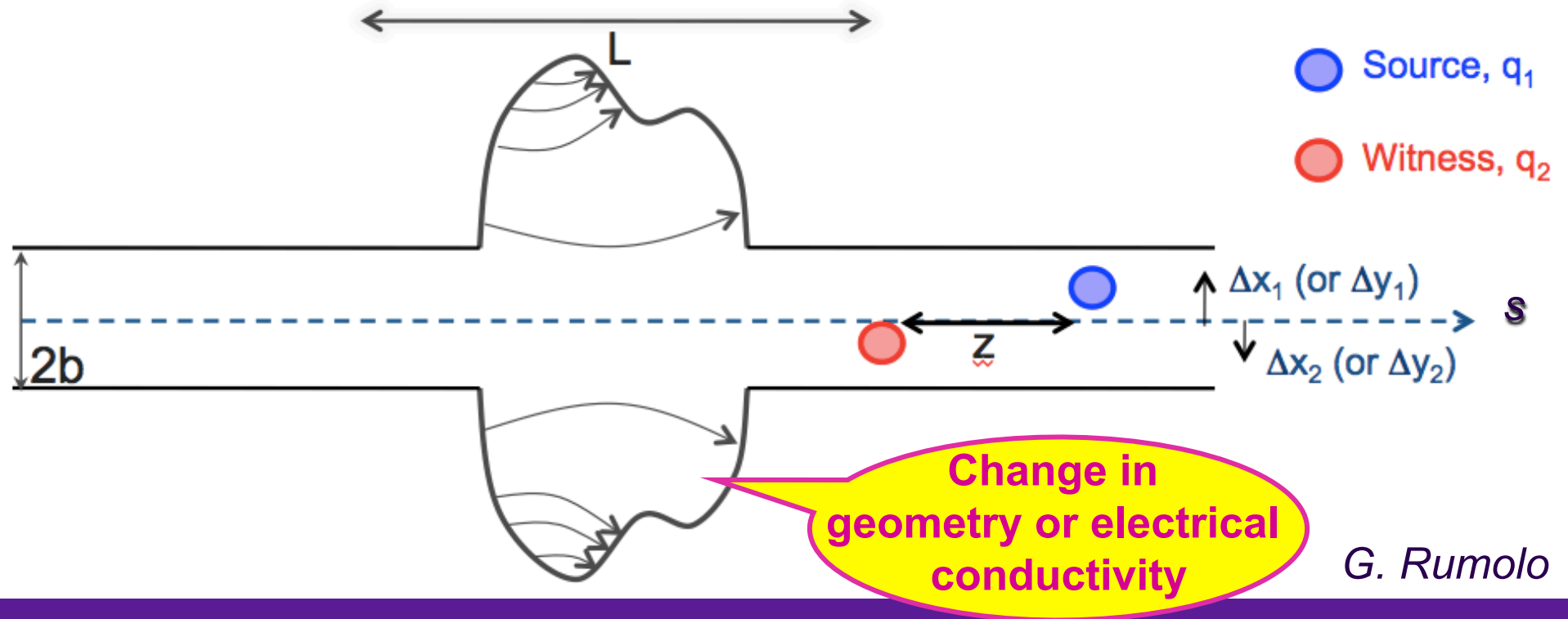


INTRODUCTION: THE IMPEDANCE



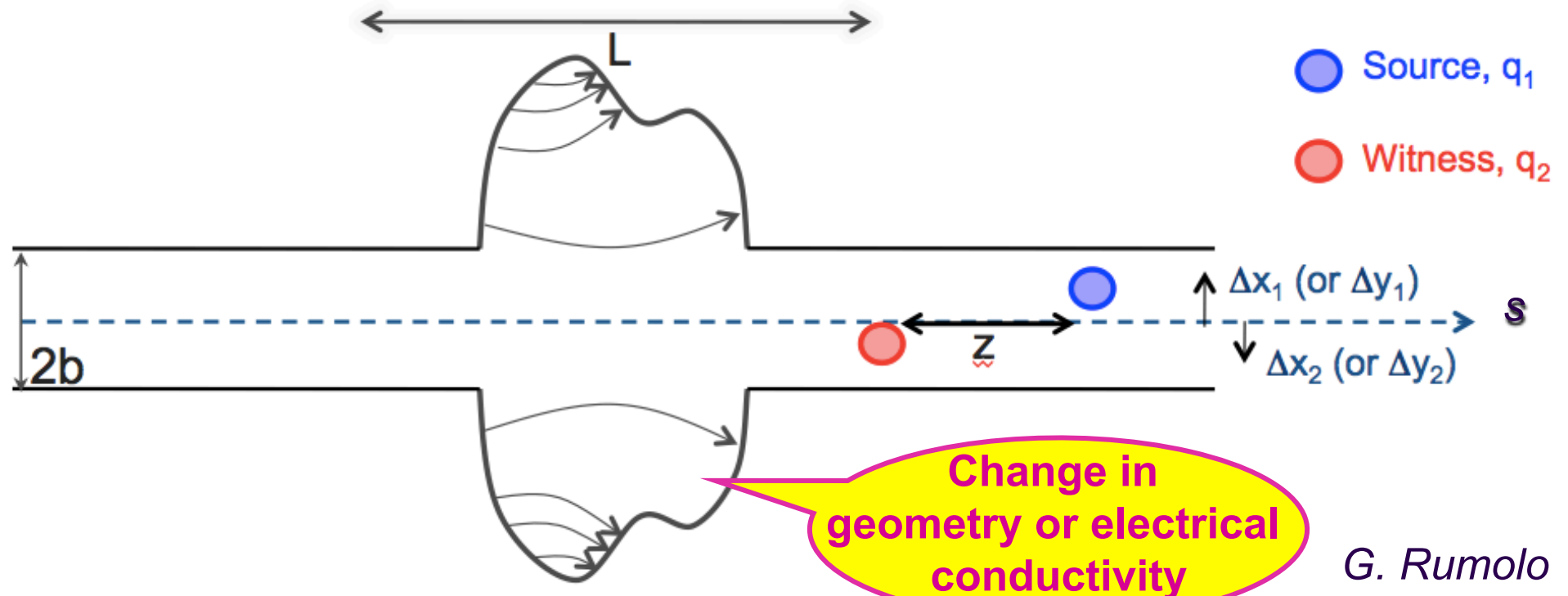
G. Rumolo

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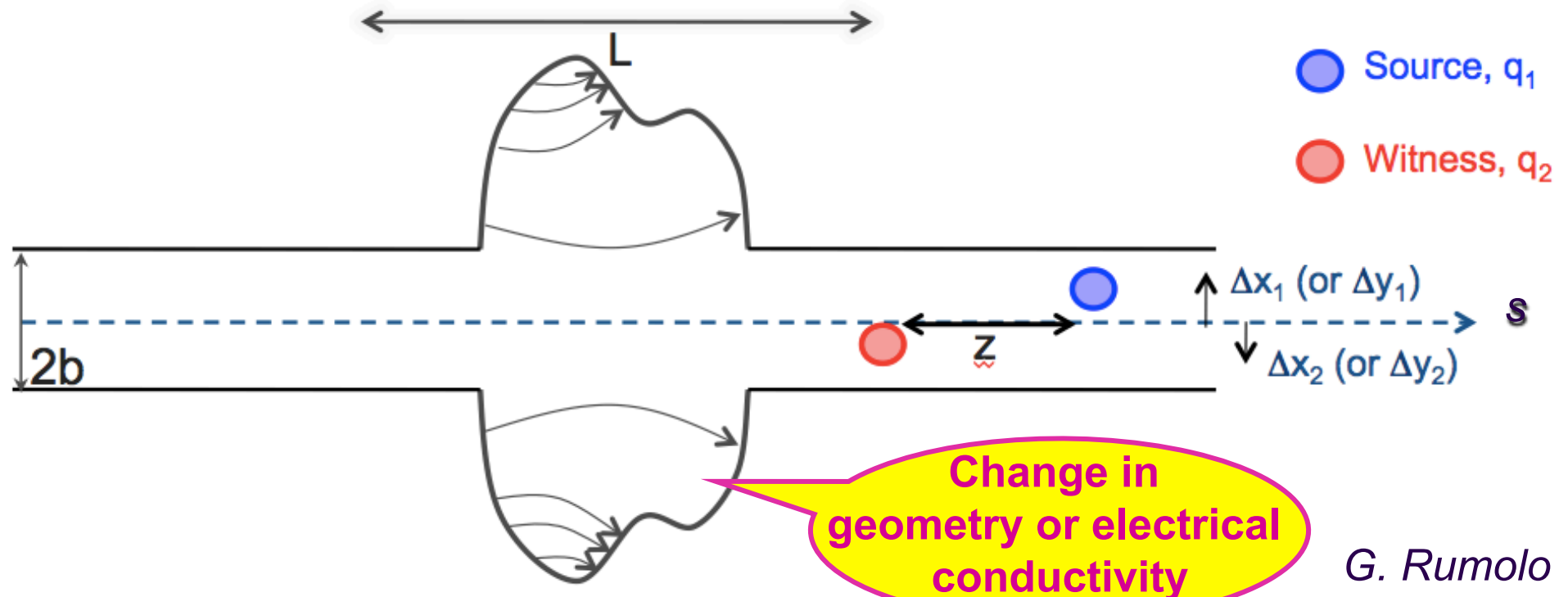
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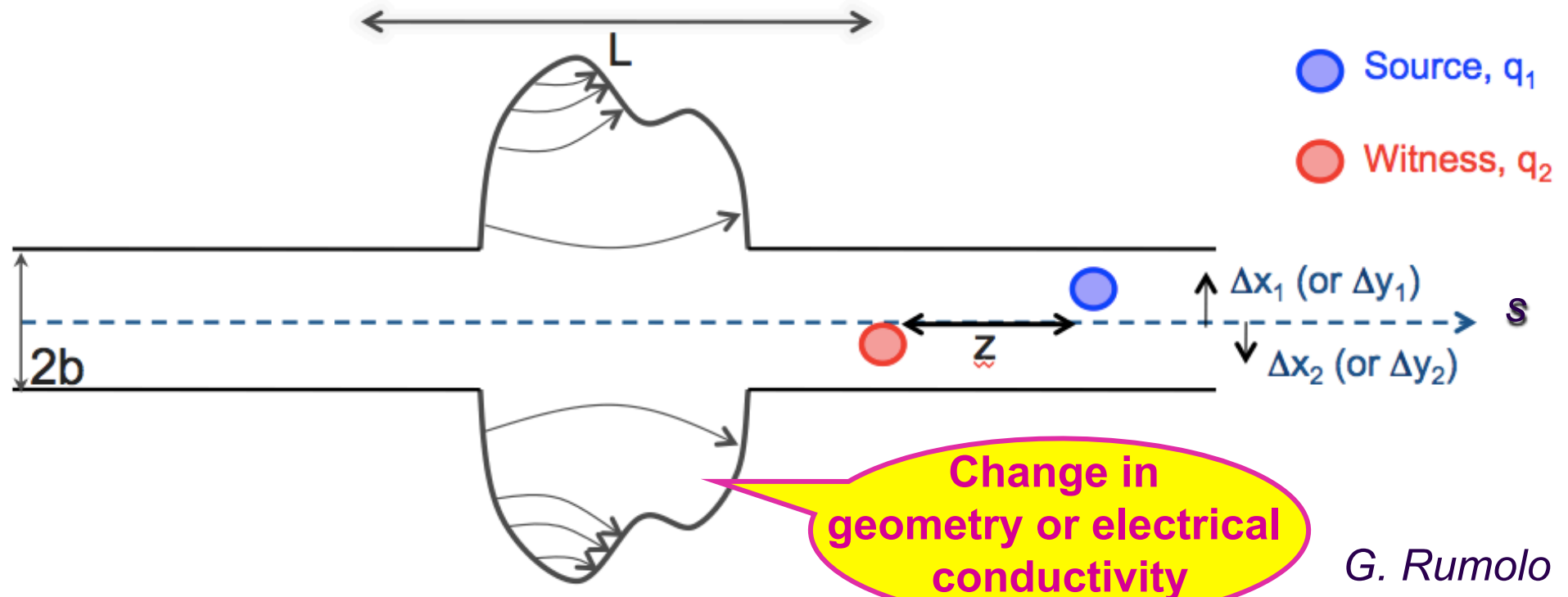
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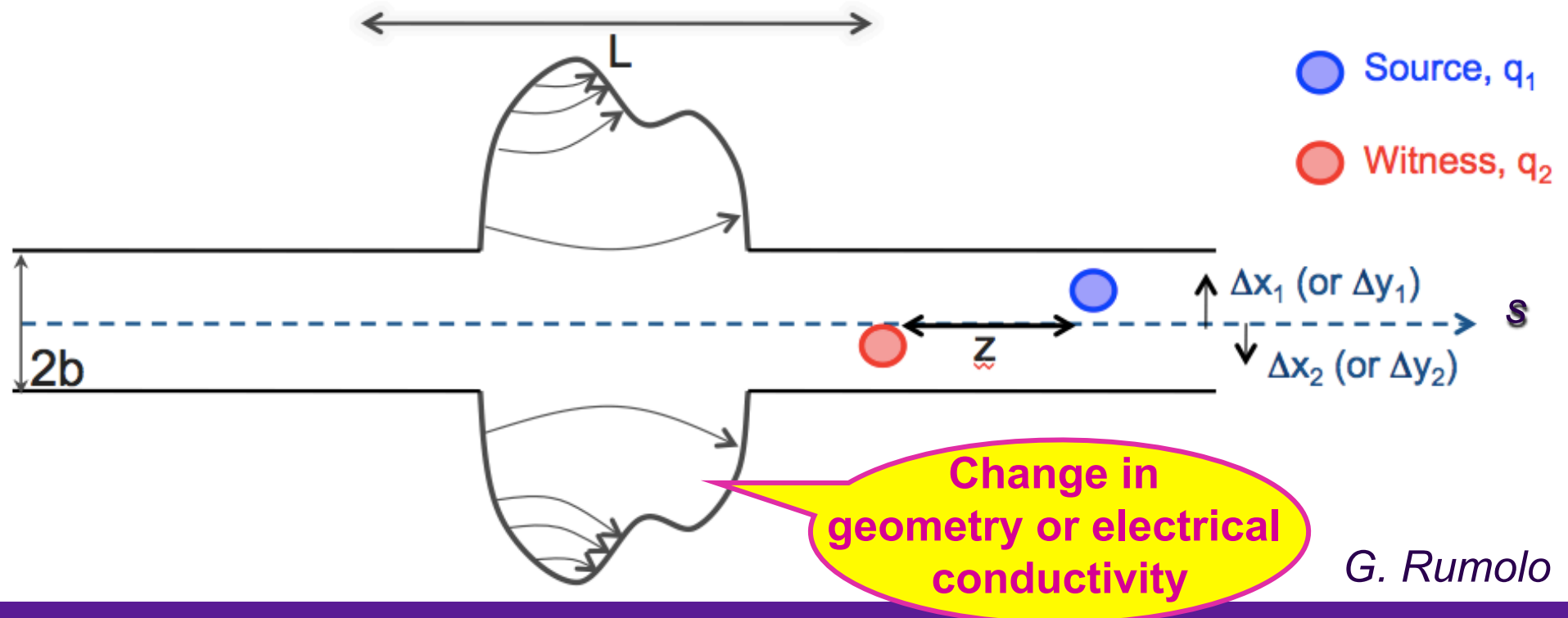
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- ◆ **Wake field** = Electromagnetic field generated by the beam interacting with its surroundings (vacuum pipe, etc.)
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- ◆ **Impedance** = Fourier transform of the wake field (wake function)

INTRODUCTION: THE IMPEDANCE

- ◆ 2 fundamental approximations behind the “conventional impedances / wakes”

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- Impulse approximation =>
$$v \Delta p = \int_0^L F ds$$


Wake potential

INTRODUCTION: THE IMPEDANCE

◆ Longitudinal case

$$\int_0^L F_l ds = -e^2 W_l(z)$$

Longitudinal wake
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Driving (or dipolar) wake

Detuning (or quadrupolar) wake

Angular wake =>
Fast damping in
VEPP-2 and BEP

INTRODUCTION: THE IMPEDANCE

- ◆ **The impedance is a complex function of frequency and at least 5 contributions are needed to correctly characterize an equipment**
 - Longitudinal impedance
 - Horizontal dipolar/driving impedance
 - Vertical dipolar/driving impedance
 - Horizontal quadrupolar/detuning impedance
 - Vertical quadrupolar/detuning impedance

In case of non axi-symmetric vacuum chambers (assuming that the particles are travelling at the speed of light => Assumption made in this talk)

CONTENTS

- ◆ **Frequency range of interest**
- ◆ **Copper coating: why and which thickness?**
- ◆ **Effect of transverse damper**
- ◆ **Effects of other coatings (e.g. a-C) or surface treatments (e.g. LESS) to fight against e-cloud**
- ◆ **Effect of HTS coating**
- ◆ **Longitudinal weld**
- ◆ **Pumping slots**
- ◆ **Conclusions**

a-C = amorphous carbon

LESS = Laser treatment of the surface

HTS = High Temperature Superconductor

FREQUENCY RANGE OF INTEREST

- ◆ **Cut-off frequency (above which modes are propagating)**

$$f_{cut-off}^{lowest} \text{ [GHz]} \approx \frac{10}{b \text{ [cm]}}$$

- **N.A. for LHC: $b \approx 2 \text{ cm} \Rightarrow f_{cut-off} \approx 5 \text{ GHz}$**

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◆ Lower limit \Rightarrow First Unstable (transverse) Betatron Line:

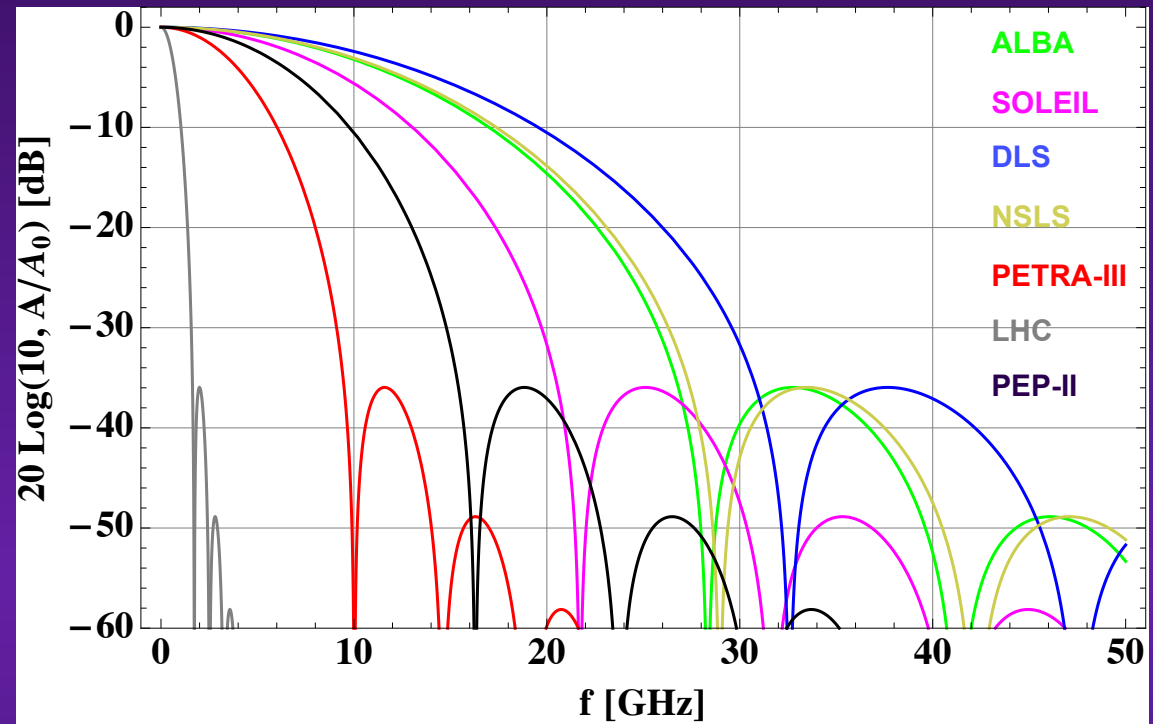
$$f_{FUBL} = (n - Q) f_{rev}$$

- N.A. for LHC: $(1 - 0.31) \times 11245 \approx 8 \text{ kHz}$

FREQUENCY RANGE OF INTEREST

◆ Bunch length and bunch spectrum

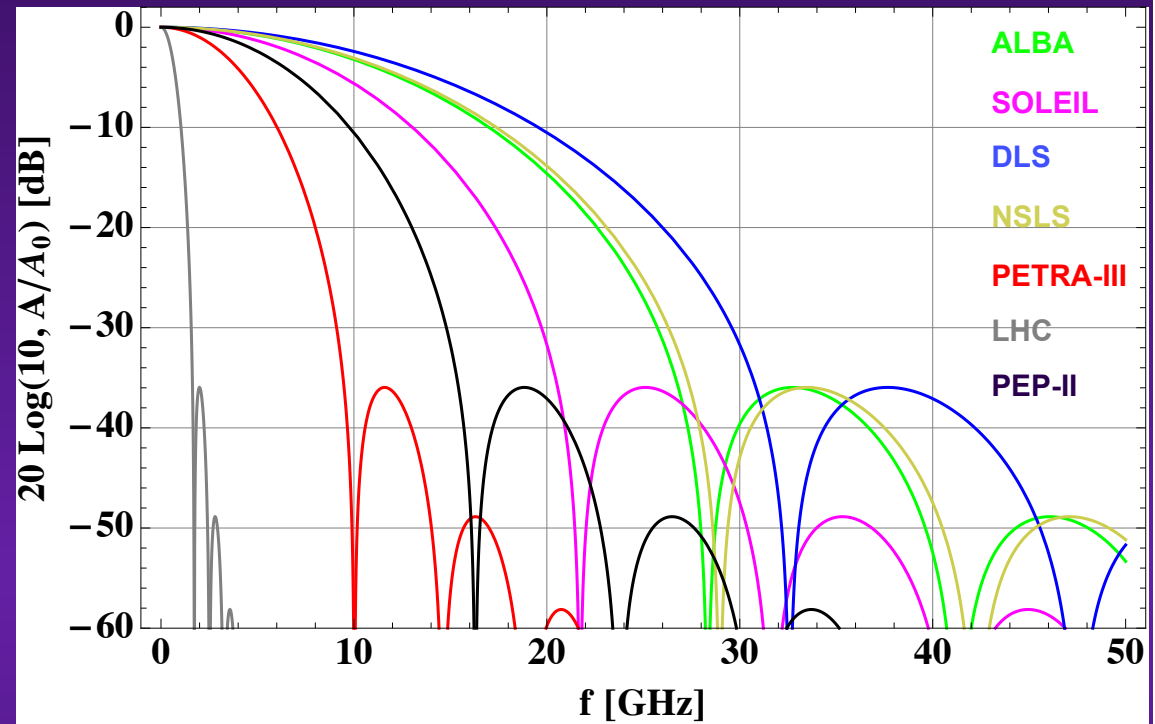
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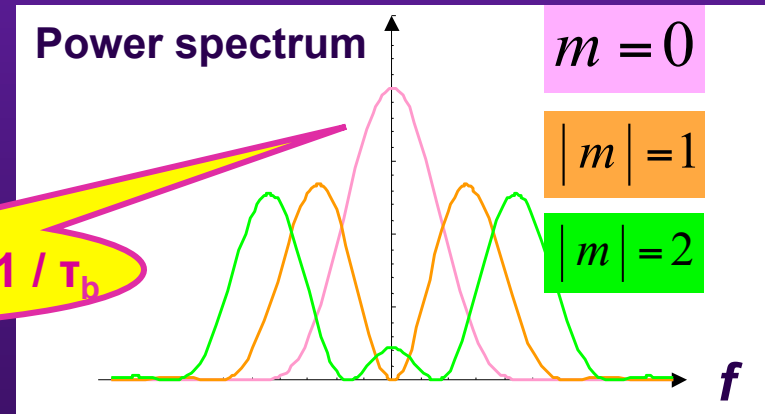
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◆ Some higher-order modes can also be excited and lead to longitudinal and/or transverse instabilities

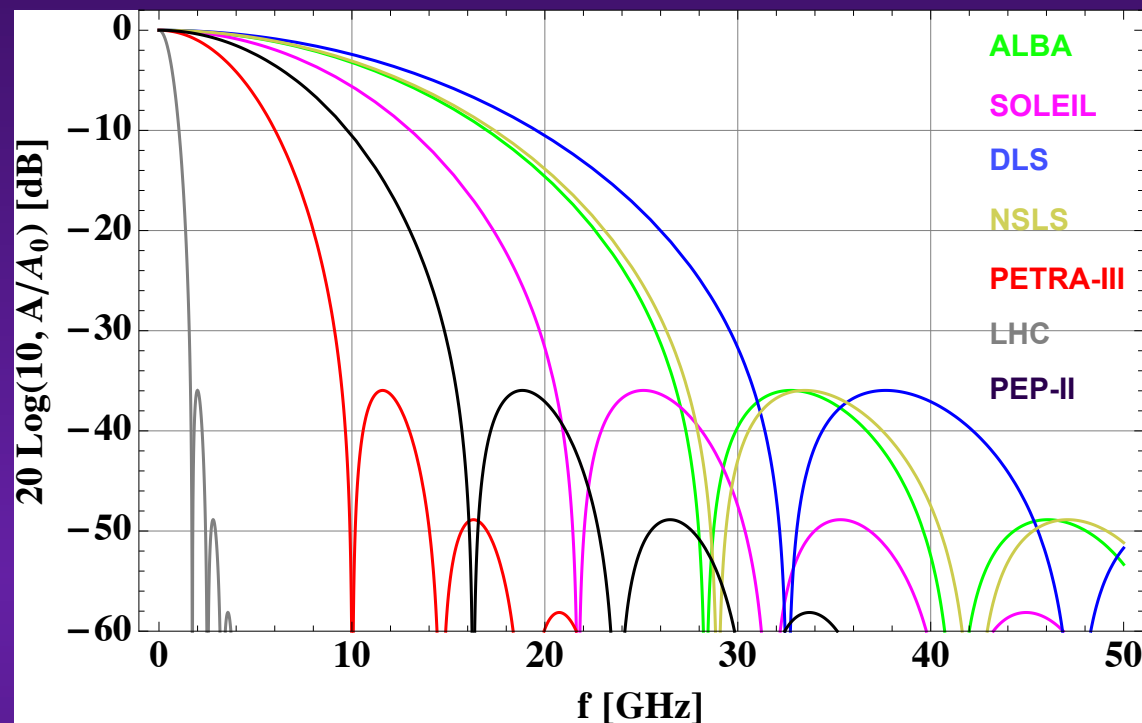
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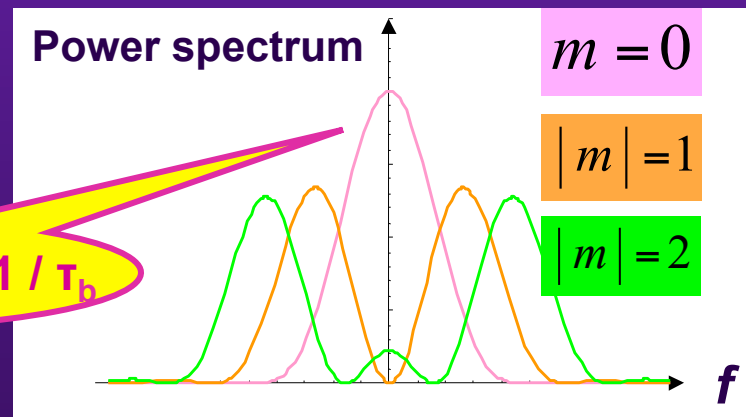
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=> For LHC: from 8 kHz to few GHz



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 - Transverse Mode-Coupling Instability: TMCI => High-frequency

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$$P_{loss/m}^{G,RW,1layer} = \frac{1}{2\pi R} \Gamma\left(\frac{3}{4}\right) \frac{M}{b} \left(\frac{N_b e}{2\pi}\right)^2 \sqrt{\frac{c \rho Z_0}{2}} \sigma_t^{-3/2} \approx 101 \text{ mW/m}$$

$$\Gamma\left(\frac{3}{4}\right) = 1.23$$

Euler gamma function

$$M = 2808$$

$$N_b = 1.15 \times 10^{11} \text{ p/b}$$

$$\sigma_t = 0.25 \text{ ns}$$

$$\begin{aligned} \text{LHC circumference} &= L \\ &= 2\pi R = 26658.883 \text{ m} \end{aligned}$$

$$\rho_{Cu}^{20K,7TeV} = 7.7 \times 10^{-10} \Omega\text{m}$$

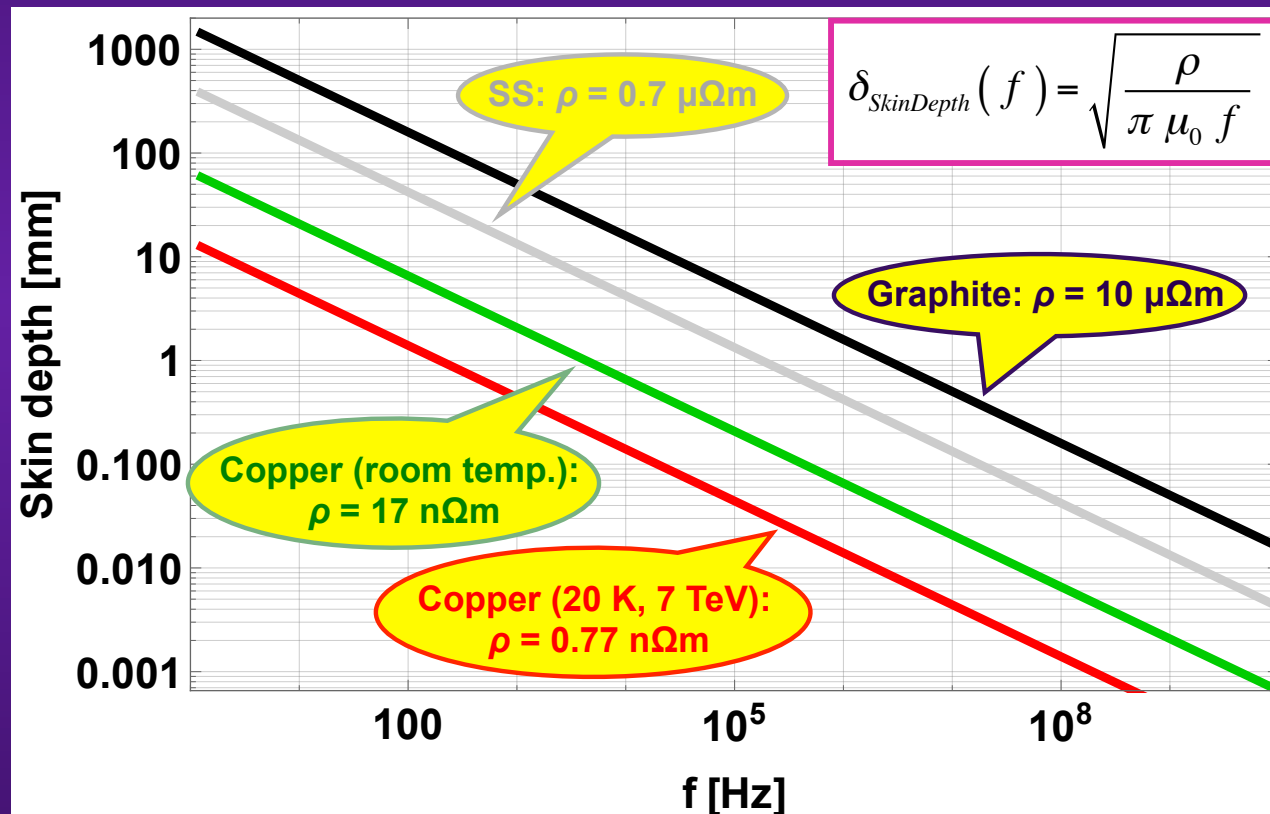
$$b = \text{beam screen half height} = 36.8 / 2 = 18.4 \text{ mm}$$

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 - For SS for instance, the power loss would be ~ 30 times more
 - Thickness of Cu (20 K, 7 TeV) coating => 1 (few) μm enough

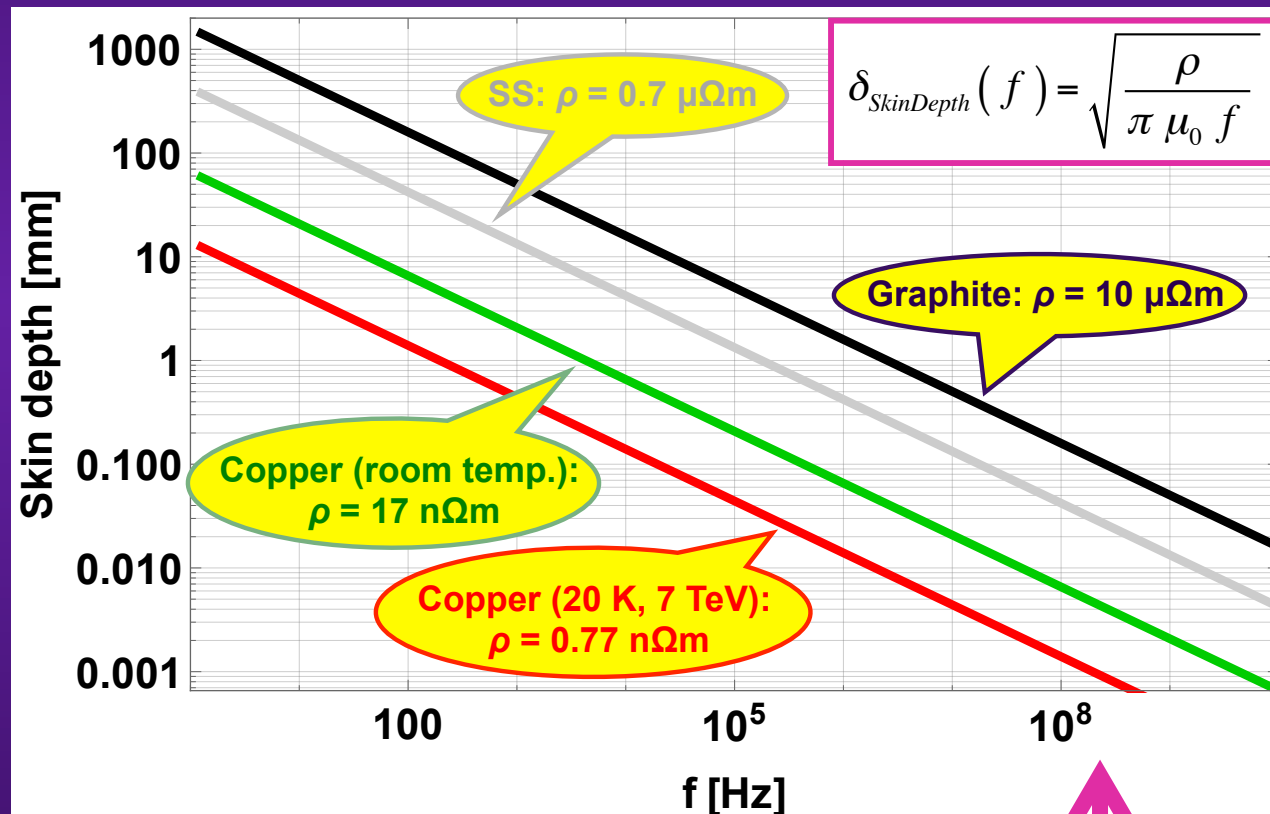
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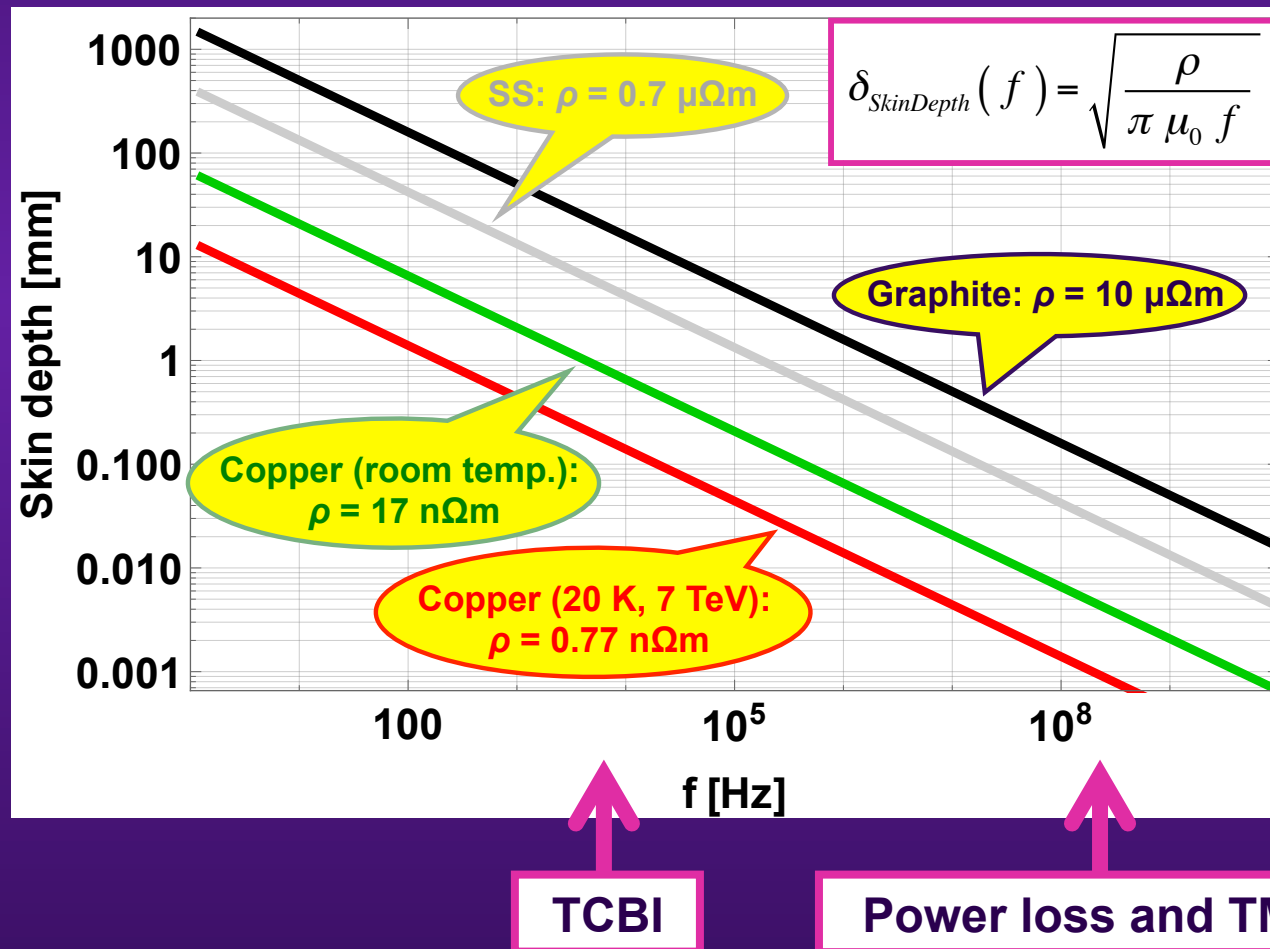
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Power loss and TMCI

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Instability rise-time
(in the thick-wall
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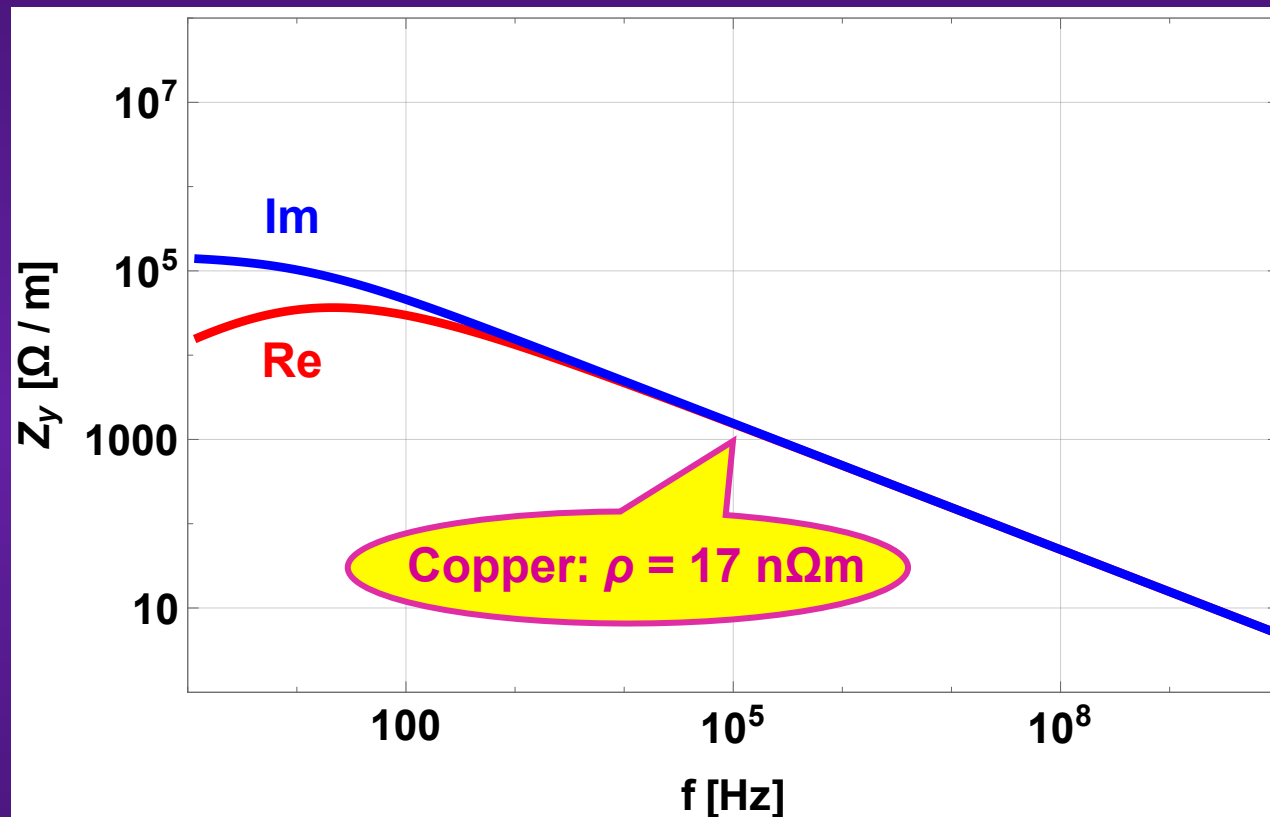
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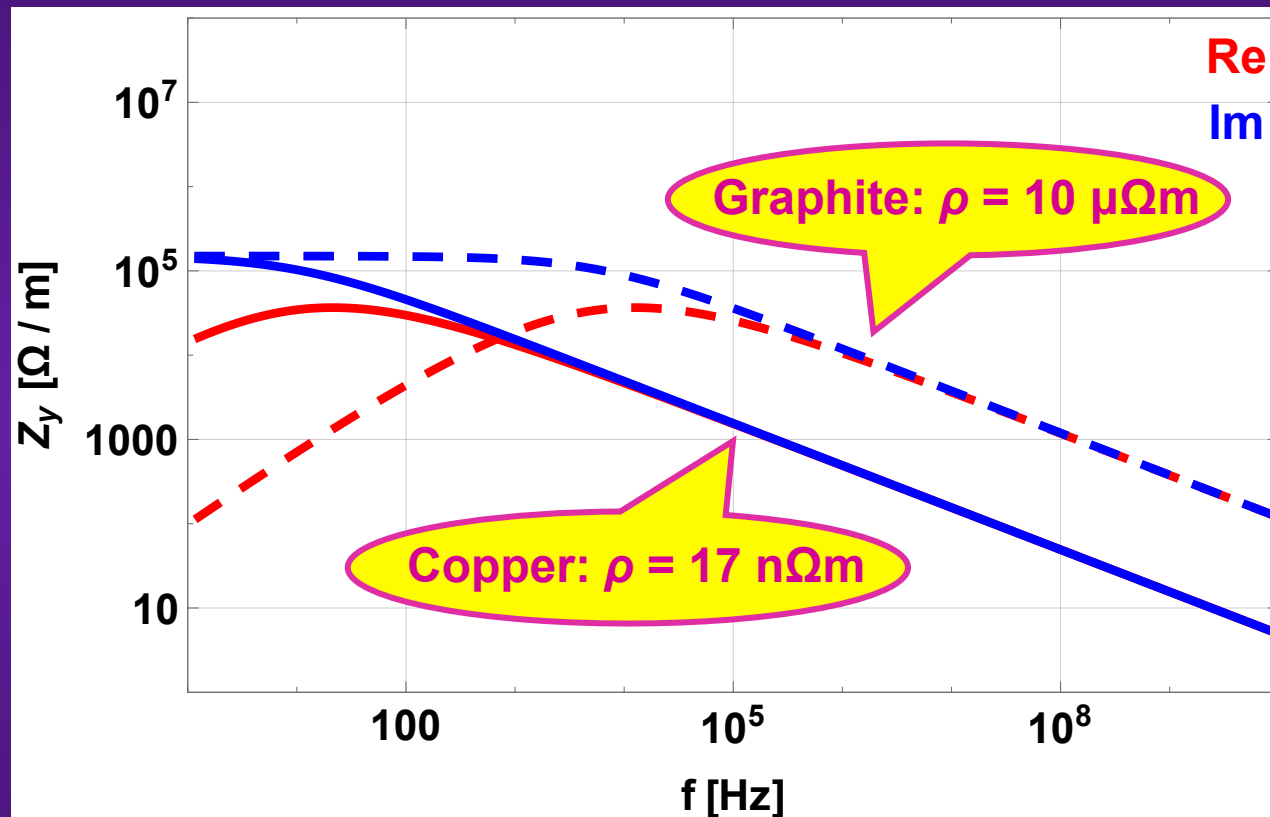
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- Previous plot reveals why in this case few tens / hundreds of μm are needed (at low frequency, **IF we are in the thick-wall regime**)
- This thick-wall regime is for instance not the case with the LHC collimators...

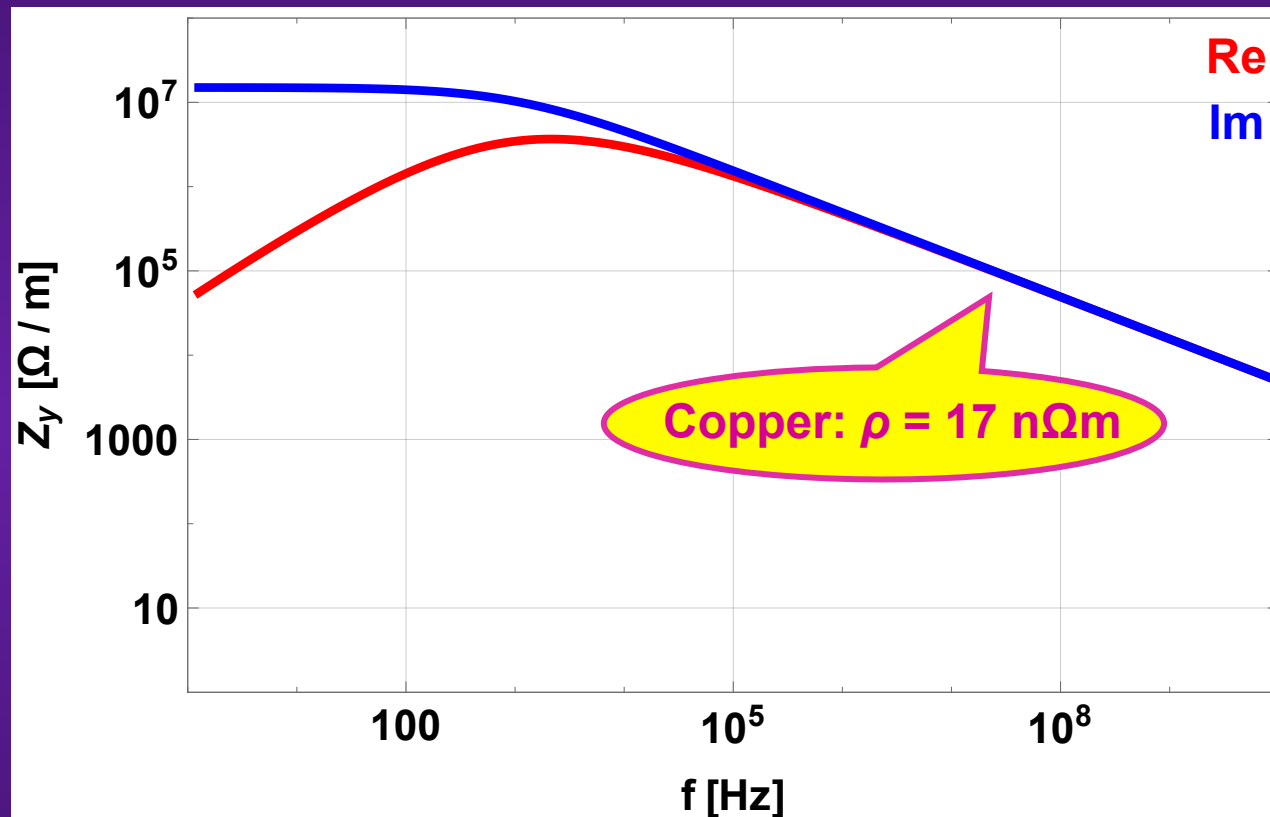
LHC beam pipe: round, 20 mm radius, 1 m long



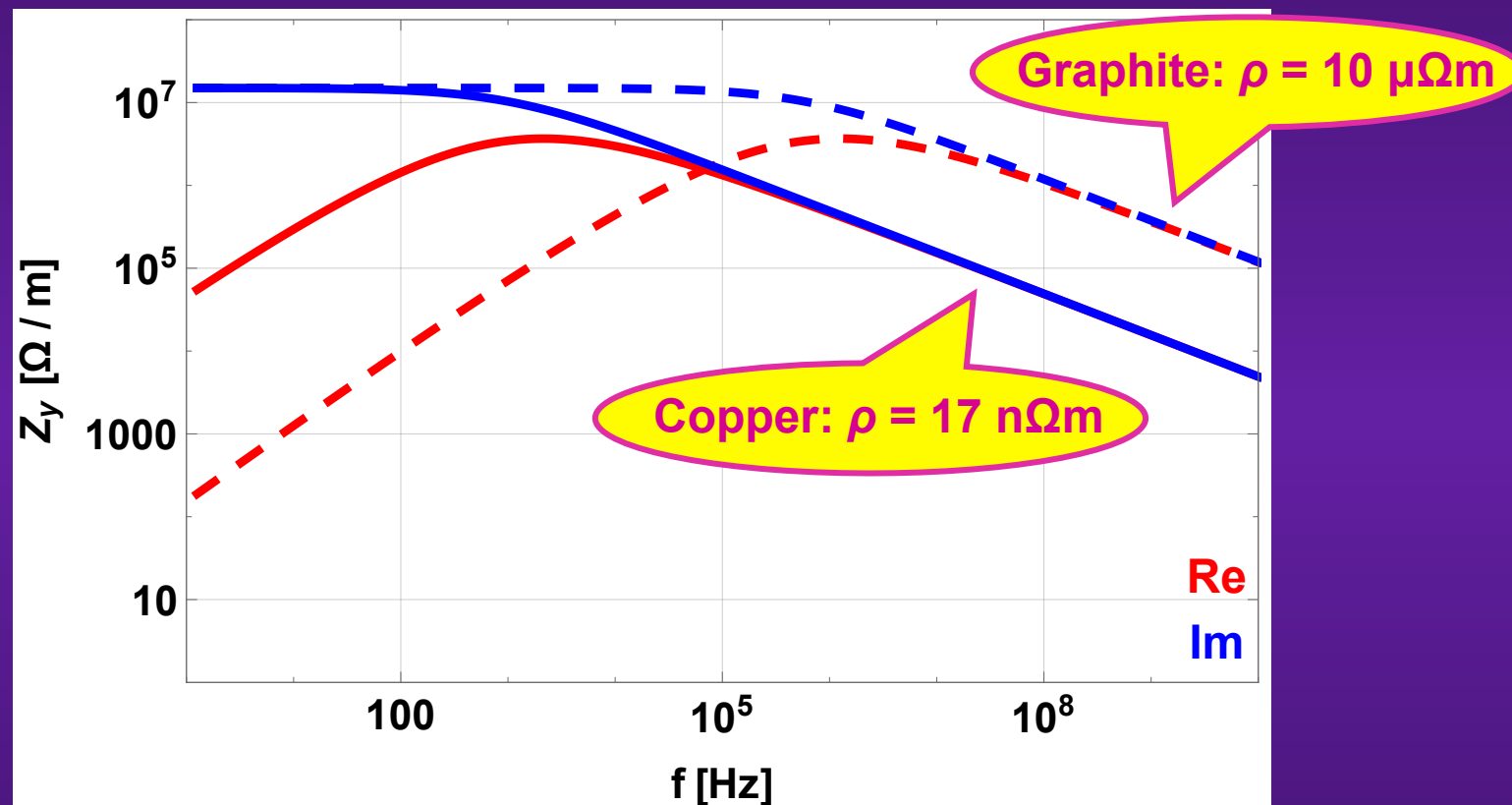
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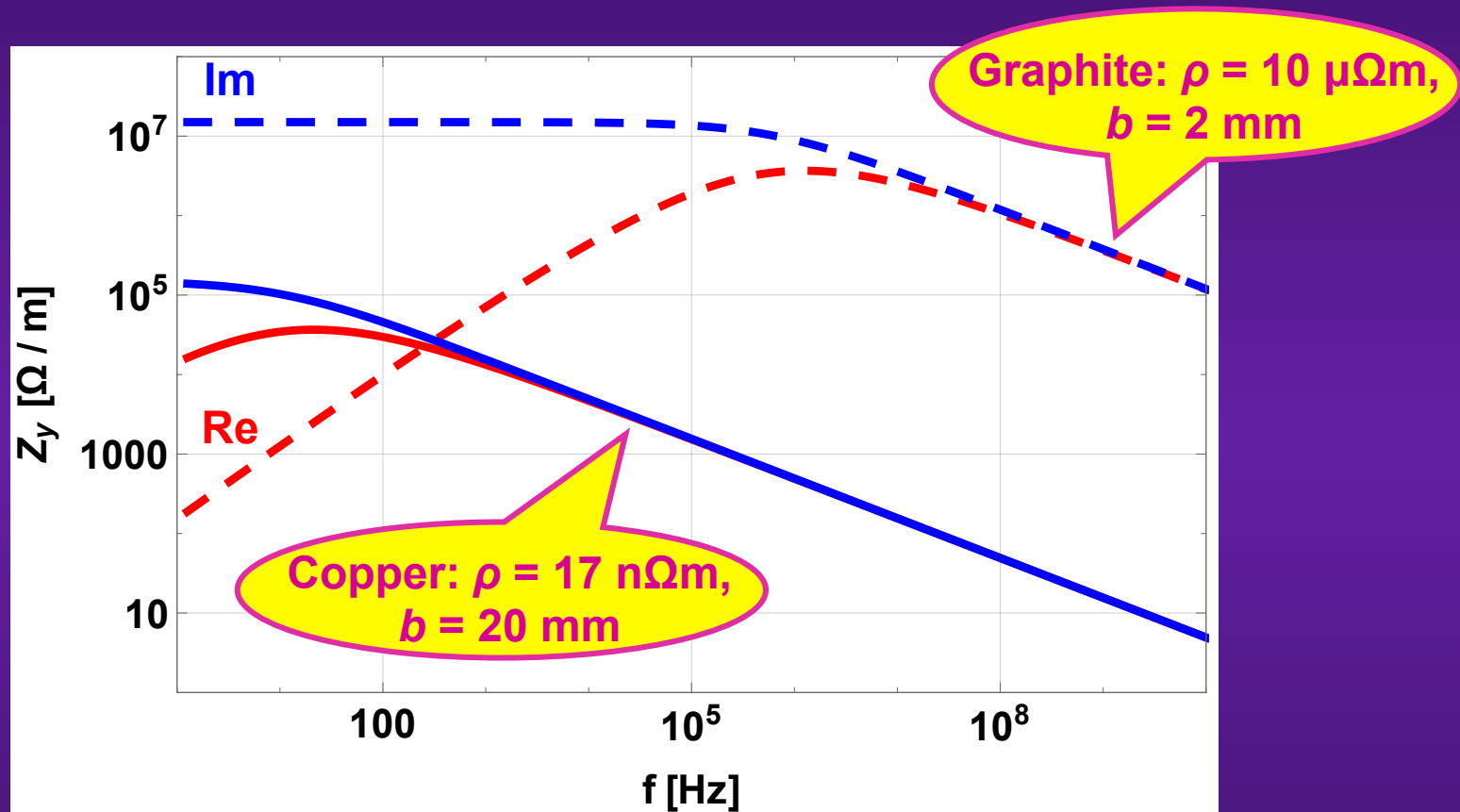
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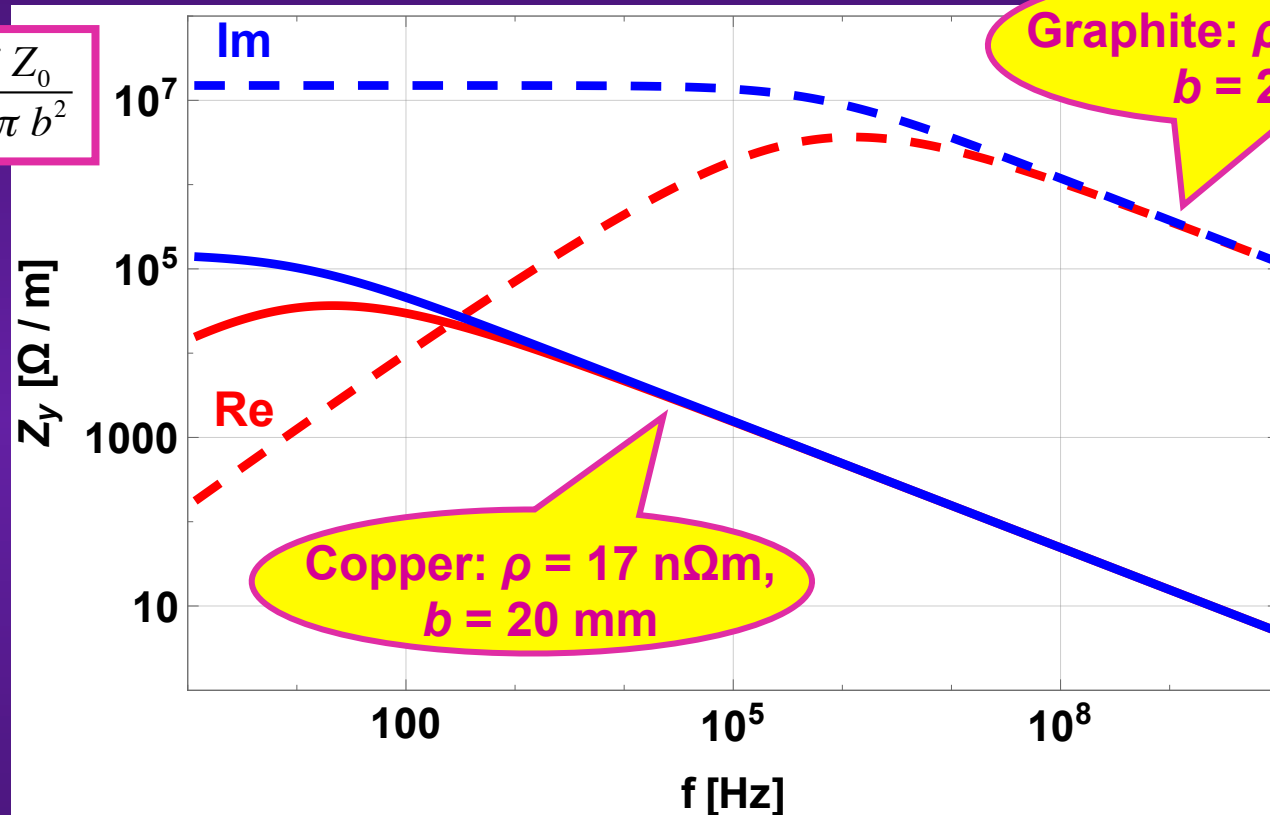


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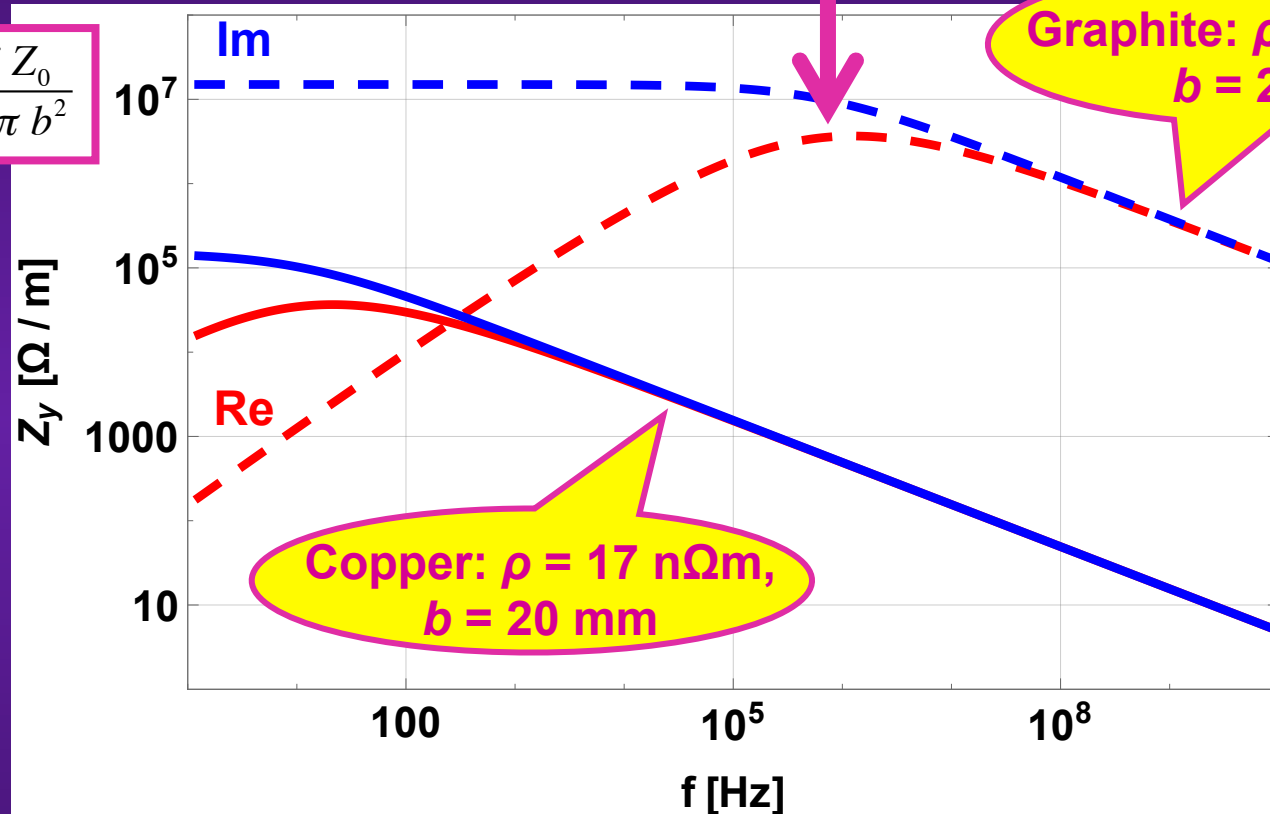
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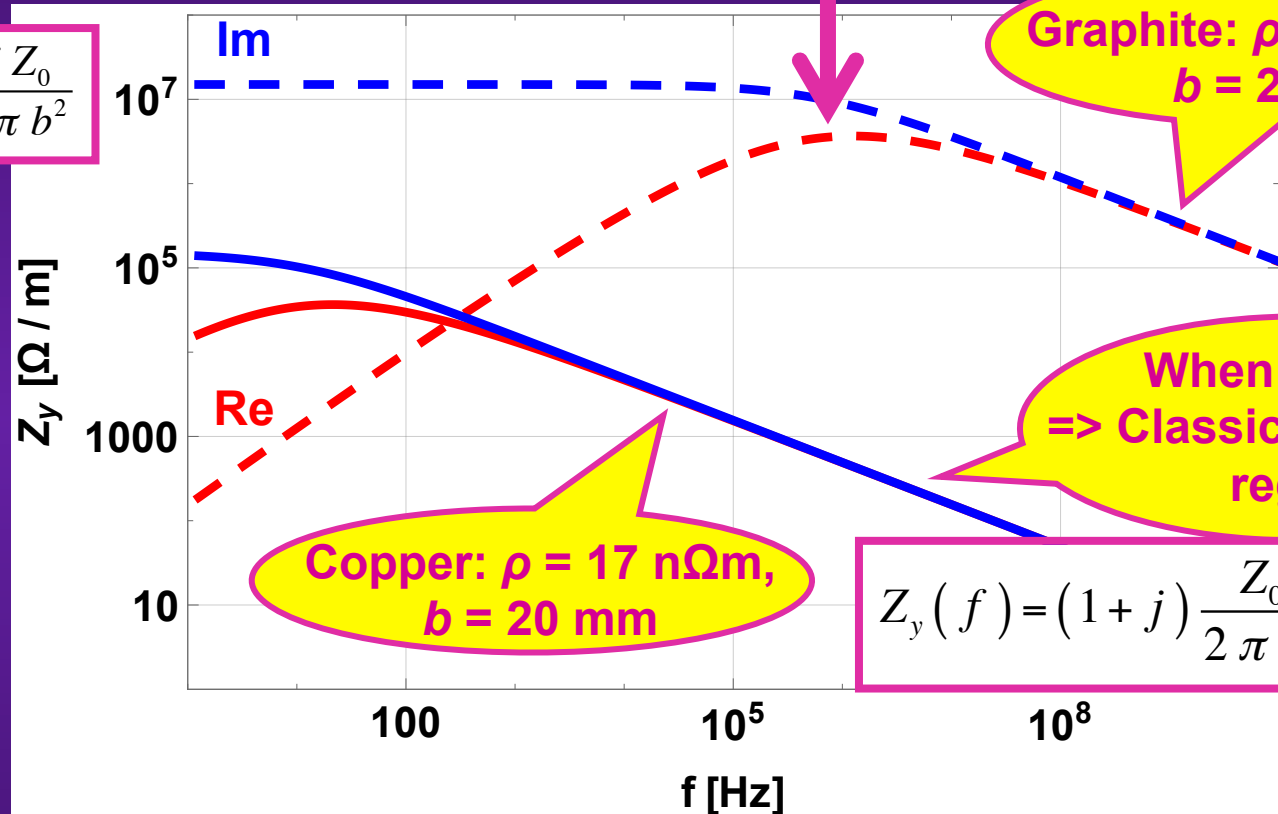
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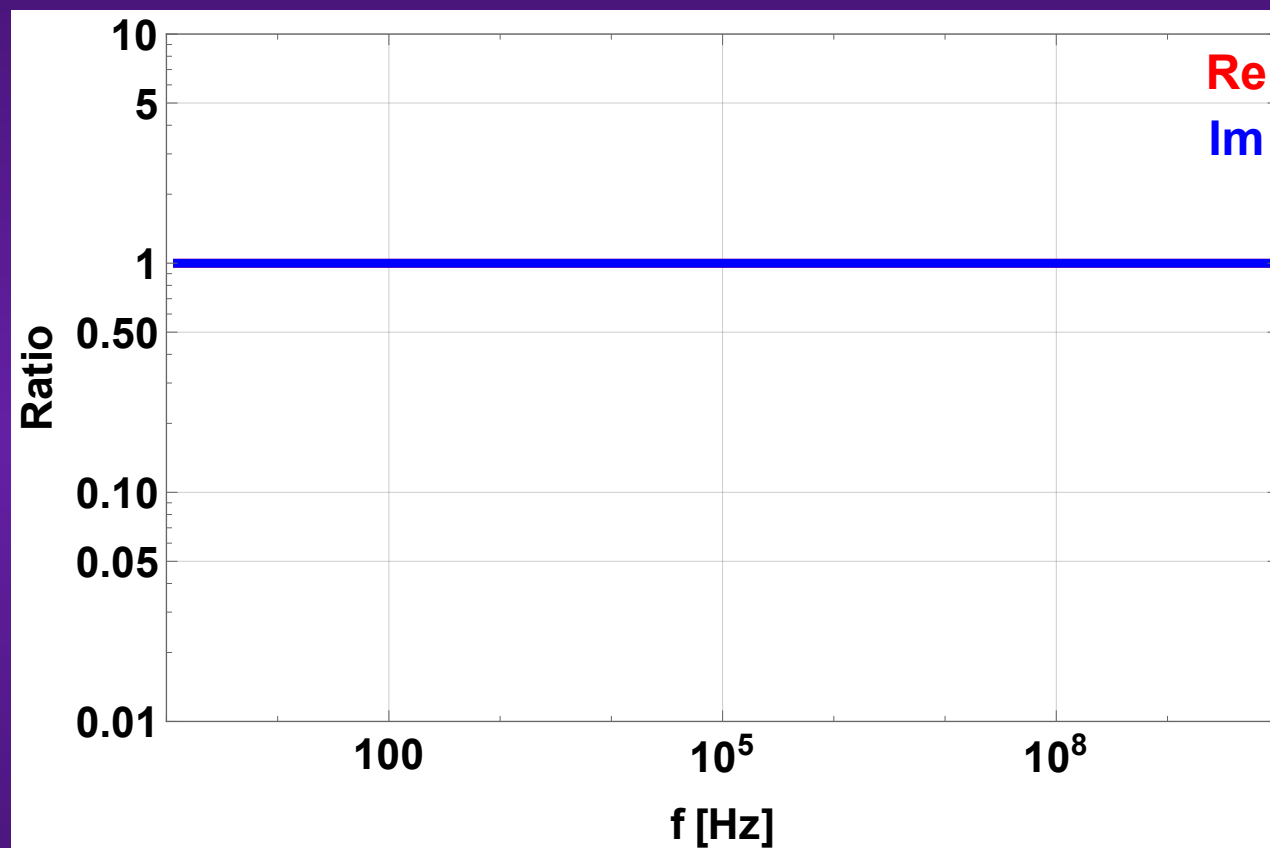
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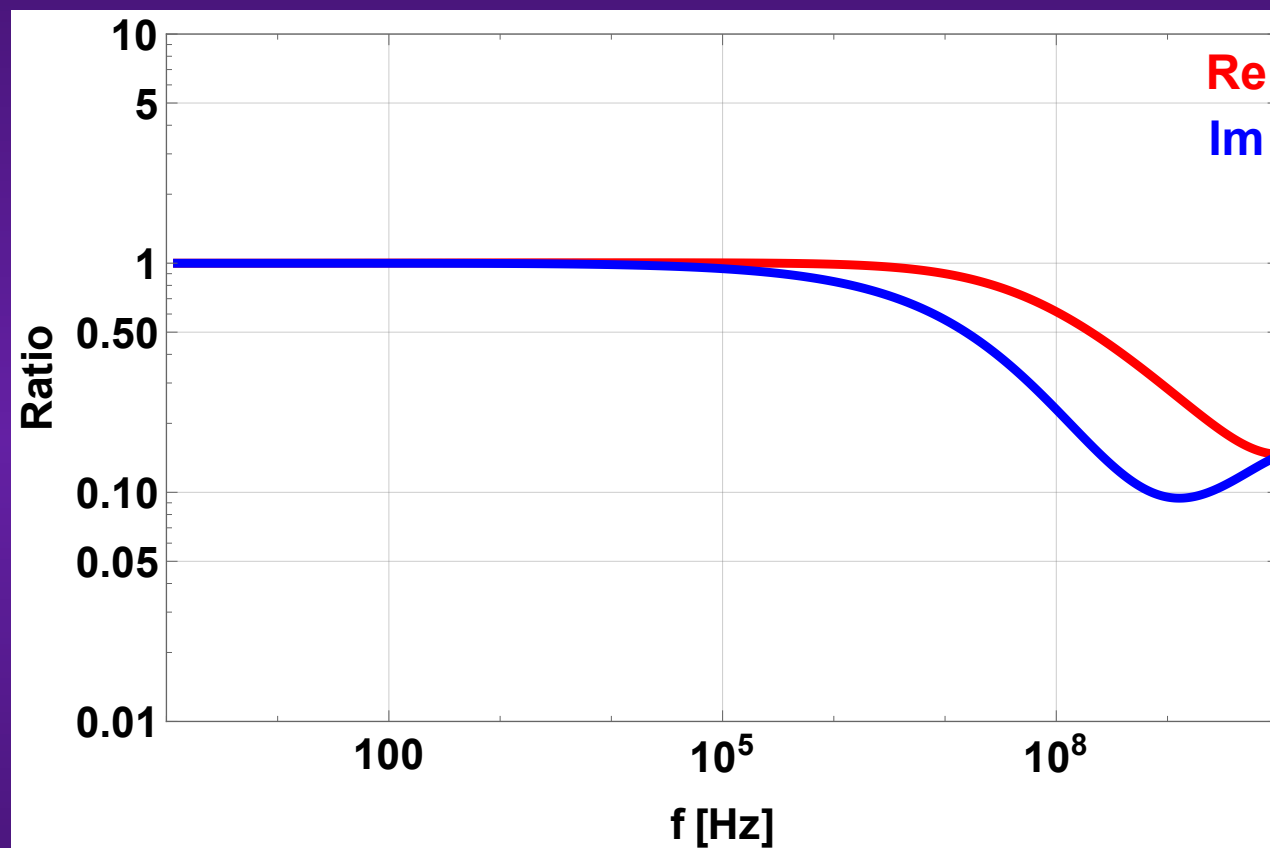
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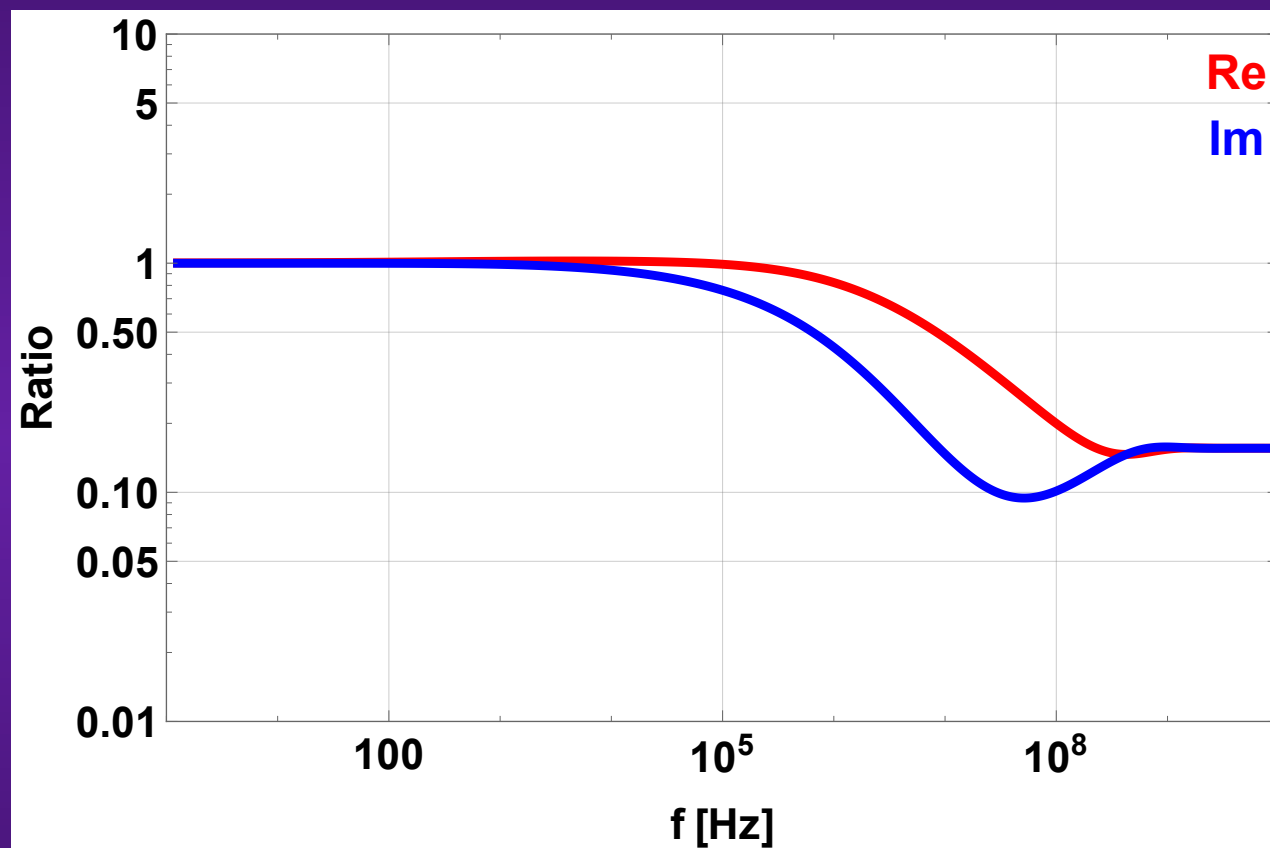
SS beam pipe with 20 mm radius and 0 μm copper coating (room temp.)



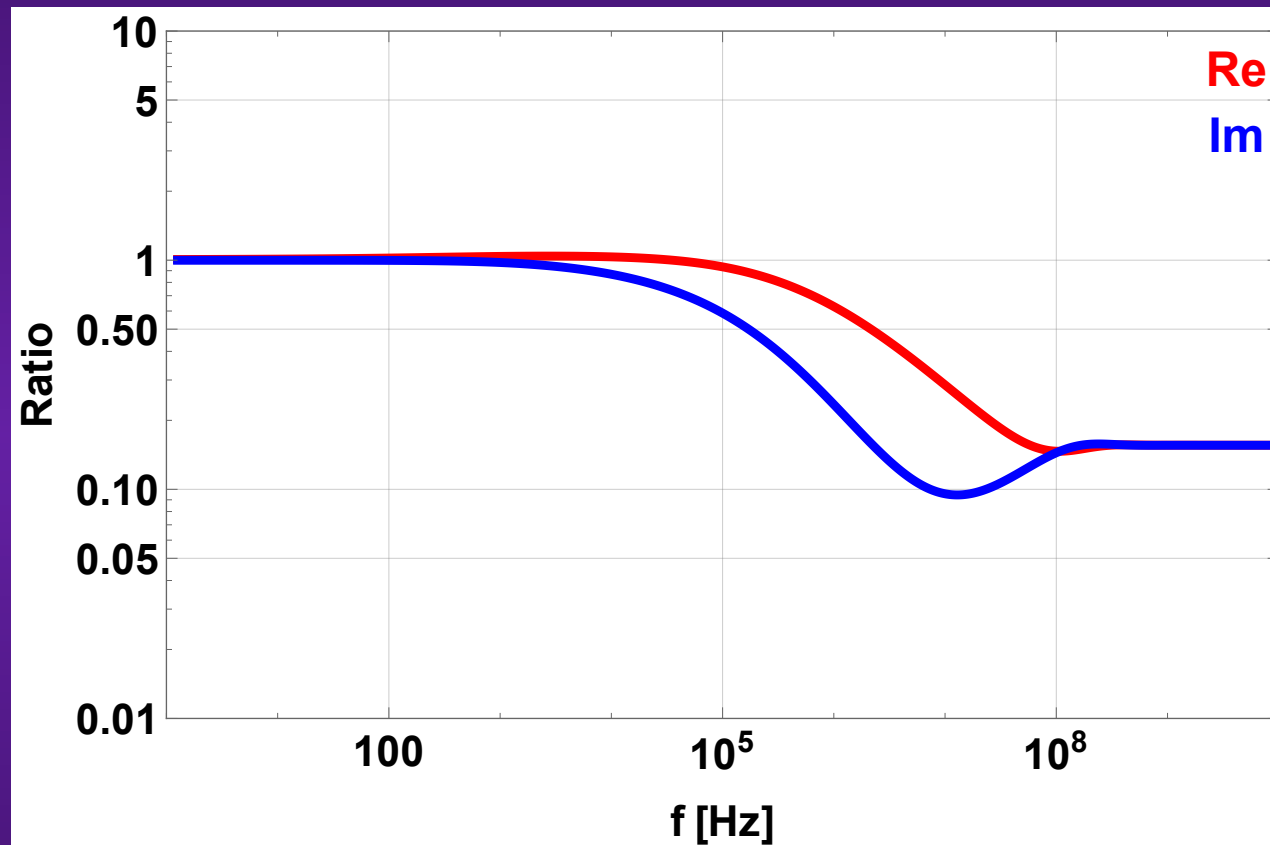
SS beam pipe with 20 mm radius and 1 μm copper coating (room temp.)



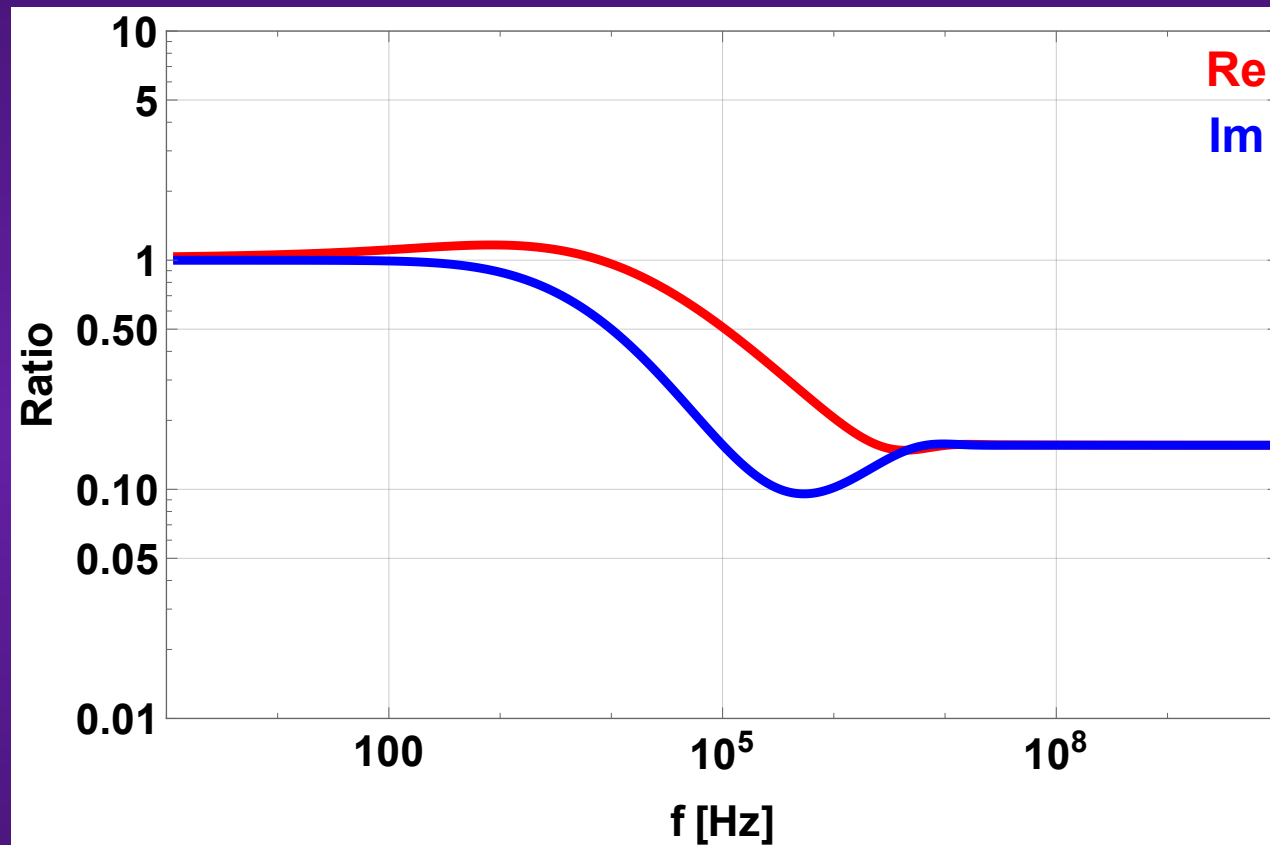
SS beam pipe with 20 mm radius and 5 μm copper coating (room temp.)



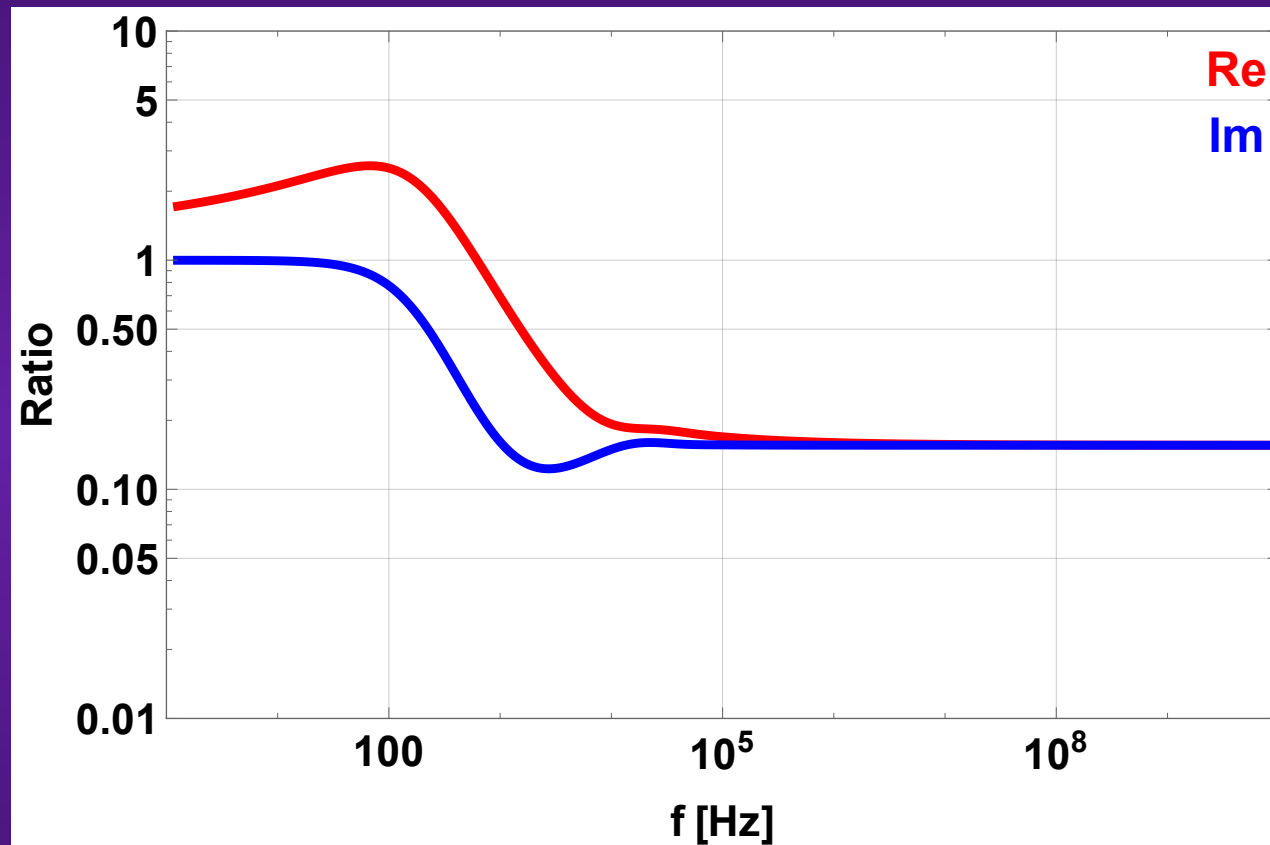
SS beam pipe with 20 mm radius and 10 μm copper coating (room temp.)



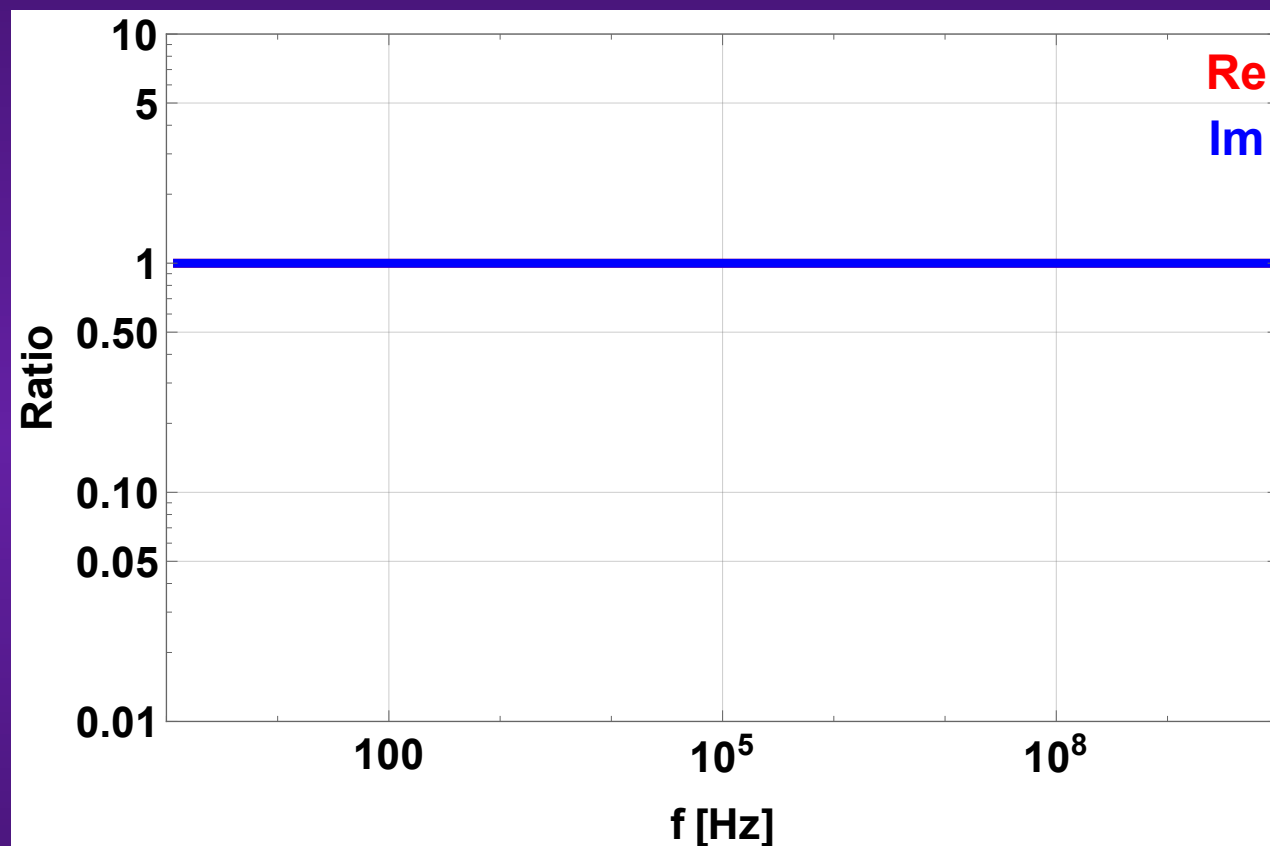
SS beam pipe with 20 mm radius and 50 μm copper coating (room temp.)



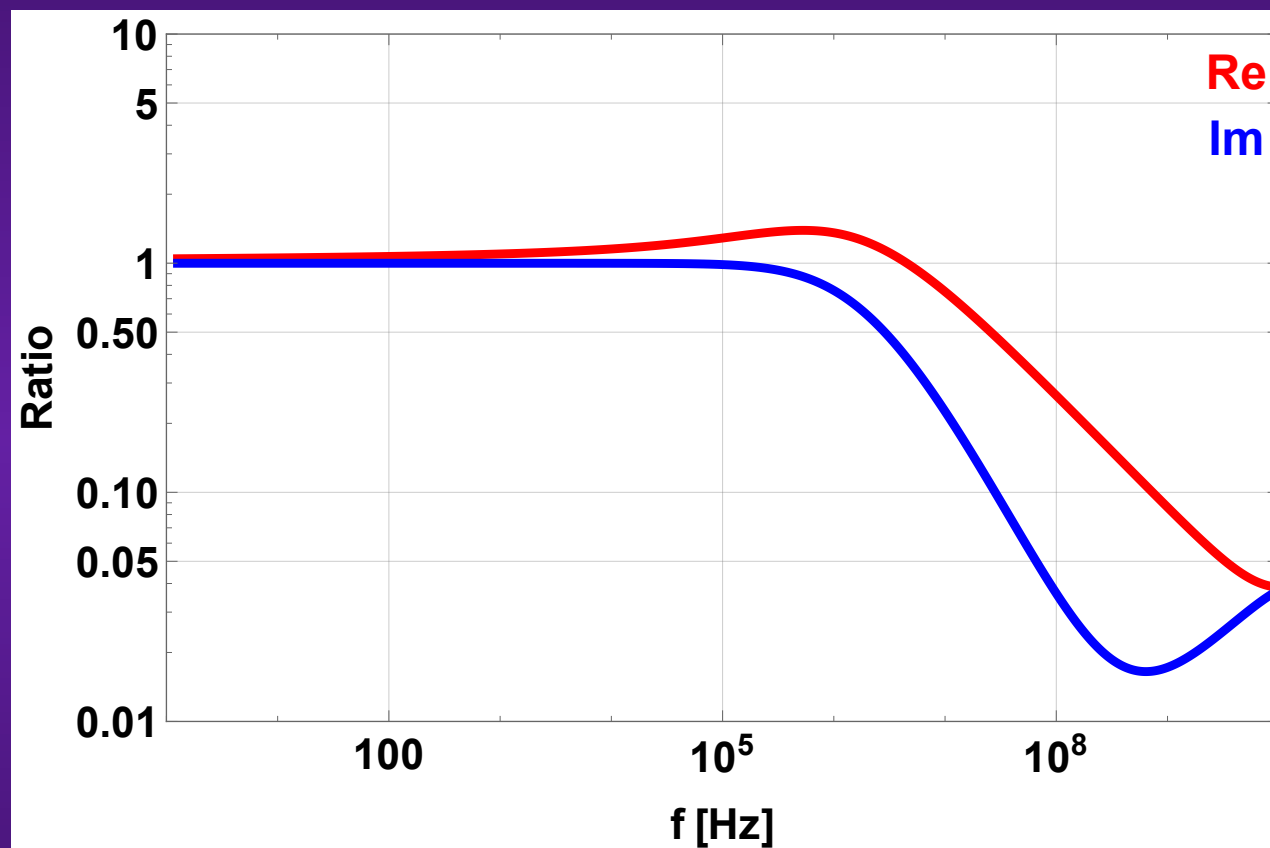
SS beam pipe with 20 mm radius and 1000 μm = 1 mm copper coating (room temp.)



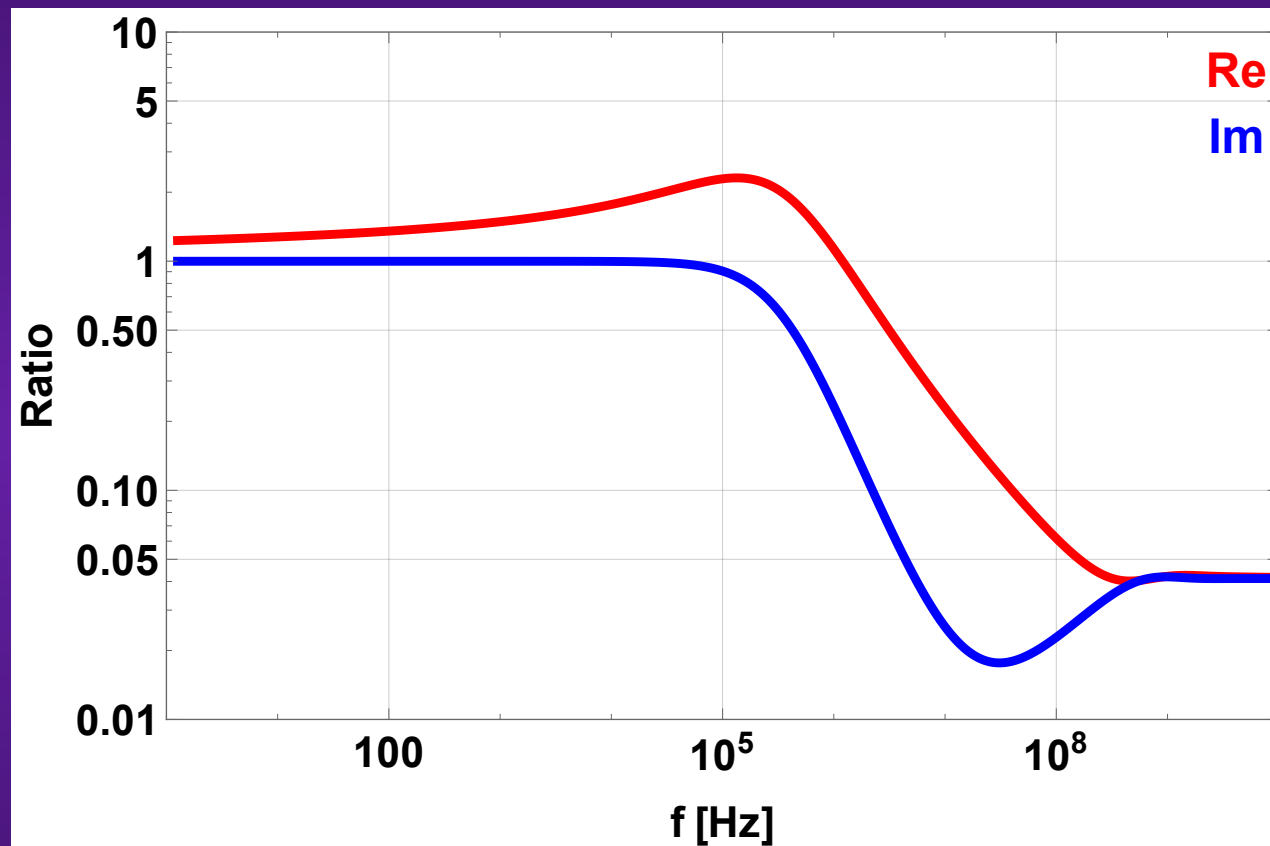
Graphite beam pipe with 2 mm radius and 0 μm copper coating (room temp.)



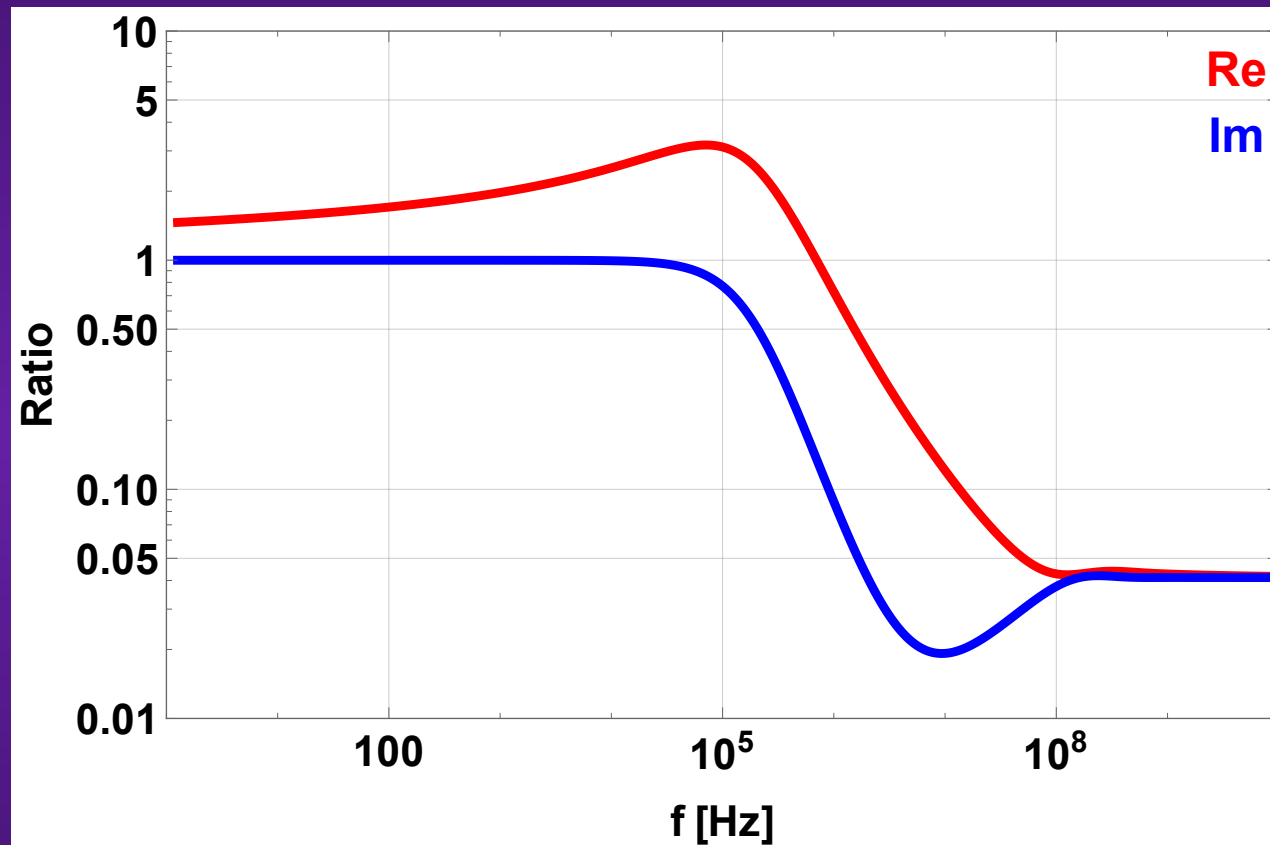
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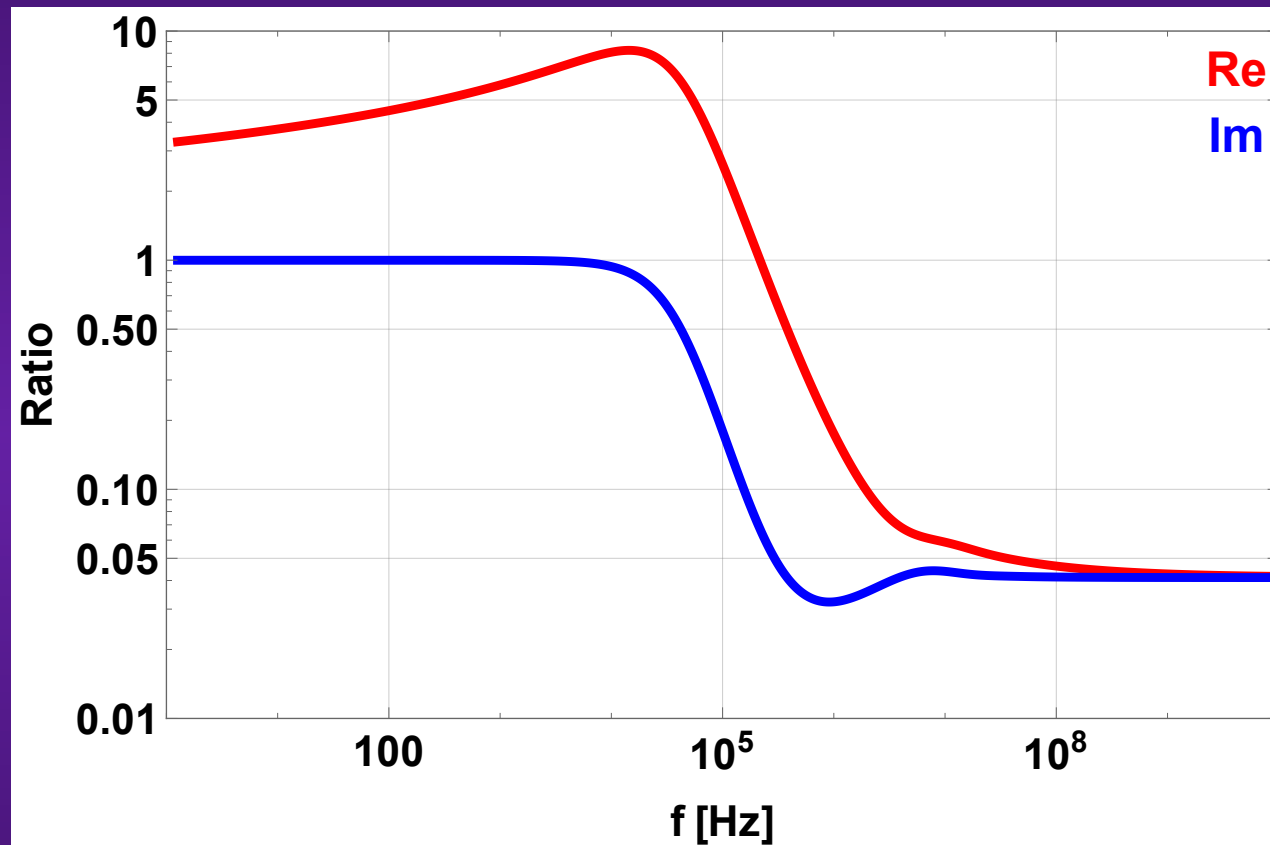
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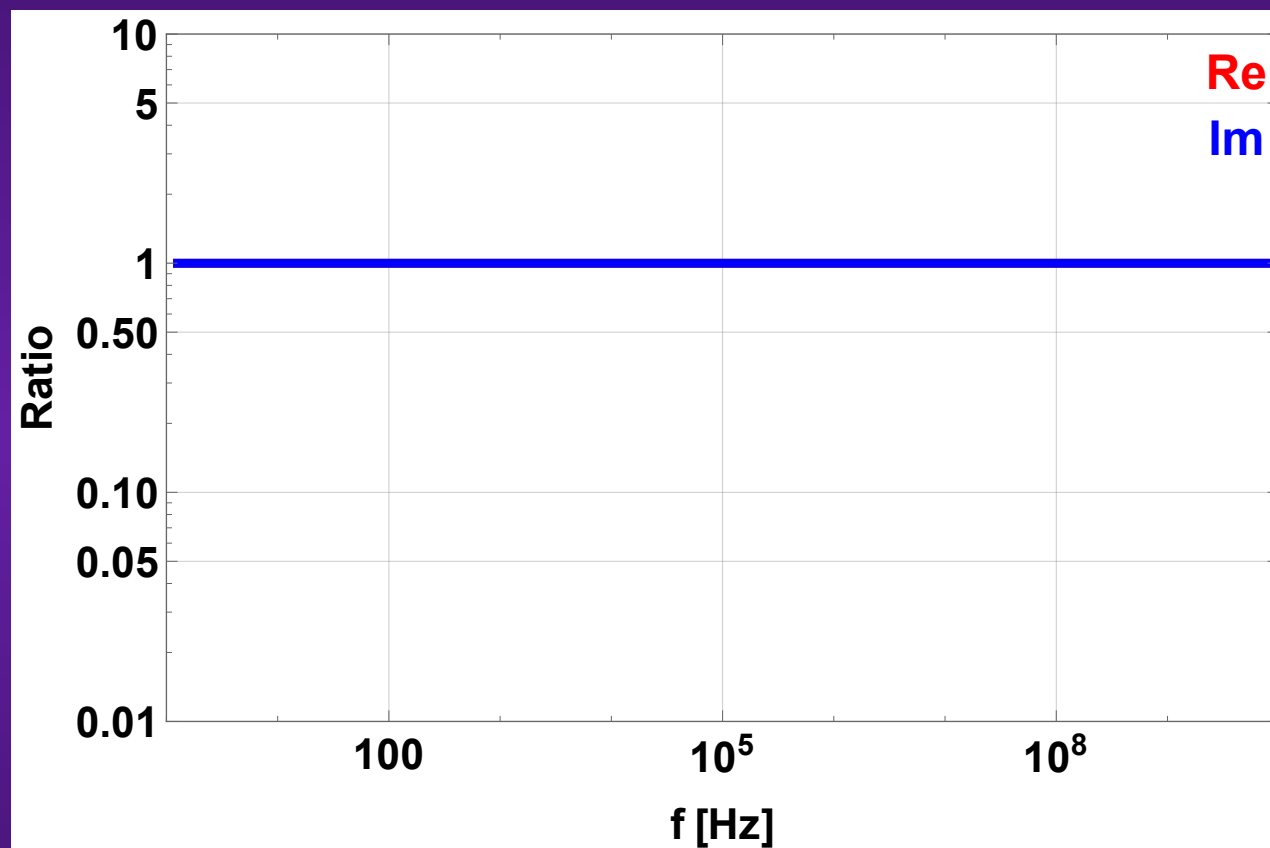
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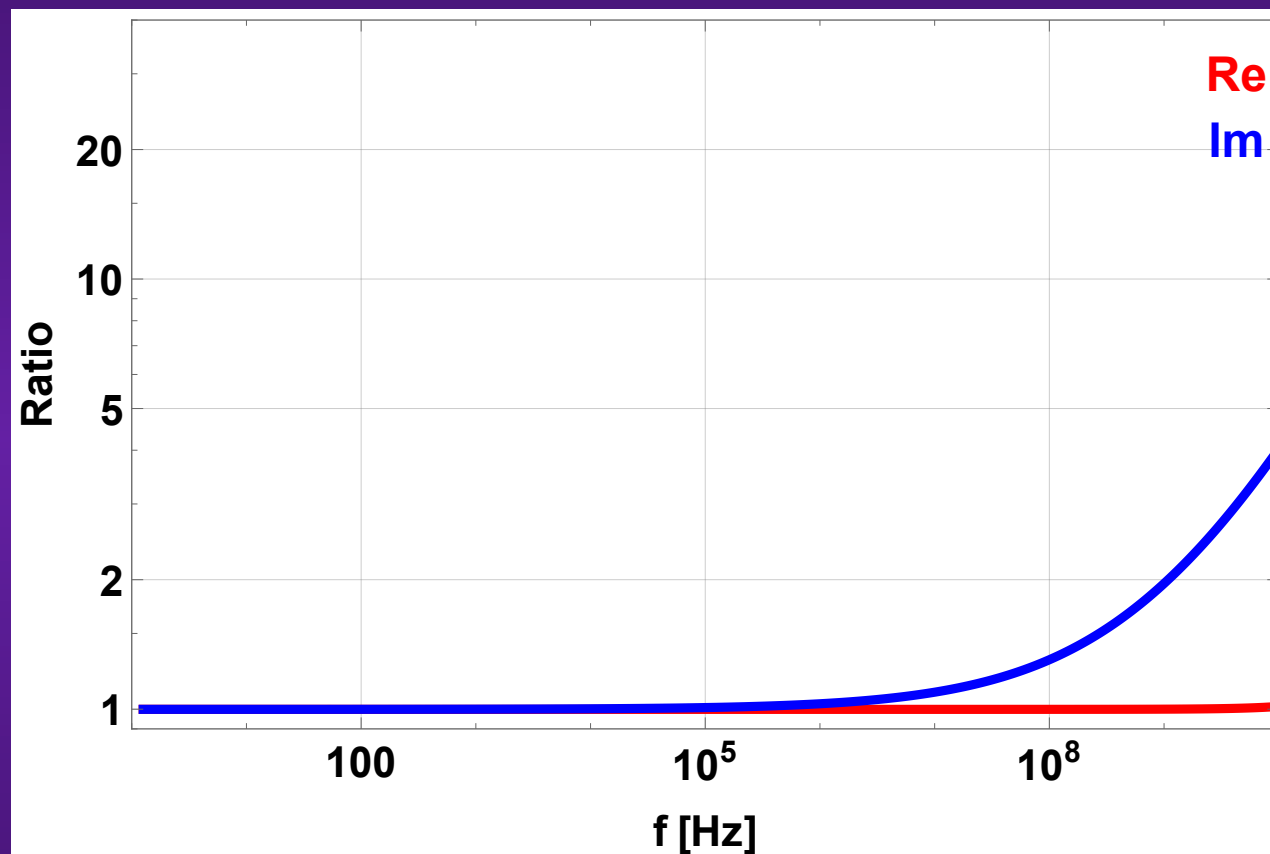
Graphite beam pipe with 2 mm radius and 50 μm copper coating (room temp.)



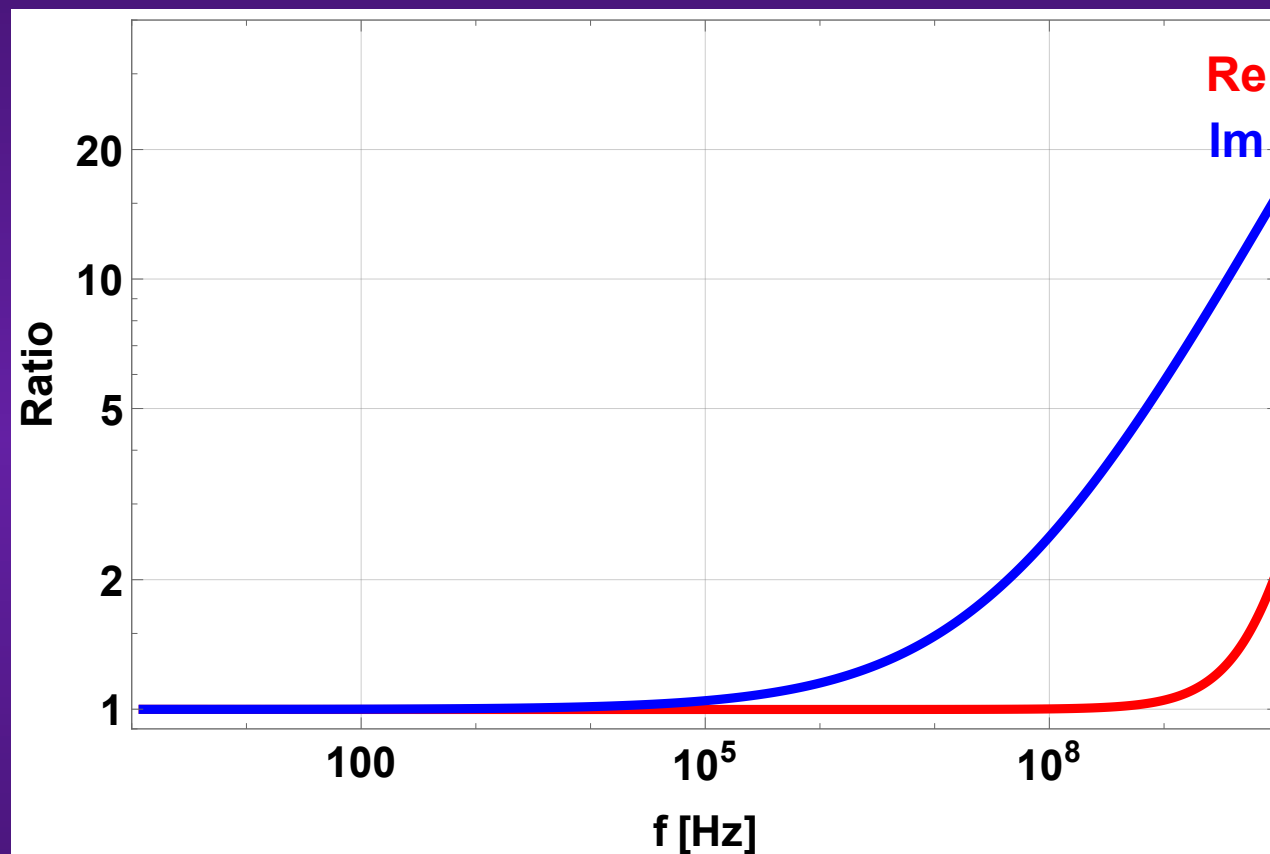
Copper (room temp.) beam pipe with 20 mm radius and 0 μm graphite coating



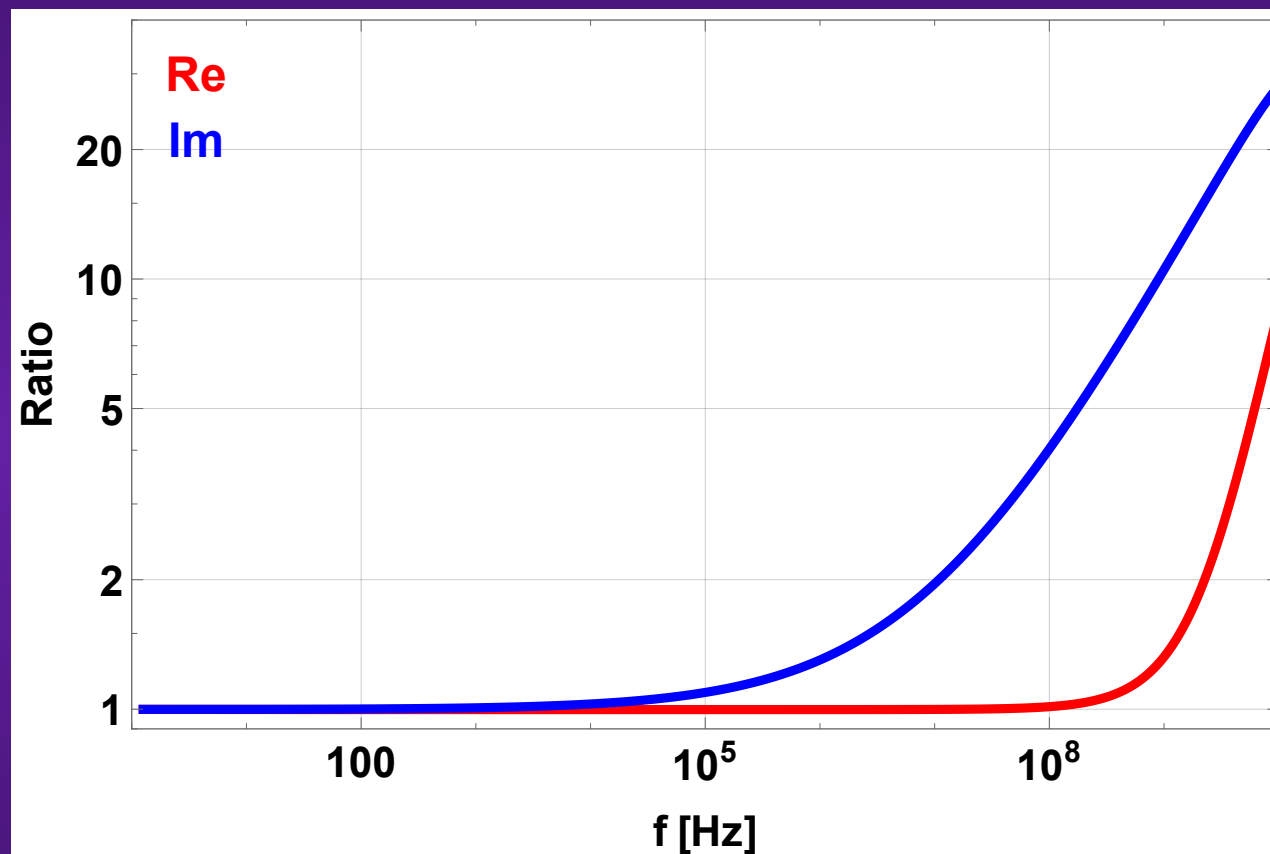
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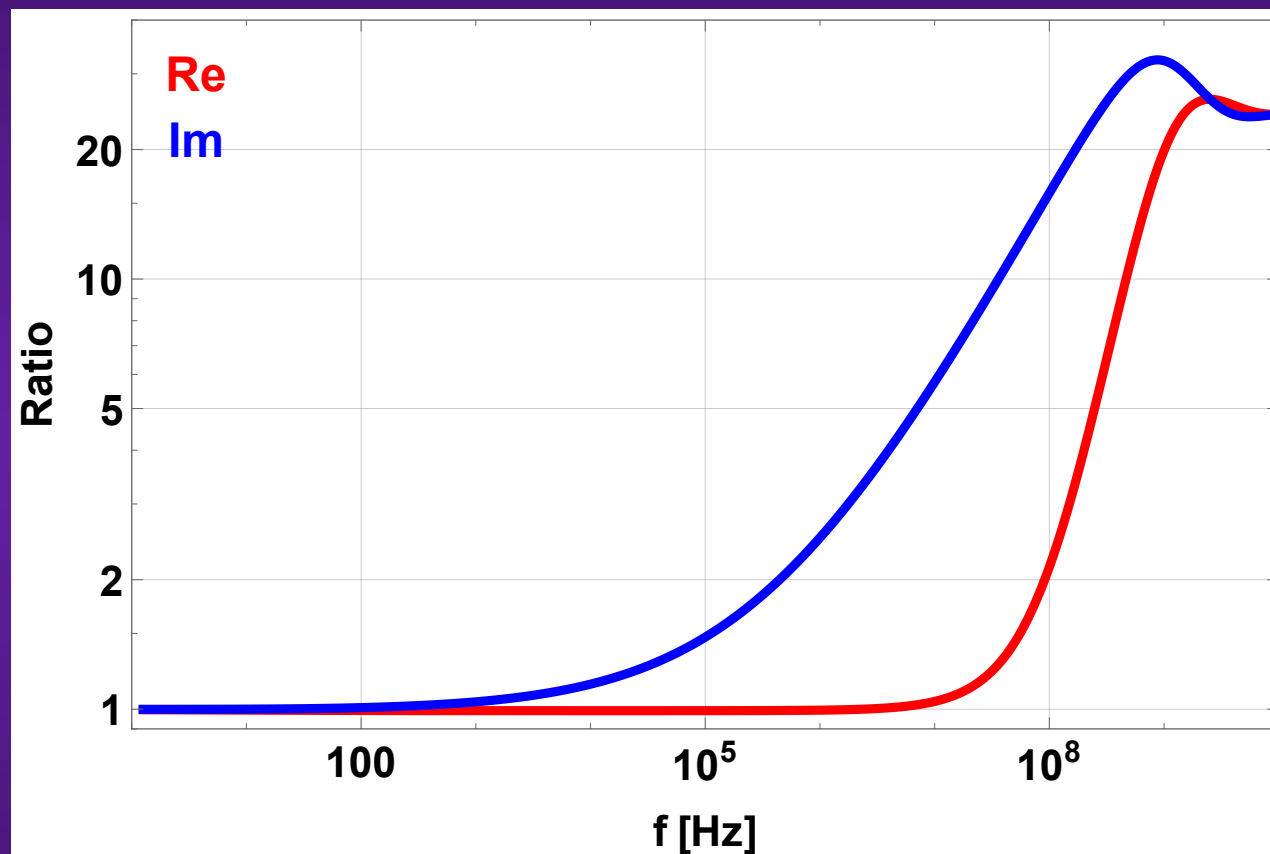
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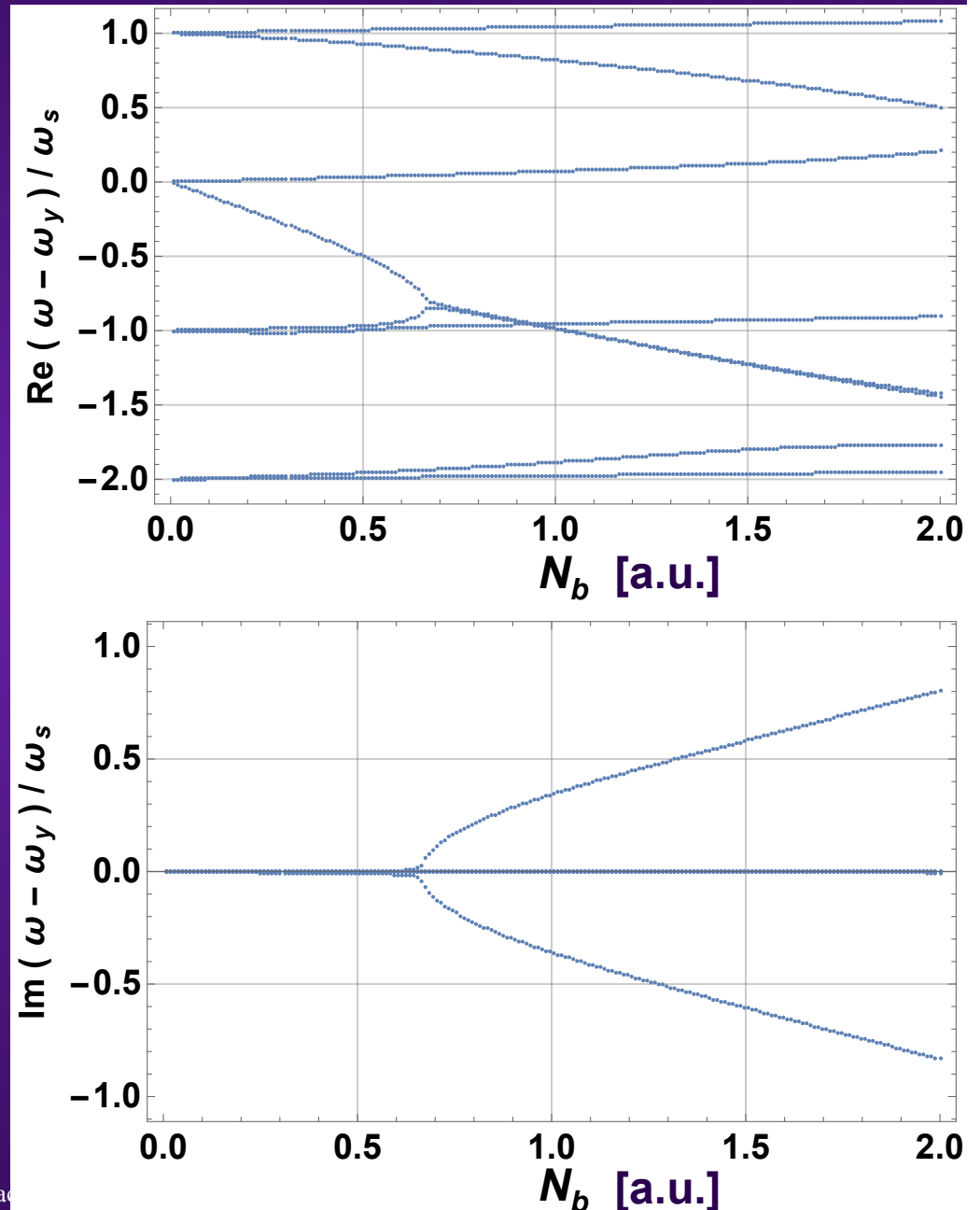
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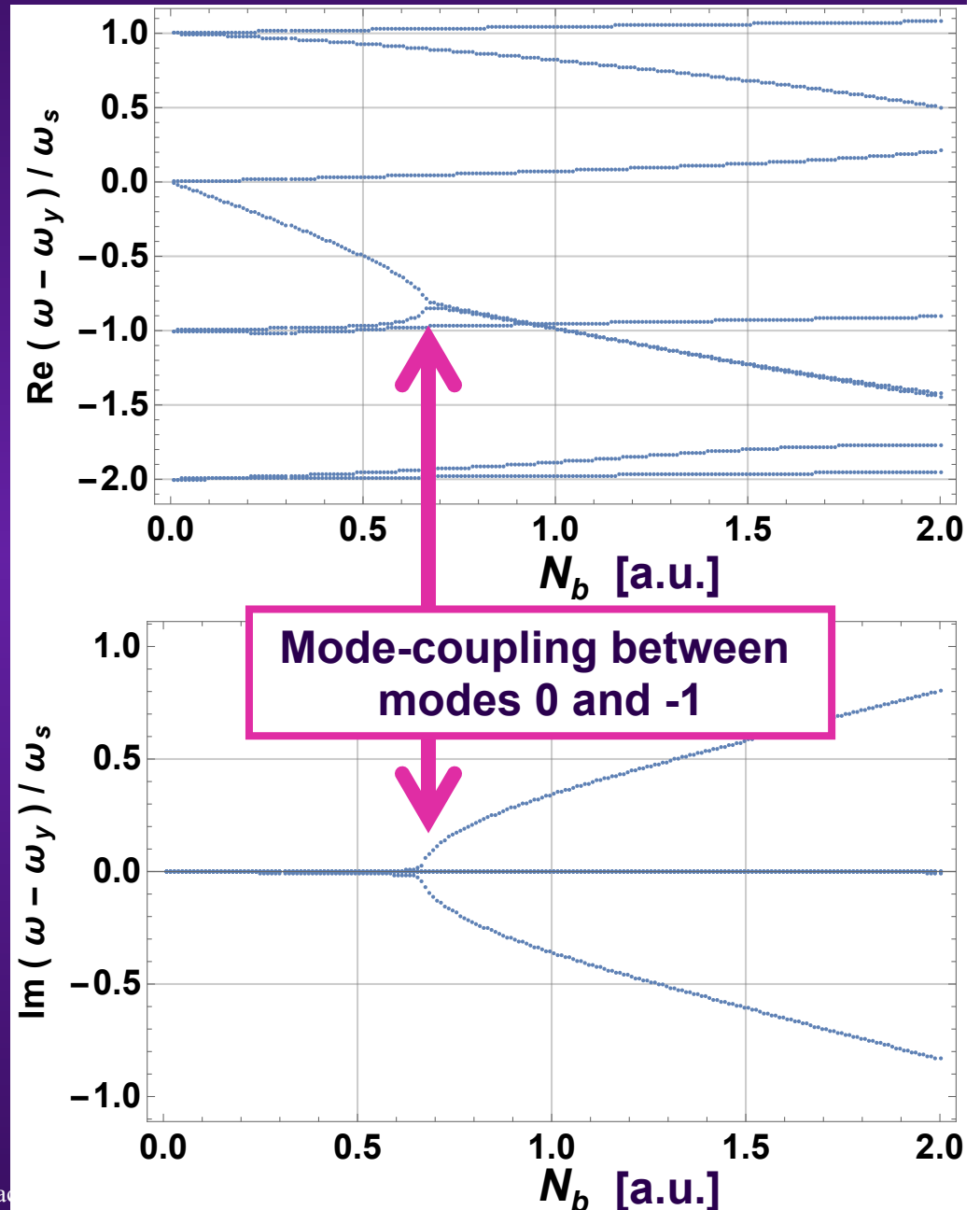
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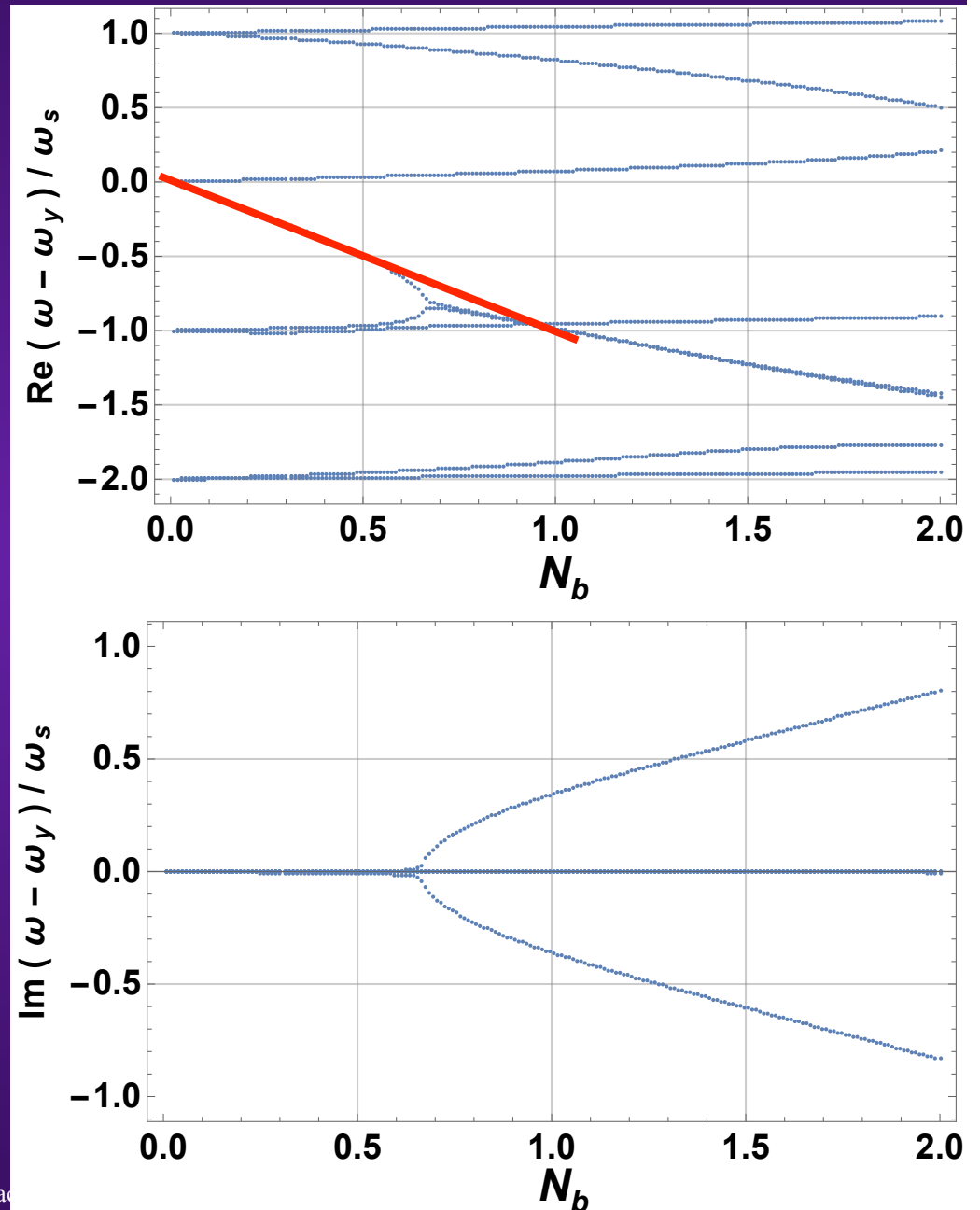


COPPER COATING: WHY AND WHICH THICKNESS?

- ◆ **3) TMCI** => (Mainly) due to imaginary part of the transverse impedance

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- Approximation to find the threshold => When tune shift of mode 0 is $\sim -Q_s$

From Sacherer formula



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Weighted by the bunch spectrum (mode 0), which also depends on bunch length...

$$\tau_b = 1 \text{ ns}$$

$$= 7\text{E}12$$

$$= 2\text{E} - 3$$

$$\text{Im} \left(Z_y^{\text{eff}} \right) < \text{Im} \left(Z_y^{\text{eff}} \right)_{\text{max}} = \frac{4 \pi \left(E_t / e \right) \tau_b Q_s}{N_b e \beta_y^{\text{av}}} \approx 134 \text{ M}\Omega/\text{m}$$

$$1.15\text{E}11 \text{ p/b}$$

$$= R / Q_y = 71.5 \text{ m}$$

EFFECT OF THE (RESISTIVE) TRANSVERSE DAMPER

- ◆ A (bunch by bunch) resistive transverse damper is usually used to damp the TCBI => IF instability rise-time is longer than ~ 10 turns

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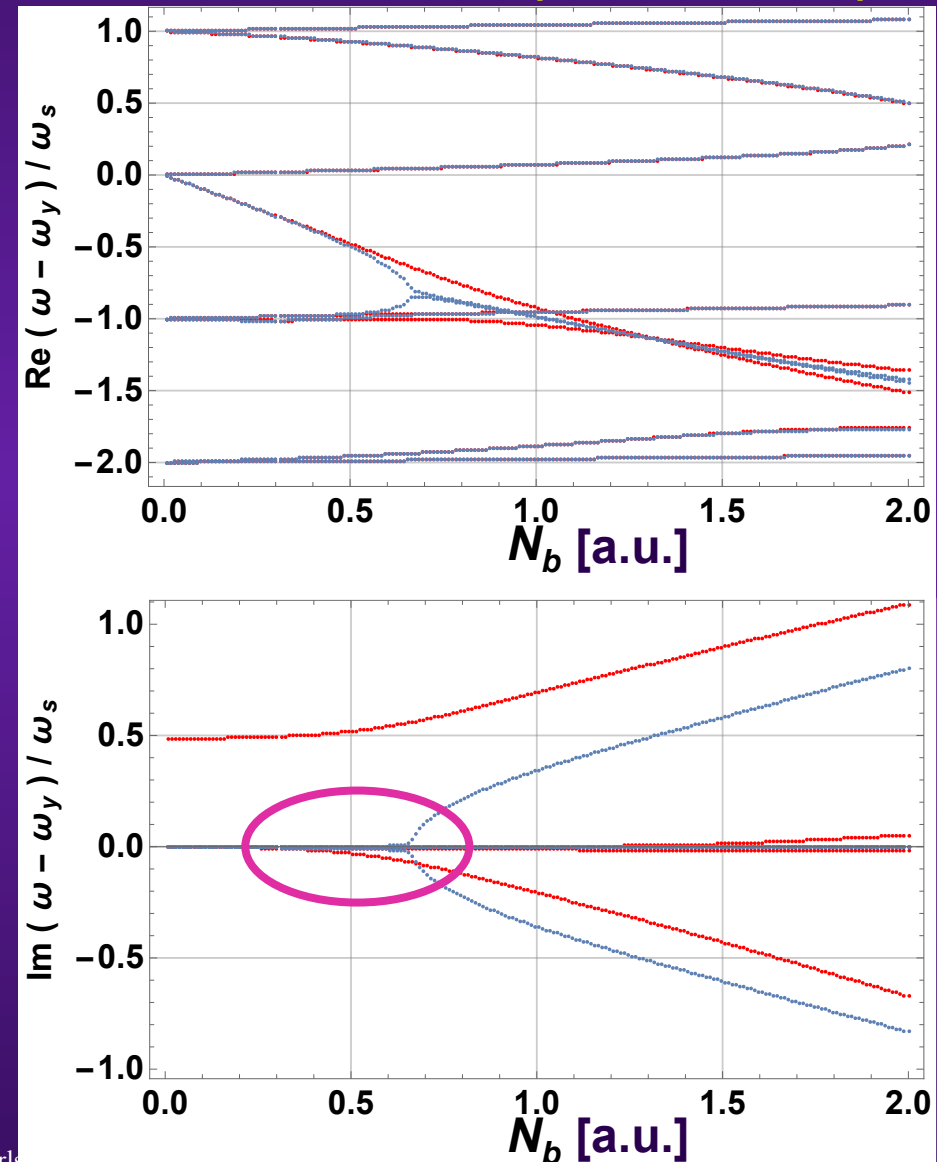
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- ◆ Recent studies revealed that for $Q' = 0$ the resistive transverse damper is destabilising (for the single bunch) and shed a light on the physical mechanism

EFFECT OF THE (RESISTIVE) TRANSVERSE DAMPER

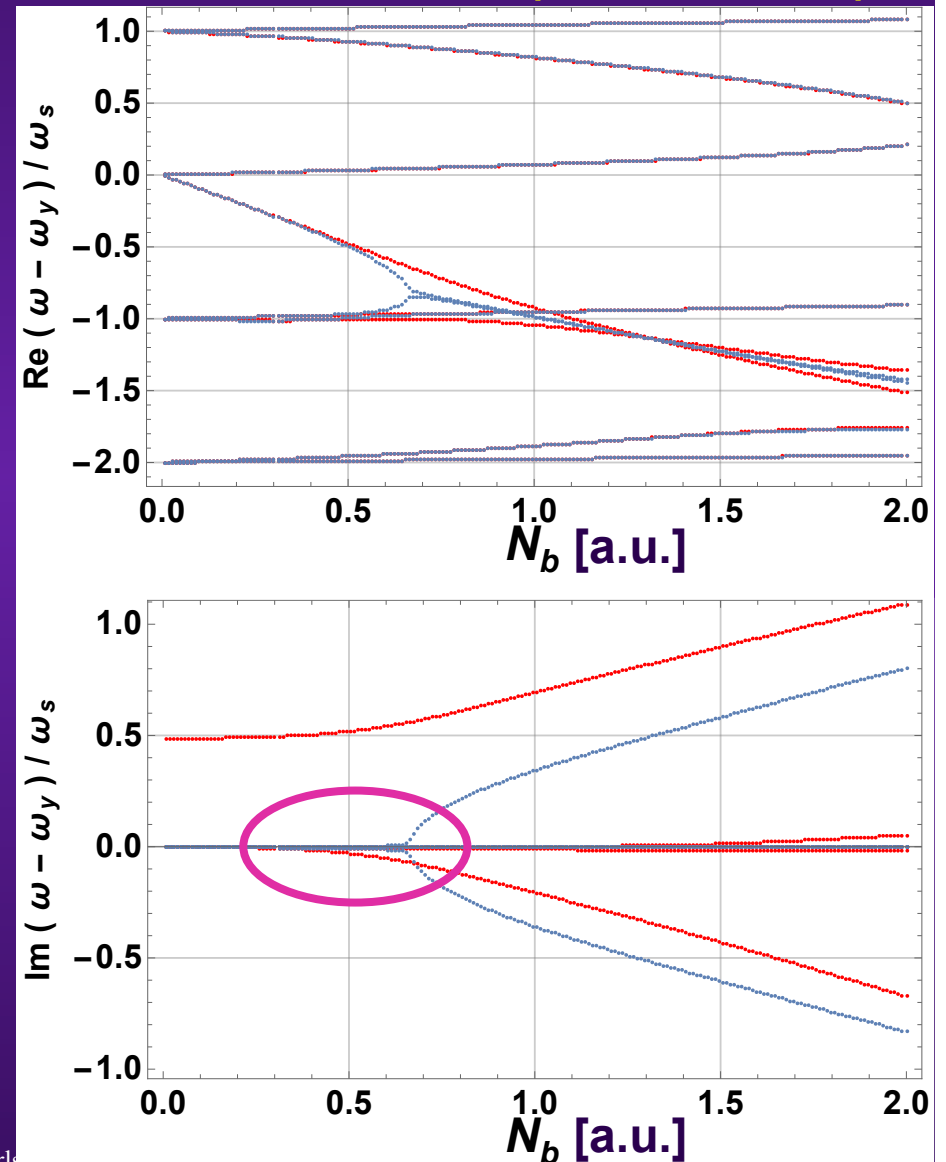
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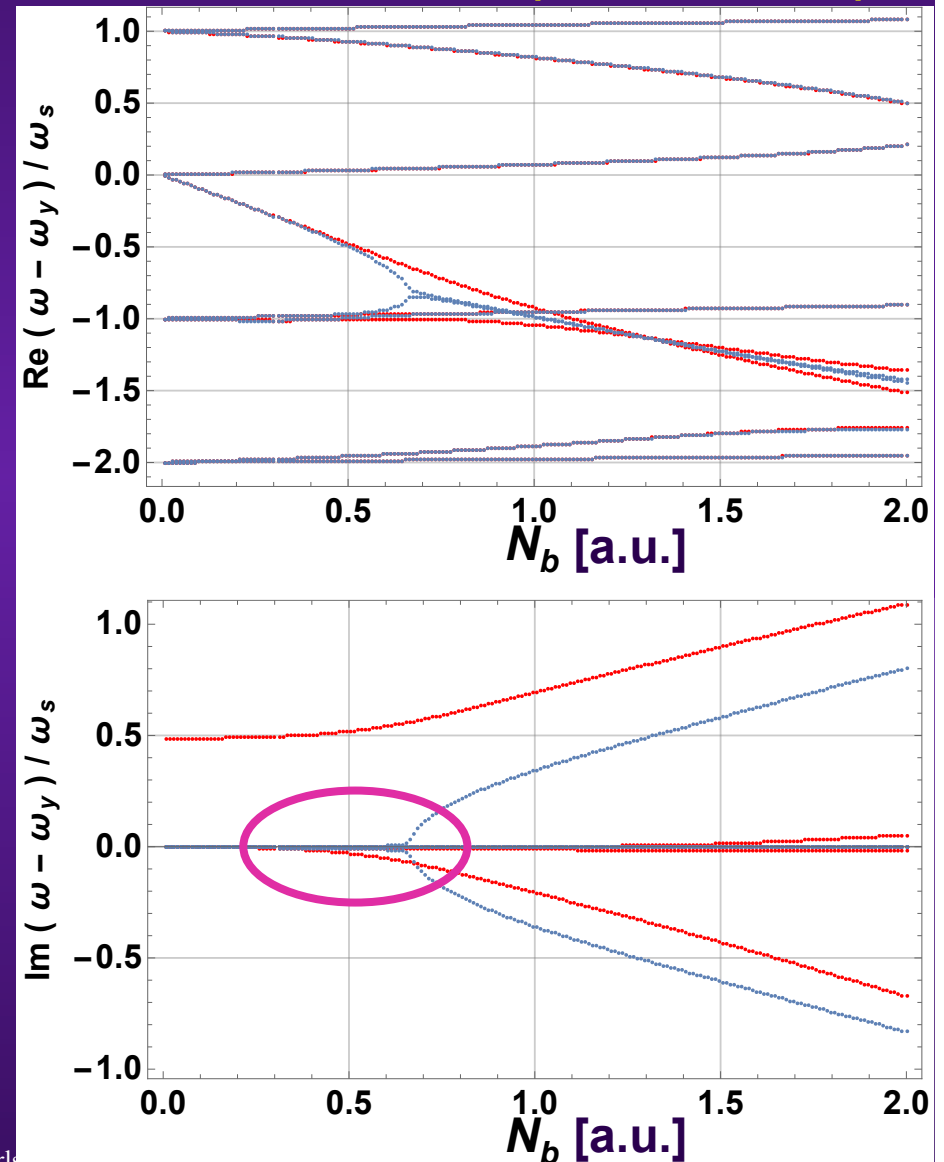
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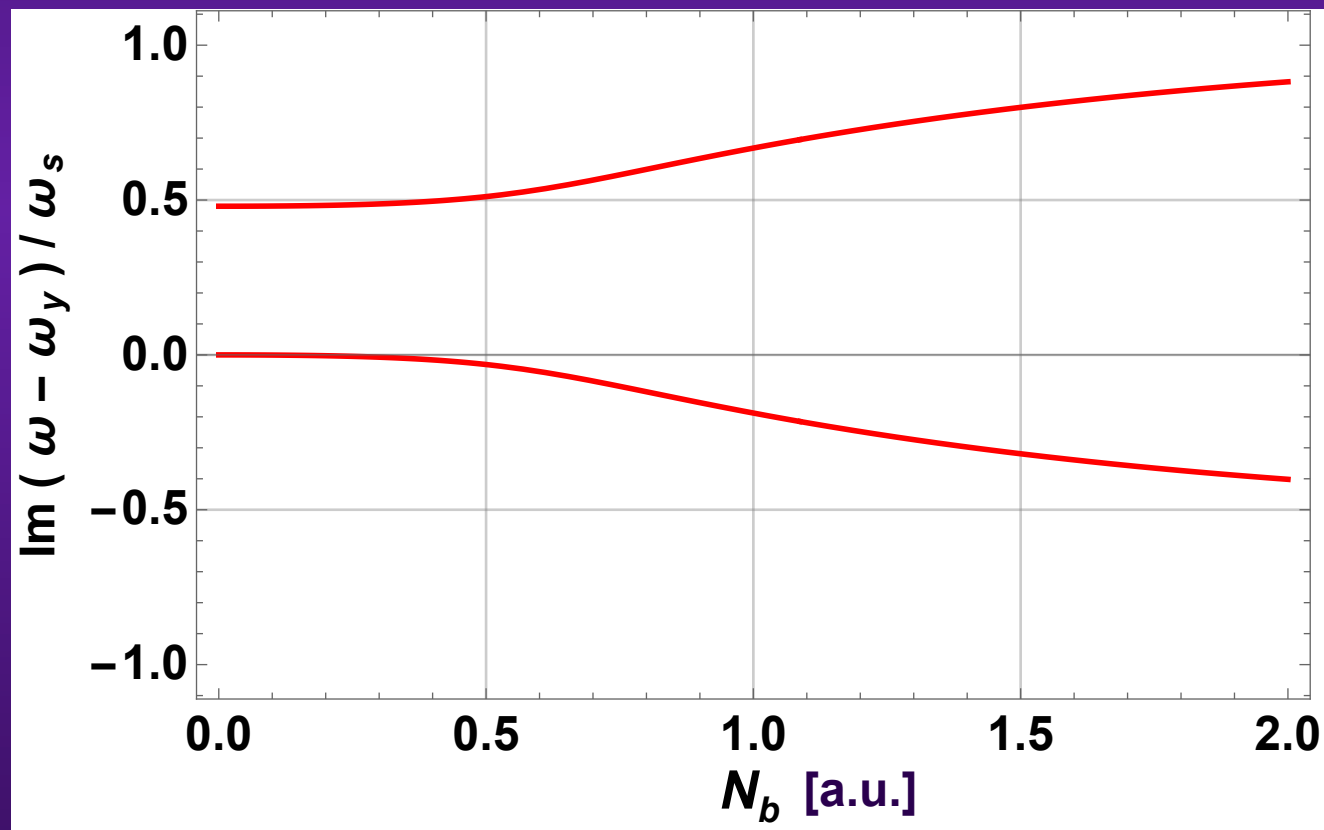
- This is the interaction between modes - 1 and 0 through the damper which creates the instability
- The “coupling” between the 2 modes pushes apart the instability growth rates and as the lowest one is 0, it becomes negative



EFFECT OF THE (RESISTIVE) TRANSVERSE DAMPER

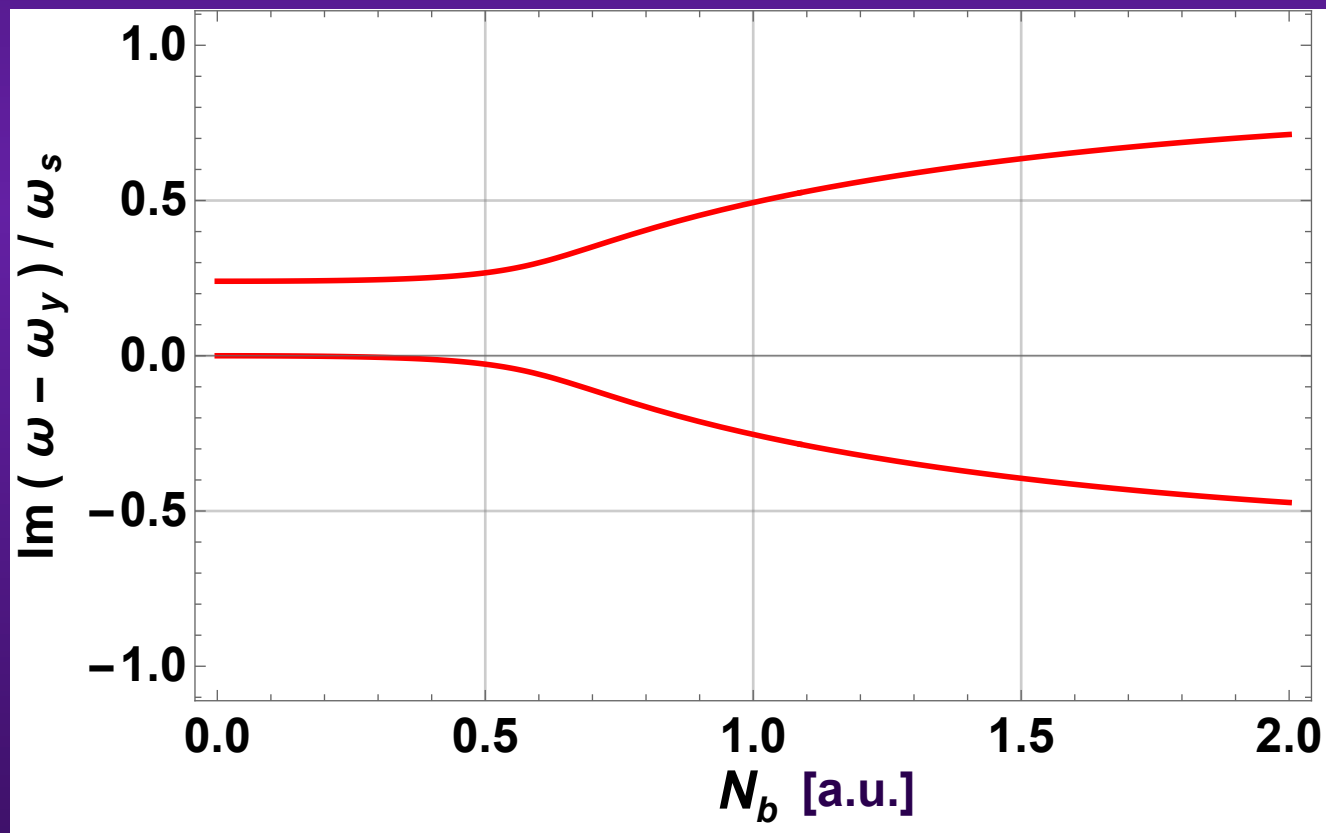
- Considering only the 2 modes 0 and - 1 yields

With the transverse damper gain used before



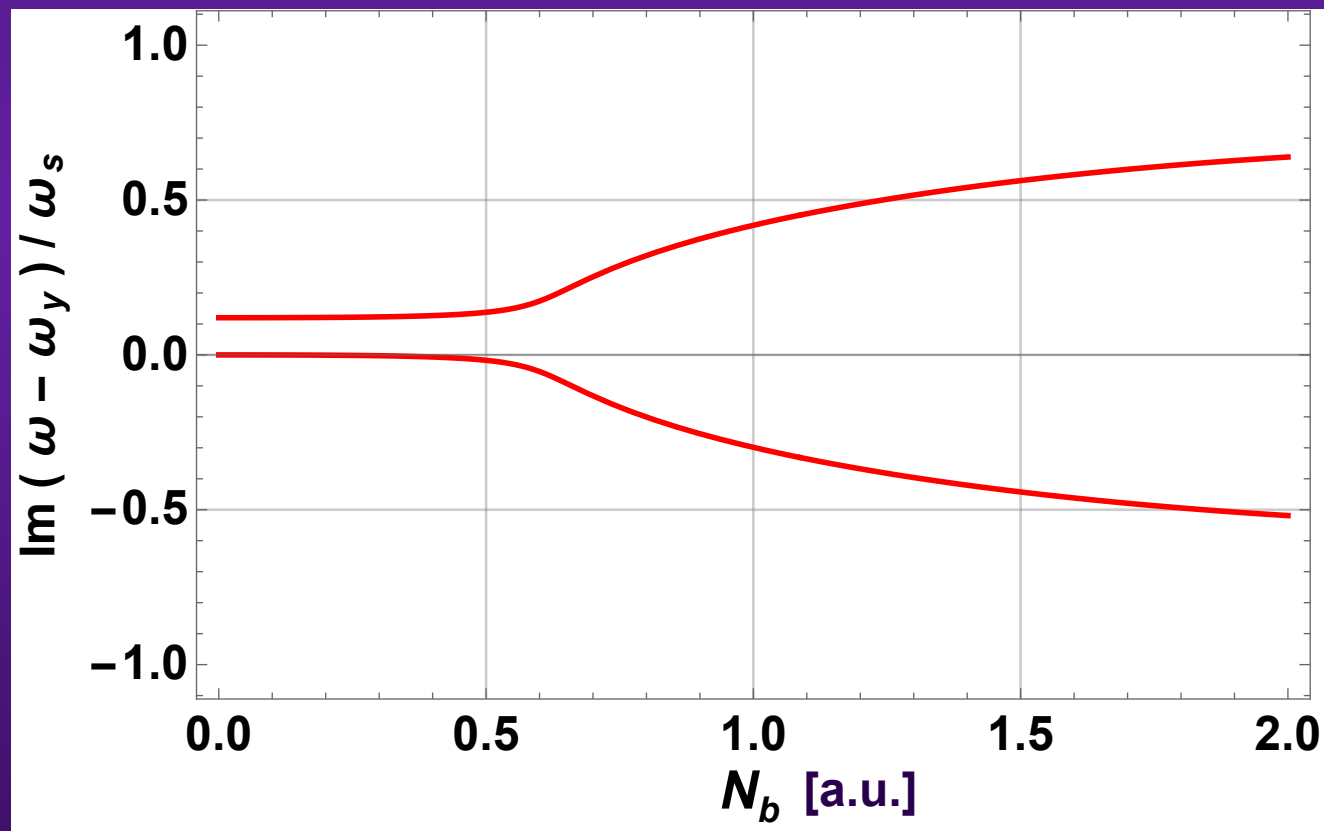
EFFECT OF THE (RESISTIVE) TRANSVERSE DAMPER

With the transverse damper gain used before / 2



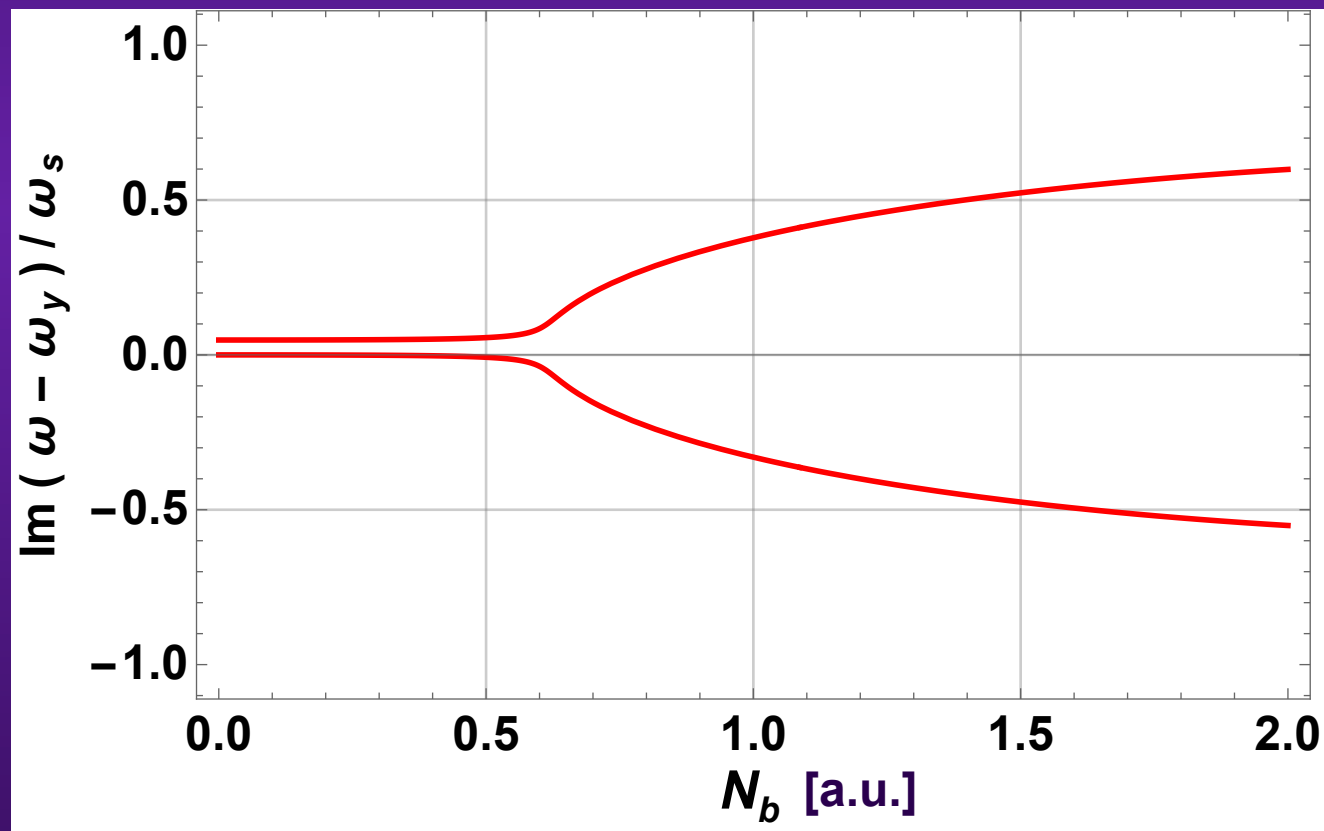
EFFECT OF THE (RESISTIVE) TRANSVERSE DAMPER

With the transverse damper gain used before / 4



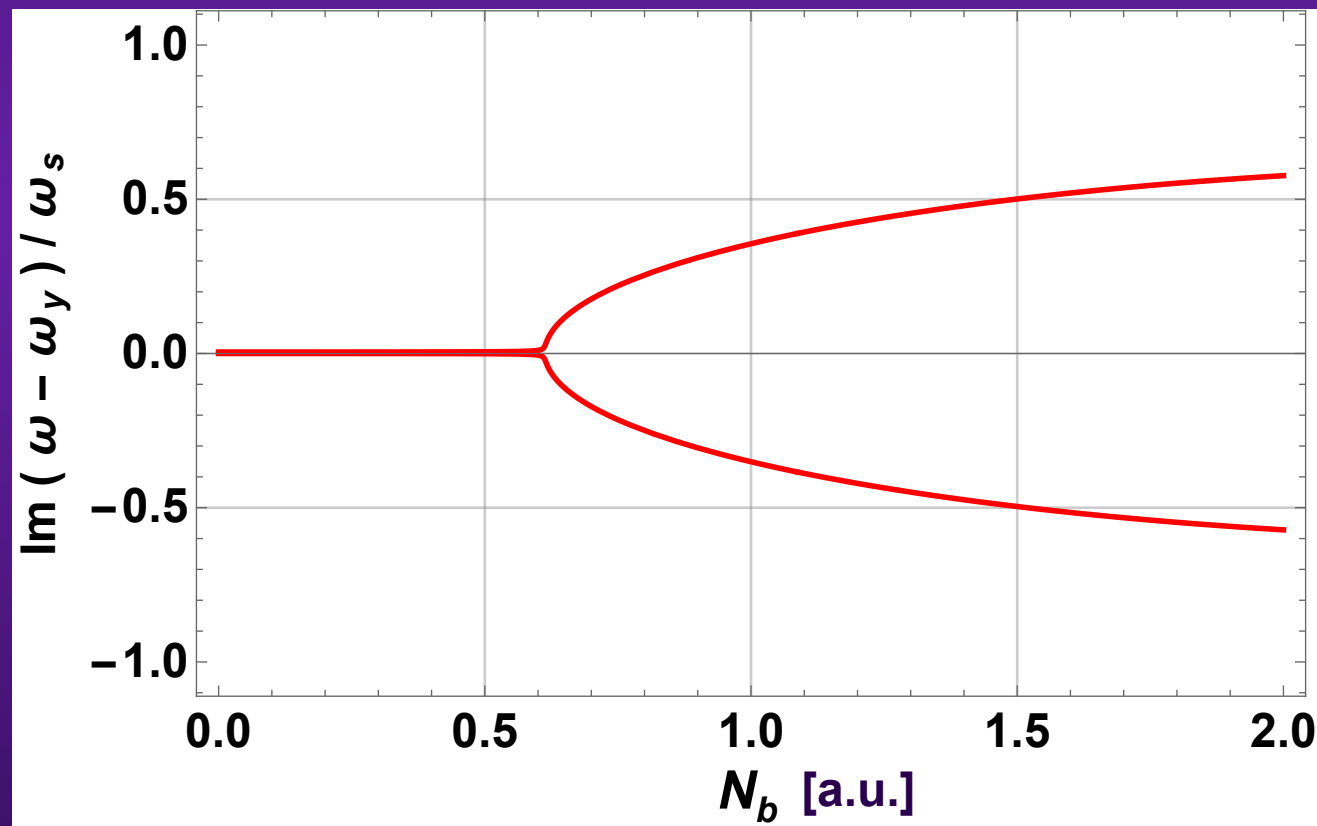
EFFECT OF THE (RESISTIVE) TRANSVERSE DAMPER

With the transverse damper gain used before / 10



EFFECT OF THE (RESISTIVE) TRANSVERSE DAMPER

With the transverse damper gain used before / 100



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- ◆ The consequences on the Landau damping are currently under investigation (as the assumption of independent modes cannot be made anymore)
- ◆ However, with a sufficiently strong (and low noise) transverse damper, the TCBI (low frequency) should not be a problem anymore
=> Particular attention should be paid to the high frequency (single-bunch) regime

COATING (e.g. a-C) OR SURFACE TREATMENT (e.g. LESS) TO FIGHT AGAINST E-CLOUD

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$$\left| \frac{Z_l(n)}{n} \right|_{eff} \leq \left| \frac{Z_l(n)}{n} \right|_{eff}^{\max} \propto \frac{h^3 \hat{V}_{RF} B_0^5}{N_b e f_{rev}}$$

35640

16 MV

$= \tau_b f_{rev} = 1 \text{ ns} \times 11245.5 \text{ Hz}$

$n = f / f_{rev}$

Weighted by the bunch spectrum

COATING (e.g. a-C) OR SURFACE TREATMENT (e.g. LESS) TO FIGHT AGAINST E-CLOUD

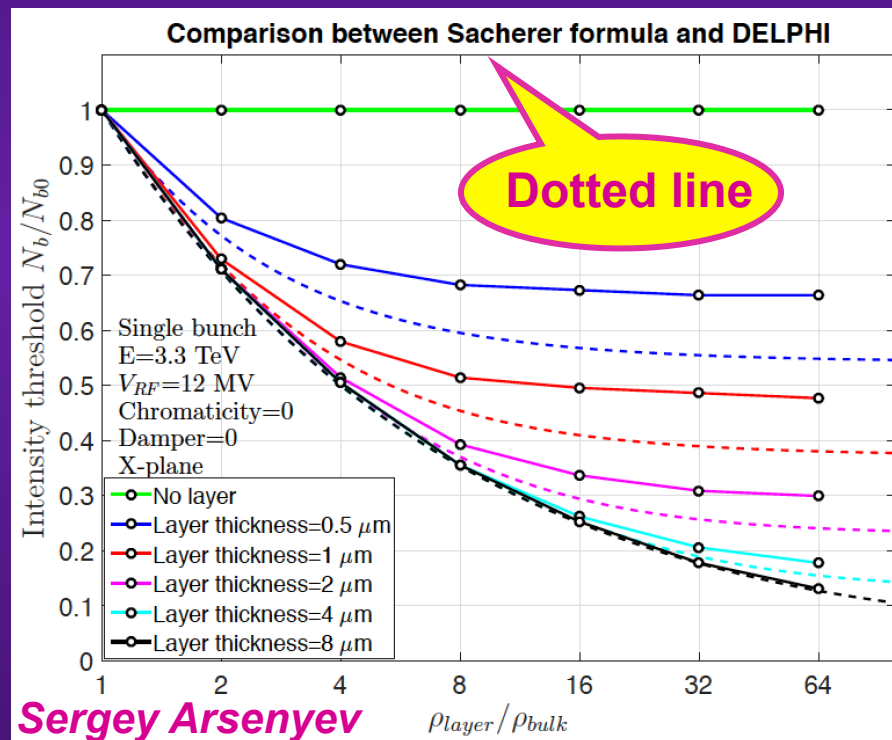
- Increase of imaginary part of transverse impedance at high frequency => More critical for TMCI

COATING (e.g. a-C) OR SURFACE TREATMENT (e.g. LESS) TO FIGHT AGAINST E-CLOUD

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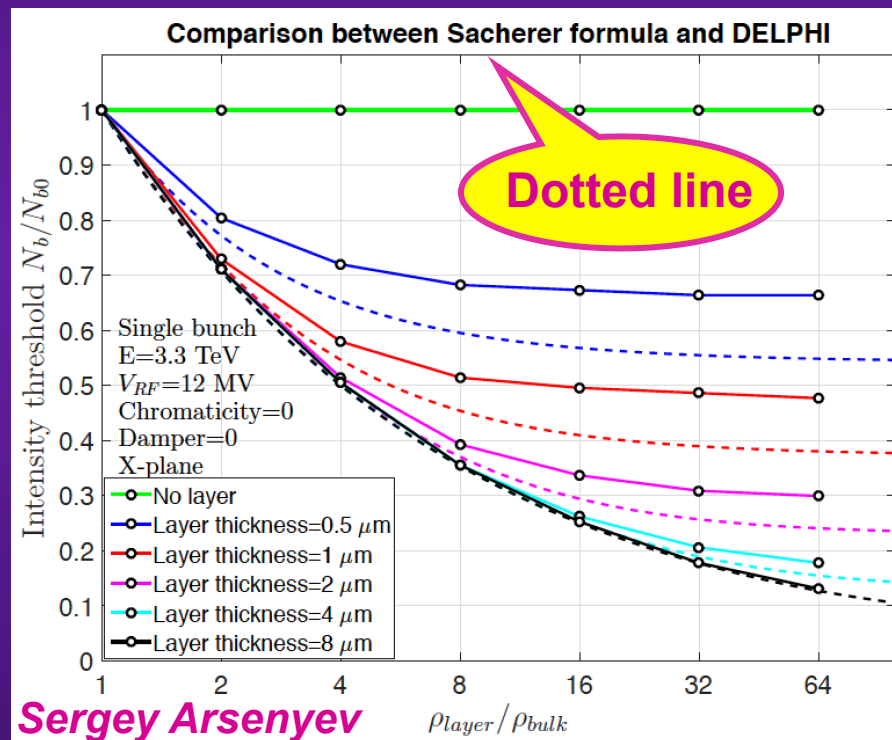
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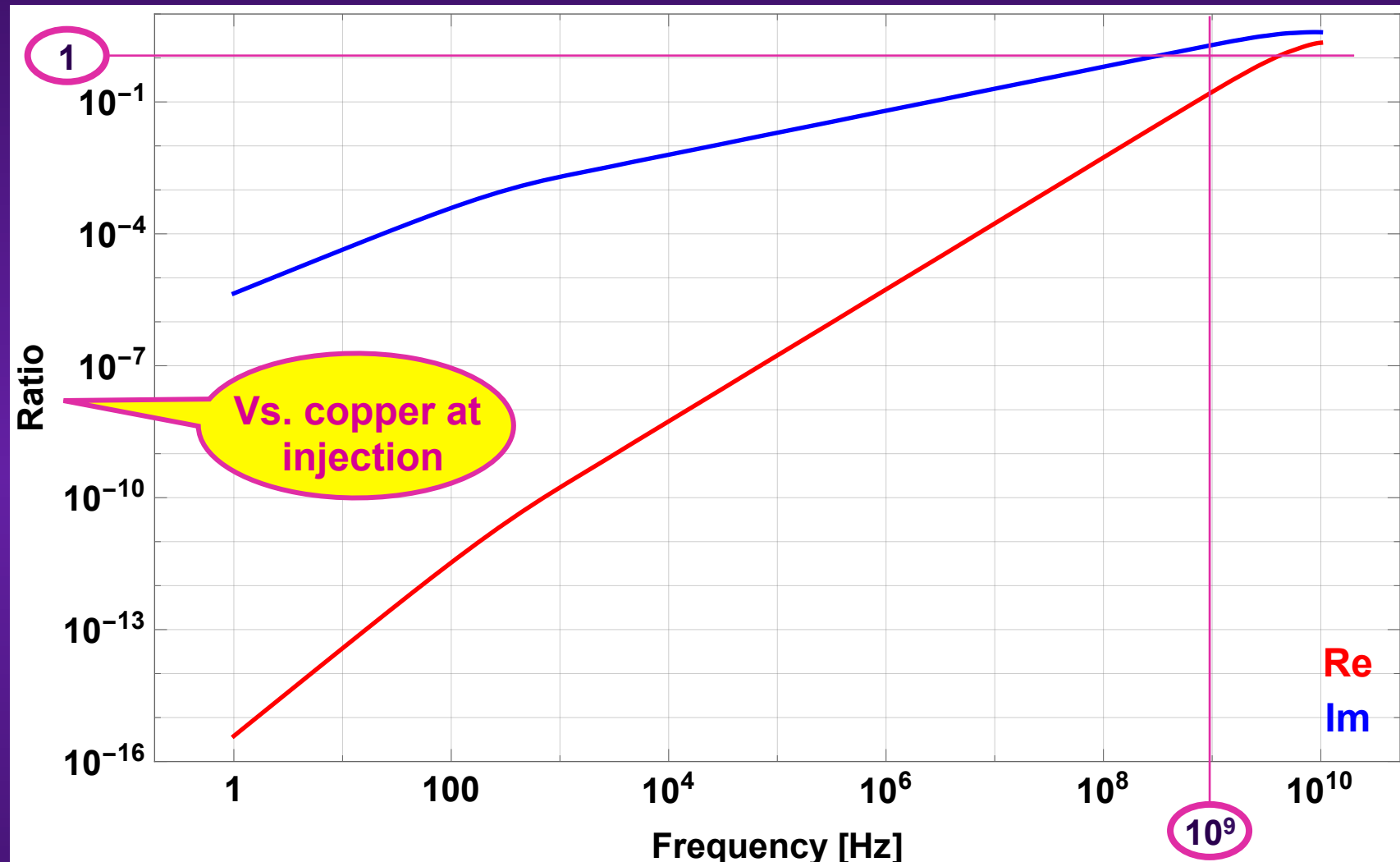
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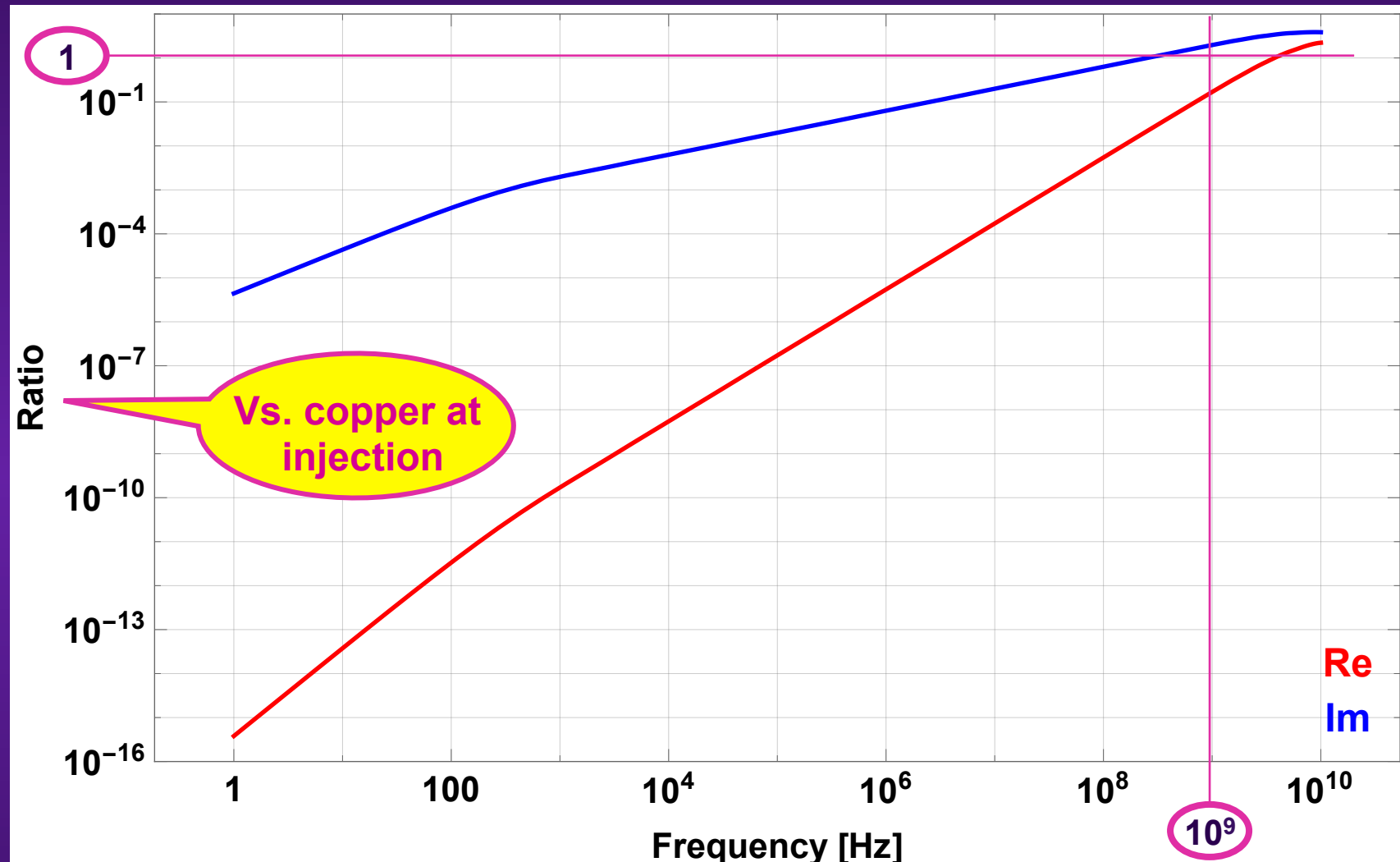
=> Measurements at low temperature and high magnetic field are required (and planned)

HTS COATING for FCC-hh: YBCO (from Sergio Calatroni)

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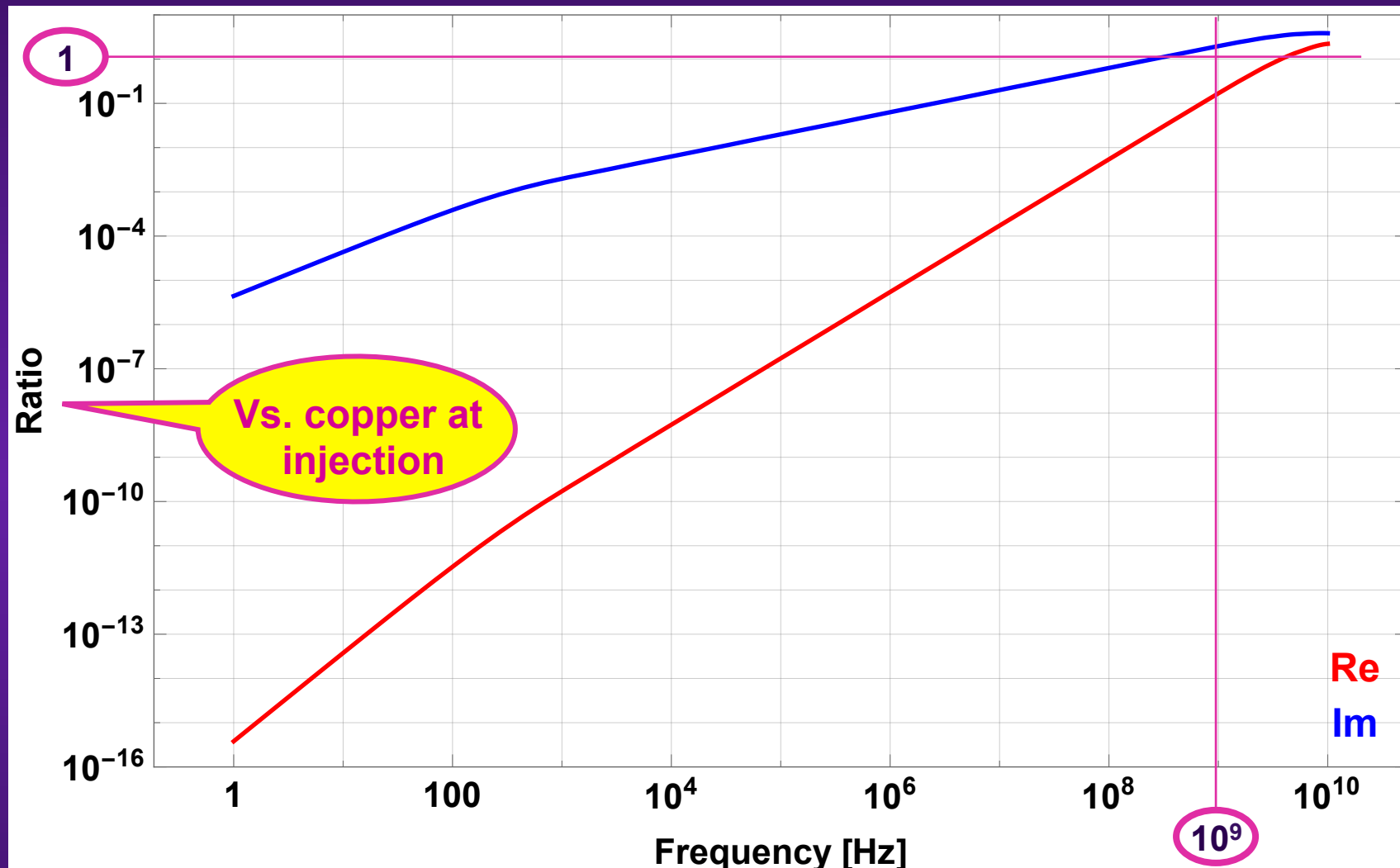


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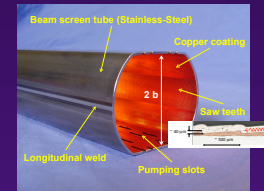
- Much better at low and intermediate frequencies

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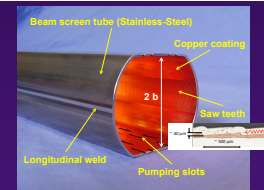


- Much better at low and intermediate frequencies
- Pay attention to higher frequencies as it could impact TMCI

Longitudinal weld

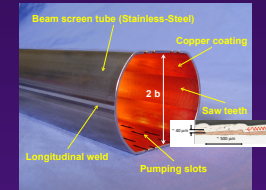


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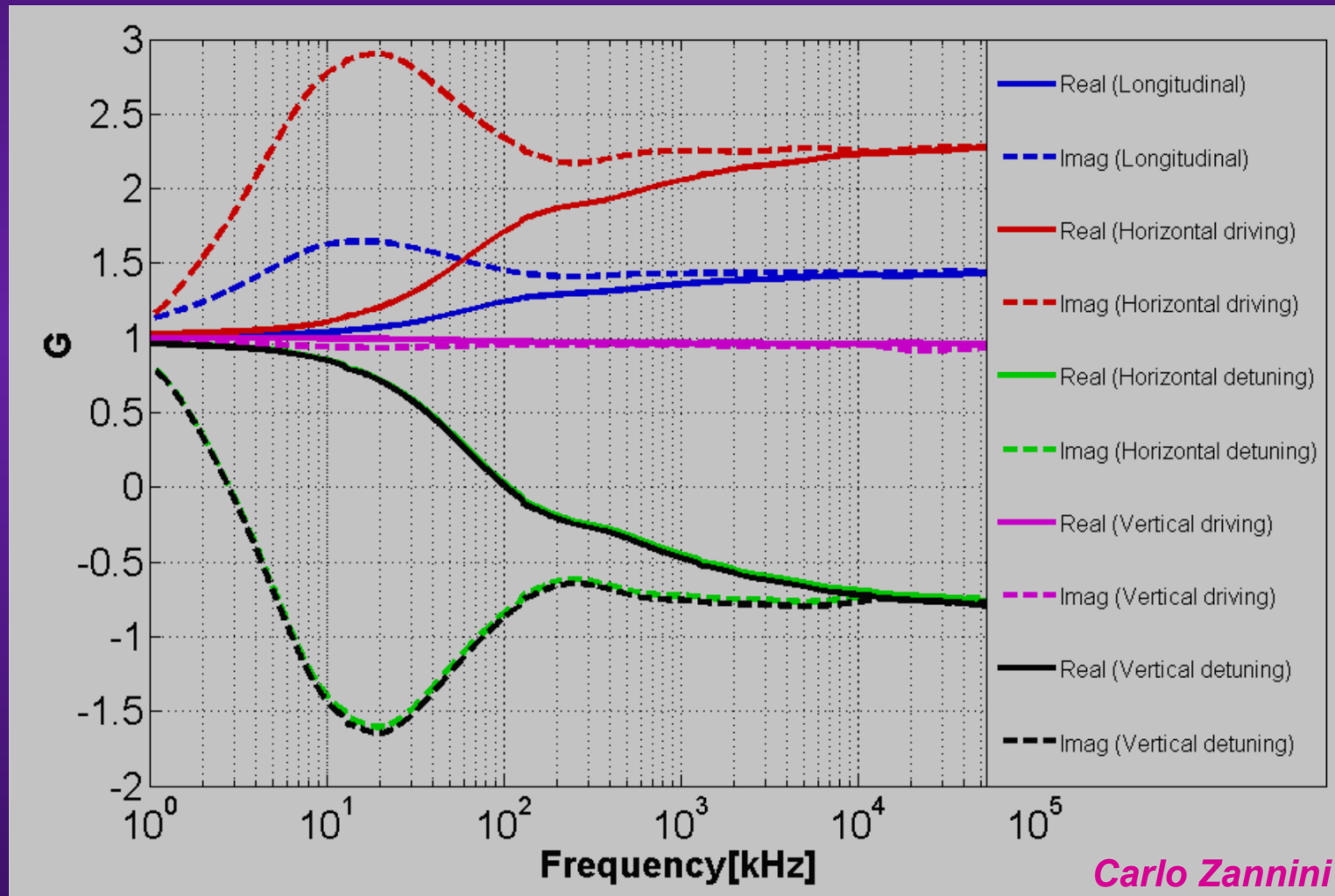


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Carlo Zannini

Longitudinal weld

- ◆ **Effect on the power loss**

Longitudinal weld

◆ Effect on the power loss

$$\rho_{Cu}^{20K, 7TeV} = 7.7 \times 10^{-10} \Omega m$$

$$\rho_{SS}^{20K} = 6 \times 10^{-7} \Omega m$$

$$\frac{\Delta_l^{Weld}}{2 \pi b} = \frac{2}{2 \pi \times 18.4} = \frac{1}{\pi \times 18.4} \approx \frac{1}{60}$$

=>

$$\frac{P_{loss/m}^{Weld}}{P_{loss/m}^{G, RW, 1layer}} \approx \sqrt{\frac{\rho_{SS}^{20K}}{\rho_{Cu}^{20K}}} \times \frac{\Delta_l^{Weld}}{2 \pi b} \approx 48\%$$

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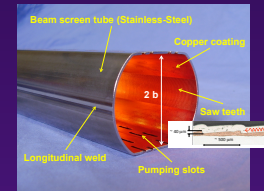
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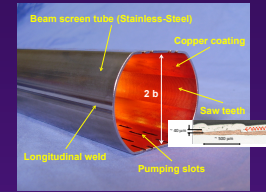
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=> The estimated increase of the power loss by ~ 50% is in agreement with the previous simulations (high frequency effect)

Pumping slots



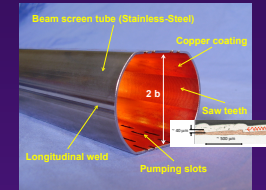
Pumping slots



◆ Fraction of surface covered by the holes

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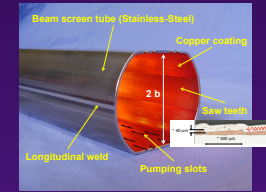
◆ This will mainly increase the imaginary part of the longitudinal and transverse impedances (\Rightarrow TMCI)

$$\frac{Z_l(n)}{n} \propto j \frac{\eta L}{b}$$

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Total length covered by the holes

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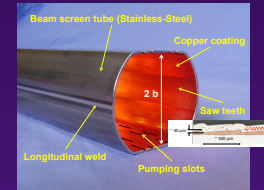
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◆ In addition, some trapped modes could be created \Rightarrow Randomization of the slots lengths (between 6,7,8,9,10 mm with average at 8 mm) + randomization of the slot spacing

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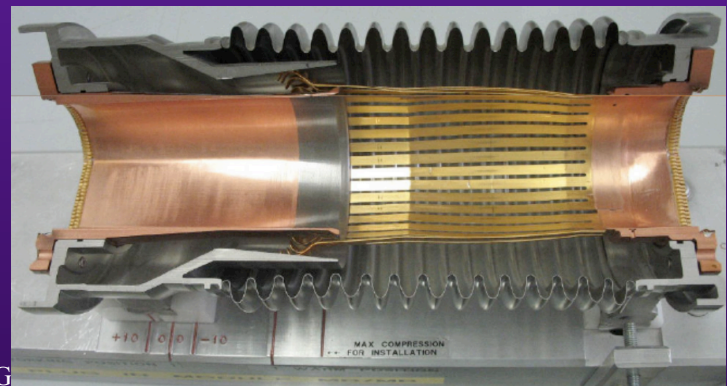
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Example of RF fingers:
PIMs = Plug-In Modules



Many thanks for your attention!

APPENDIX A: LHC BEAM SCREENS

Arc beam screens:

Inner dimension between flats:	36.8 mm
Inner dimension between radii:	46.4 mm
SS thickness:	1.0 mm
Cu thickness:	0.075 mm

LSS beam screens:

Inner dimension between flats:	varying from 37.6 until 61.0 mm
Inner dimension between radii:	varying from 47.2 until 70.7 mm
SS thickness:	0.6 mm
Cu thickness:	0.075 mm

Courtesy of N. Kos

Resistance SS at room temp: $7\text{E-}7$ ohm.m

RRR SS: 1.2

Low temp resistance SS: $7\text{E-}7/1.2 = 6\text{E-}7$ ohm.m

Resistance copper at room temp: $2\text{E-}8$ ohm.m

RRR Cu (co-laminated surface): 100

Low temp Cu resistance: $2\text{E-}8/100 = 2\text{E-}10$ ohm.m

Courtesy of N. Kos

APPENDIX B: RRR (Residual Resistivity Ratio)

- ◆ Reduction of the resistivity with temperature \Rightarrow The resistivity decreases with temperature towards a minimum (determined by purity) and the RRR is defined as the ratio of the DC resistivity at room temperature to its cold-DC lower limit

*“Handbook of Accelerator Physics and Engineering”,
2nd Printing, Edited by A.W. Chao and M. Tigner, p. 368*

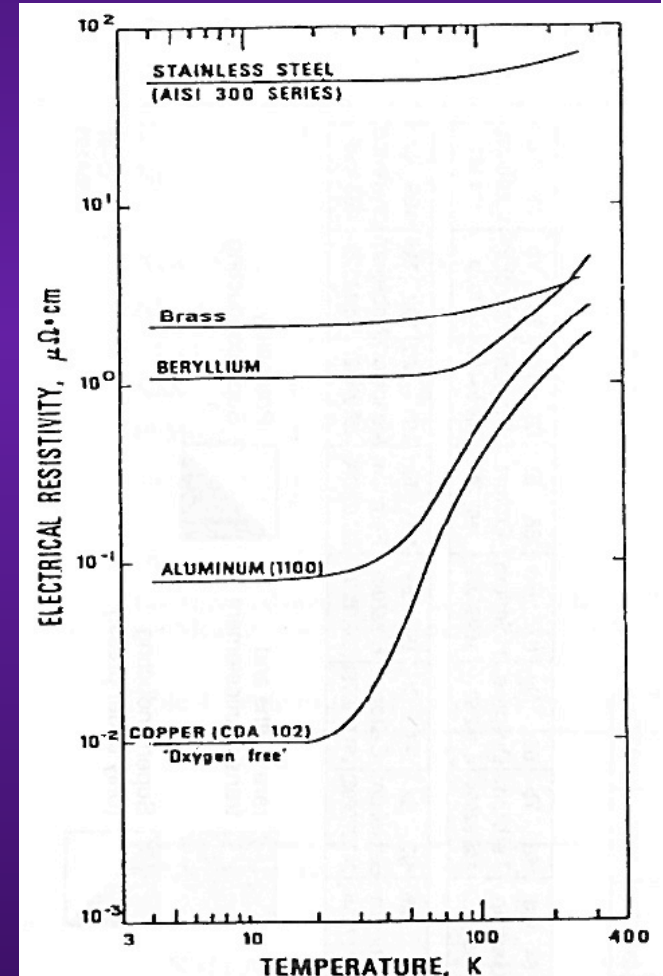
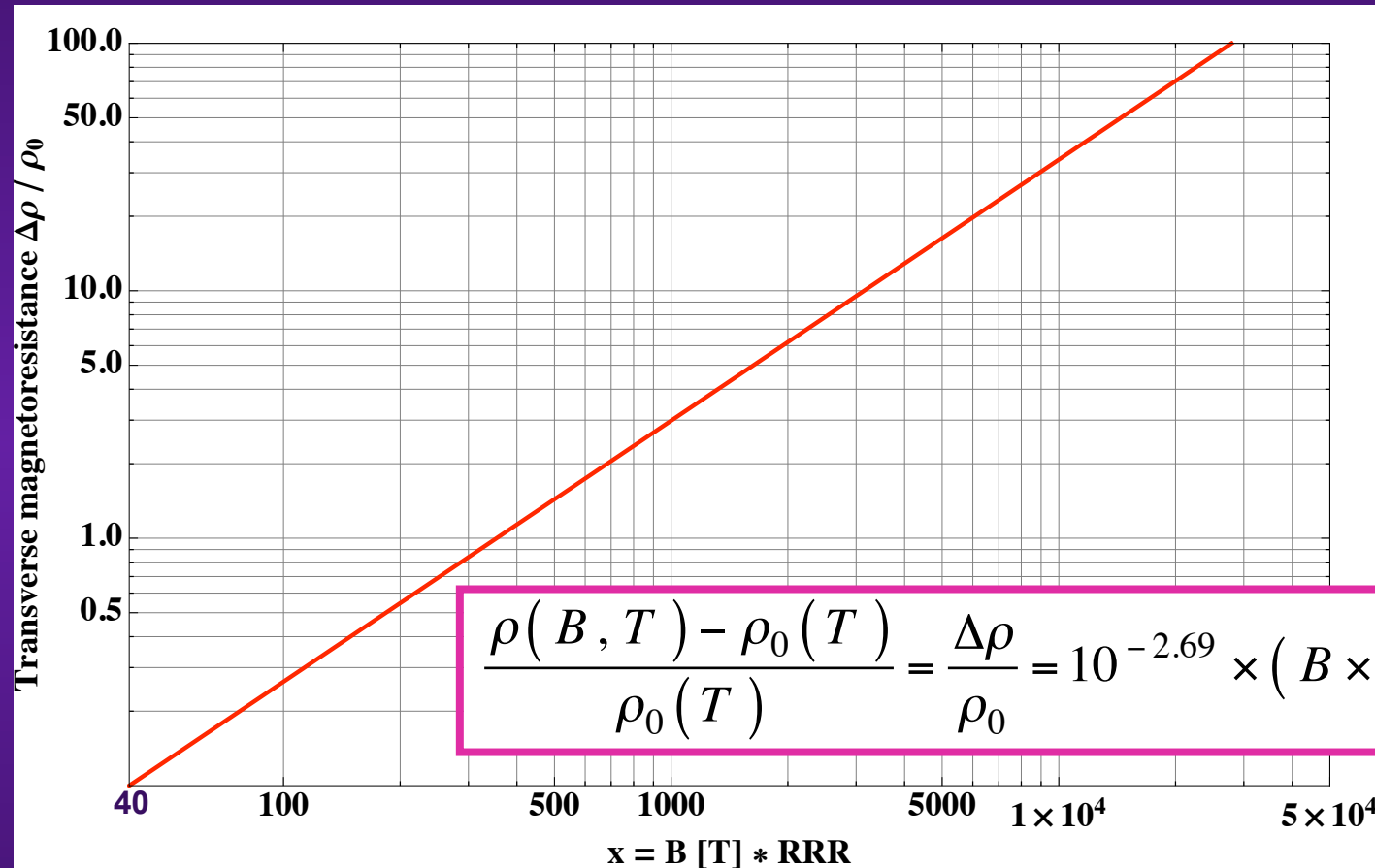


Figure 2: Resistivity of several metals vs T .

APPENDIX C: MAGNETO-RESISTANCE

◆ Increase of the resistivity with magnetic field => Kohler's rule



■ **0.535 T**

$$x = 53.5$$

$$\Delta\rho / \rho_0 \approx 0.14$$

■ **8.33 T**

$$x = 833$$

$$\Delta\rho / \rho_0 \approx 2.5$$

■ **20 T**

$$x = 2000$$

$$\Delta\rho / \rho_0 \approx 6.2$$

APPENDIX D: PUMPING HOLES

- ◆ **The parameters for the current beam screen are**
 - **Length of the slots:** $L = 6, 7, 8, 9 \text{ and } 10 \text{ mm} \Rightarrow \text{Laverage} = 8 \text{ mm}$
 - **Width of the slots:**
 - **In the arcs:** $W = 1.5 \text{ mm}$
 - **In the LSS:** $W = 1.0 \text{ mm}$
 - **Beam screen thickness:**
 - **In the arcs:** $T = 1 \text{ mm SS} + 0.075 \text{ mm Cu} = 1.075 \text{ mm}$
 - **In the LSS:** $T = 0.6 \text{ mm SS} + 0.075 \text{ mm Cu} = 0.675 \text{ mm}$